Rev. 5.0, 05/2015



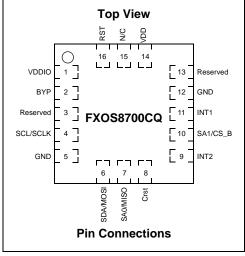
# FXOS8700CQ, 6-Axis Sensor with Integrated Linear Accelerometer and Magnetometer

FXOS8700CQ is a small, low-power, 3-axis, linear accelerometer and 3-axis, magnetometer combined into a single package. The device features a selectable I $^2$ C or point-to-point SPI serial interface with 14-bit accelerometer and 16-bit magnetometer ADC resolution along with smart-embedded functions. FXOS8700CQ has dynamically selectable acceleration full scale ranges of  $\pm 2$  g/ $\pm 4$  g/ $\pm 8$  g and a fixed magnetic measurement range of  $\pm 1200~\mu T$ . Output data rates (ODR) from 1.563 Hz to 800 Hz are selectable by the user for each sensor. Interleaved magnetic and acceleration data is available at ODR rates of up to 400 Hz. FXOS8700CQ is available in a plastic QFN package and it is guaranteed to operate over the extended temperature range of -40 °C to +85 °C.

#### **Features**

- Complete 6-axis, e-compass hardware solution
- 1.95 V to 3.6 V VDD supply voltage, 1.62 V to 3.6 V VDDIO voltage
- ±2 g/±4 g/±8 g dynamically selectable acceleration full-scale range
- ±1200 µT magnetic sensor full-scale range
- Output data rates (ODR) from 1.563 Hz to 800 Hz for each sensor, and up to 400 Hz when operated in hybrid mode with both sensors active
- Low noise: < 126 µg/√Hz acceleration noise density at 200 Hz bandwidth,</li>
   < 100 nT/√Hz magnetic noise density at 100 Hz bandwidth</li>
- 14-bit ADC resolution for acceleration measurements
- 16-bit ADC resolution for magnetic measurements
- Low power: 240  $\mu A$  current consumption at 100 Hz, and 80  $\mu A$  at 25 Hz with both sensors active
- Embedded programmable acceleration event functions:
  - Freefall and motion detection
  - Transient detection
  - Vector-magnitude change detection
  - Pulse and tap detection (single and double)
  - Orientation detection (portrait/landscape)
- Embedded programmable magnetic event functions:
  - Threshold detection
  - Vector-magnitude change detection
  - Autonomous magnetic min/max detection
  - Autonomous hard-iron calibration
- Programmable automatic ODR change using Auto-Wake and return to Sleep functions to save power. This function works
  with both magnetic and acceleration event interrupt sources.
- 32-sample FIFO for acceleration data only
- Integrated accelerometer and magnetometer self-test functions







#### **Target Markets**

- Smartphones, tablets, personal navigation devices, robotics, unmanned aerial vehicles (UAVs), and wrist watches with embedded electronic compass (e-compass) function.
- Medical applications: patient monitoring, fall detection, and rehabilitation

#### **Applications**

- E-Compass in mobile devices
- · User interface (menu scrolling by orientation change, tap detection for button replacement)
- Orientation detection (portrait/landscape: up/down, left/right, back/front orientation identification)
- Augmented reality (AR), gaming, and real-time activity analysis (pedometry, freefall, and drop detection for hard disk drives and other devices)
- · Power management for mobile devices using inertial and magnetic event detection
- Shock and vibration monitoring (mechatronic compensation, shipping, and warranty usage logging)

| ORDERING INFORMATION                                       |  |  |  |  |  |  |
|--|--|--|--|--|--|--|
| Part Number Temperature Range Package Description Shipping |  |  |  |  |  |  |
| FXOS8700CQR1 -40 °C to +85 °C QFN Tape and Reel            |  |  |  |  |  |  |

#### **Related Documentation**

The FXOS8700CQ device features and operations are described in a variety of reference manuals, user guides, and application notes. To find the most-current versions of these documents:

1. Go to the Freescale homepage at:

http://www.freescale.com/

In the Keyword search box at the top of the page, enter the device number FXOS8700CQ.

In the Refine Your Result pane on the left, click on the Documentation link.

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# 1 Block Diagram

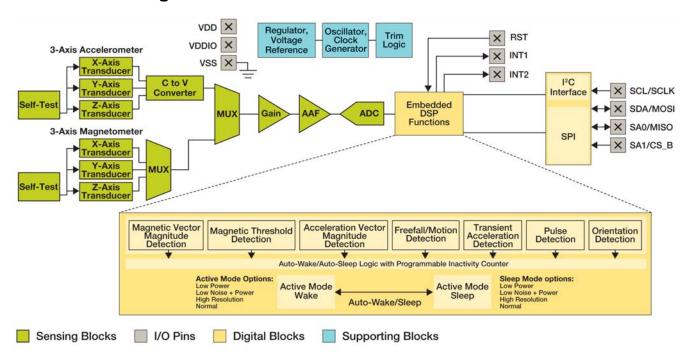
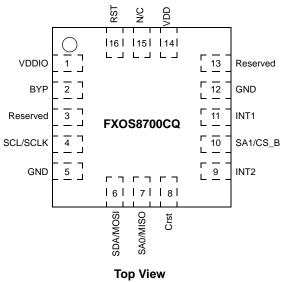


Figure 1. Block diagram

# 2 Pin Description



16 Lead QFN-COL 3 mm x 3 mm x 1.2 mm

Figure 2. Pinout diagram

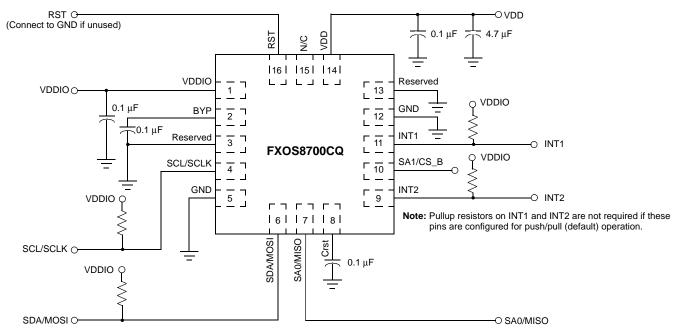
Table 1. Pin Description

| Pin | Name               | Function  |
|-----|--------------------|---|
| 1   | VDDIO              | Interface supply voltage  |
| 2   | BYP                | Internal regulator output bypass capacitor connection                                   |
| 3   | Reserved           | Test reserved, connect to GND   |
| 4   | SCL/SCLK           | I <sup>2</sup> C Serial Clock/SPI Clock <sup>(1)</sup>                                  |
| 5   | GND                | Ground  |
| 6   | SDA/MOSI           | I <sup>2</sup> C Serial Data/SPI Master Out, Slave In <sup>(1)(2)</sup>                 |
| 7   | SA0/MISO           | I <sup>2</sup> C address selection bit 0/SPI Master In, Slave Out <sup>(1)(2)(3)</sup>  |
| 8   | Crst               | Magnetic reset capacitor  |
| 9   | INT2               | Interrupt 2   |
| 10  | SA1/CS_B           | I <sup>2</sup> C address selection bit 1/SPI Chip Select (active low) <sup>(2)(3)</sup> |
| 11  | INT1               | Interrupt 1   |
| 12  | GND                | Ground  |
| 13  | Reserved           | Test reserved, connect to GND   |
| 14  | VDD                | Sensor supply voltage   |
| 15  | N/C                | Not connected internally  |
| 16  | RST <sup>(2)</sup> | Reset input, active high. Connect to GND if unused                                      |

- 1. Refer to Section 5.2.1 regarding point-to-point SPI operation.
- 2. Refer to Section 5.2.3 regarding SPI bus requirements during 1 ms period following a reset.
- 3. Refer to Table 10 for I<sup>2</sup>C address options selectable using the SA0 and SA1 pins.

Device power is supplied through the VDD pin. Power supply decoupling capacitors (100 nF ceramic plus 4.7  $\mu$ F bulk) should be placed as close as possible to pin 14 of the device. The digital interface supply voltage (VDDIO) should be decoupled with a 100 nF ceramic capacitor placed as close as possible to pin 1 of the device.

The digital control signals SCL, SDA, SA0, SA1, and RST are not tolerant of voltages exceeding VDDIO + 0.3 V. If VDDIO is removed, these pins will clamp any logic signals through their internal ESD protection diodes. The function and timing of the two interrupt pins (INT1 and INT2) are user programmable through the I<sup>2</sup>C/SPI interface. The SDA and SCL I<sup>2</sup>C connections are open drain and therefore require a pullup resistor as shown in the application diagram in Figure 3. The INT1 and INT2 pins may also be configured for open-drain operation. If they are configured for open drain, external pullup resistors are required.



**Note:** Pullup resistors on SCL/SCLK and SDA/MOSI are not required if the device is operated in SPI Interface mode.

Figure 3. Electrical connection

# 2.1 Soldering information

The QFN package is compliant with the RoHS standards. Please refer to Freescale application note AN4077 for more information.

# 2.2 Orientation

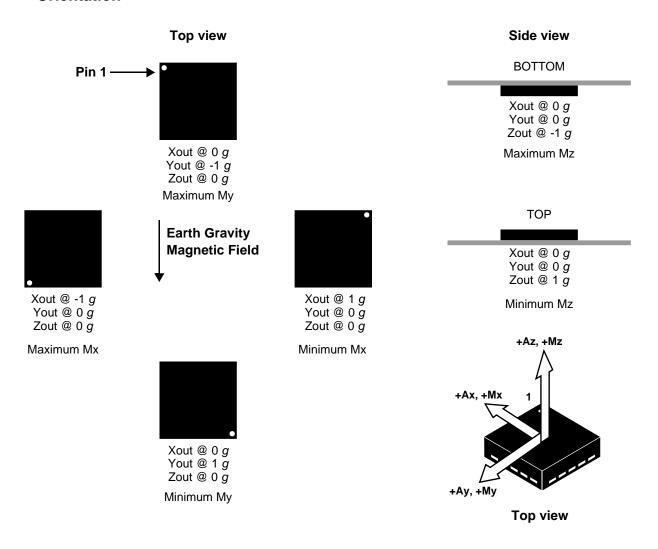


Figure 4. Product orientation and axis orientation

# 3 Terminology

## 3.1 Sensitivity

Sensitivity is represented in mg/LSB for the accelerometer and  $\mu$ T/LSB for the magnetometer. The magnetometer sensitivity is fixed at 0.1  $\mu$ T/LSB. The accelerometer sensitivity changes with the full-scale range selected by the user. Accelerometer sensitivity is 0.244 mg/LSB in 2 g mode, 0.488 mg/LSB in 4 g mode, and 0.976 mg/LSB in 8 g mode.

### 3.2 Zero-g and Zero-Flux offset

For the accelerometer, zero-g offset describes the deviation of the output values from the ideal values when the sensor is stationary. With an accelerometer stationary on a level horizontal surface, the ideal output is 0 g for the X and Y axes, and 1 g for the Z-axis. The deviation of each output from the ideal value is called zero-g offset. Offset is to some extent a result of stress on the sensor, and therefore, can slightly change after mounting the sensor onto a printed circuit board or exposing it to extensive mechanical stress. For the magnetometer, zero-flux offset describes the deviation of the output signals from zero when the device is shielded from external magnetic field sources (that is, inside a zero-gauss chamber).

#### 3.3 Self-Test

Self-Test can be used to verify the transducer and signal chain functionality without the need to apply an acceleration or magnetic field stimulus. When the accelerometer self-test is activated, an electrostatic actuation force is applied to the sensor, simulating a small acceleration. In this case the sensor X, Y, Z outputs will exhibit a change in DC levels related to the selected full-scale range (sensitivity). When self-test is activated, the device output level is given by the algebraic sum of the signals produced by the acceleration acting on the sensor and by the electrostatic self-test force. When self-test is activated for the magnetometer, an internal magnetic field is generated along the X, Y and Z axes. The sensor response will be the sum of the ambient magnetic field and the self-test induced field.

# 4 Device Characteristics

# 4.1 Mechanical characteristics (accelerometer)

Table 2. Mechanical characteristics @ VDD = 2.5 V, VDDIO = 1.8 V T = 25 °C unless otherwise noted.

| Parameter   | Test Conditions                             | Symbol                 | Min                   | Тур   | Max | Unit                |
|---|---|------------------------|-----------------------|-------|-----|---------------------|
|   | ±2 g mode                                   |                        |                       | ±2    |     |                     |
| Measurement range <sup>(1)</sup>                              | ±4 g mode                                   | FS <sub>ACC</sub>      |                       | ±4    |     | g                   |
|   | ±8 g mode                                   |                        |                       | ±8    | 3   |                     |
|   | 12 a mada                                   |                        |                       | 4096  |     | LSB/g               |
|   | ±2 g mode                                   |                        |                       | 0.244 |     | mg/LSB              |
| On a state that   | 4 a see de                                  | OEN                    |                       | 2048  |     | LSB/g               |
| Sensitivity   | ±4 g mode                                   | SEN <sub>ACC</sub>     |                       | 0.488 |     | mg/LSB              |
|   | 0   |                        |                       | 1024  |     | LSB/g               |
|   | ±8 g mode                                   |                        |                       | 0.976 |     | mg/LSB              |
| Sensitivity change with temperature <sup>(1)</sup>            | ±2 g, ±4 g, ±8 g modes                      | TCS <sub>ACC</sub>     |                       | ±0.01 |     | %/°C                |
| Sensitivity accuracy  | @ 25 °C                                     | SEN-TOL <sub>ACC</sub> |                       | ±2.5  |     | %SEN <sub>ACC</sub> |
| Zero-g level offset accuracy <sup>(2)</sup>                   | ±2 g, ±4 g, ±8 g modes                      | OFF <sub>ACC</sub>     |                       | ±20   |     | mg                  |
| Zero-g level offset accuracy post-board mount <sup>(3)</sup>  | ±2 g, ±4 g, ±8 g modes                      | OFF <sub>ACC-PBM</sub> |                       | ±30   |     | mg                  |
| Zero-g level change versus temperature                        | -40 °C to 85 °C <sup>(1)</sup>              | TCO <sub>ACC</sub>     |                       | ±0.2  |     | mg/°C               |
| Nonlinearity (deviation from straight line) <sup>(4)(5)</sup> | Over ±1 g range normal mode                 | NL <sub>ACC</sub>      |                       | ±0.5  |     | %FS <sub>ACC</sub>  |
| change <sup>(6)</sup> X Y Z                                   | Set to ±2 g mode                            | STOC <sub>ACC</sub>    | +192<br>+270<br>+1275 |       |     | LSB                 |
| Output noise density <sup>(4)(7)</sup>                        | ODR = 400 Hz, normal mode                   | ND <sub>ACC-NM</sub>   |                       | 126   |     | μg/√Hz              |
| Output hoise defisity.  | ODR = 400 Hz, low-noise mode <sup>(1)</sup> | ND <sub>ACC-LNM</sub>  |                       | 99    |     | μg/√Hz              |
| Operating temperature range                                   |   | Тор                    | -40                   |       | +85 | °C                  |

<sup>1.</sup> Dynamic range is limited to  $\pm 4~g$  when in the low-noise mode.

<sup>2.</sup> Before board mount.

<sup>3.</sup> Post-board mount offset specifications are based on a 2-layer PCB design.

<sup>4.</sup> Evaluation only.

<sup>5.</sup> After post-board mount corrections for sensitivity, cross axis and offset. Refer to AN4399 for more information.

<sup>6.</sup> Self-test is only exercised along one direction for each sensitive axis.

<sup>7.</sup> Measured using earth's gravitational field (1 g) with the device oriented horizontally (+Z axis up) and stationary.

# 4.2 Magnetic characteristics (magnetometer)

Table 3. Magnetic characteristics @ VDD = 2.5 V, VDDIO = 1.8 V T = 25 °C unless otherwise noted.

| Parameter   | Test Conditions           | Symbol               | Min   | Тур  | Max | Unit               |
|---|---------------------------|----------------------|-------|------|-----|--------------------|
| Measurement range   |                           | FS <sub>MAG</sub>    | ±1200 |      |     | μТ                 |
| Sensitivity   |                           | SEN <sub>MAG</sub>   |       | 0.1  |     | μT/LSB             |
| Sensitivity change versus temperature                             |                           | TCS <sub>MAG</sub>   |       | ±0.1 |     | %/°C               |
| Zero-flux offset accuracy <sup>(1)</sup>                          |                           | OFF <sub>MAG</sub>   |       | ±10  |     | μТ                 |
| Zero-flux offset change with temperature                          |                           | TCO <sub>MAG</sub>   |       | ±0.8 |     | μT/°C              |
| Hysteresis <sup>(2)(3)</sup>                                      |                           | HYST <sub>MAG</sub>  |       | ±0.5 |     | %FS <sub>MAG</sub> |
| Nonlinearity <sup>(3)</sup> Deviation from best-fit straight line |                           | NL <sub>MAG</sub>    |       | ±1   |     | %FS <sub>MAG</sub> |
| Temperature sensor sensitivity                                    |                           |                      |       | 0.96 |     | °C/LSB             |
|   | ODR = 800 Hz, OSR = 2     |                      |       | 1.5  |     | μT-rms             |
|   | ODR = 400 Hz, OSR = 4     |                      |       | 1.2  |     |                    |
|   | ODR = 200 Hz, OSR = 8     |                      |       | 0.85 |     |                    |
| Magnetometer output noise   | ODR = 100 Hz, OSR = 16    | Noise <sub>MAG</sub> |       | 0.6  |     |                    |
| iwagnetometer output hoise  | ODR = 50 Hz, OSR = 32     | INDISEMAG            |       | 0.5  |     |                    |
|   | ODR = 12.5 Hz, OSR = 128  |                      |       | 0.35 |     |                    |
|   | ODR = 6.25 Hz, OSR = 256  |                      |       | 0.3  |     |                    |
|   | ODR = 1.56 Hz, OSR = 1024 |                      |       | 0.3  |     |                    |
|   | X-axis                    |                      | 1161  |      |     | LSB                |
| Self-Test output change <sup>(1)(4)</sup>                         | Y-axis                    | STOC <sub>MAG</sub>  | -1130 |      |     | LSB                |
|   | Z-axis                    |                      | -43   |      |     | LSB                |
| Operating temperature range                                       |                           | Тор                  | -40   |      | +85 | °C                 |

<sup>1.</sup> After m-cell has been factory trimmed

# 4.3 Hybrid characteristics

Table 4. Hybrid characteristics @ VDD = 2.5 V, VDDIO = 1.8 V T = 25 °C unless otherwise noted.

| Parameter                               | Test Conditions | Symbol             | Min | Тур   | Max | Unit |
|---|-----------------|--------------------|-----|-------|-----|------|
| Maximum output data rate in hybrid mode |                 | ODR <sub>max</sub> |     | 400   |     | Hz   |
| Operating temperature range             |                 | Тор                | -40 |       | +85 | °C   |
| Output data bandwidth                   |                 | BW                 |     | ODR/2 |     | Hz   |

<sup>2.</sup> Hysteresis is measured by sweeping the applied magnetic field from -1000  $\mu$ T to 1000  $\mu$ T and then back to -1000  $\mu$ T. The difference in the two readings at -1000  $\mu$ T divided by the swept field range is the hysteresis figure, expressed in% of the full-scale range (FS<sub>MAG</sub>).

<sup>3.</sup> Tested over a  $\pm 1000~\mu T$  measurement range.

<sup>4.</sup> Minimum offset is shown with polarity. This means that the actual offset can be a smaller number for negative figures.

# 4.4 Electrical characteristics

Table 5. Electrical characteristics @ VDD = 2.5 V, VDDIO = 1.8 V T = 25  $^{\circ}$ C unless otherwise noted.

| Parameter  | Test Conditions   | Symbol                              | Min        | Тур       | Max       | Unit |
|--|---|-------------------------------------|------------|-----------|-----------|------|
| Supply voltage   |   | VDD                                 | 1.95       | 2.5       | 3.6       | V    |
| Interface supply voltage   |   | VDDIO                               | 1.62       | 1.8       | 3.6       | V    |
|  | ODR = 12.5 Hz   |                                     |            | 8         |           |      |
| Low-power acceleration mode  | ODR = 100 Hz  | Idd <sub>ACC-LPM</sub>              |            | 35        |           | μΑ   |
|  | ODR = 400 Hz  |                                     |            | 130       |           |      |
|  | ODR = 50 Hz   |                                     |            | 35        |           |      |
| Normal acceleration mode   | ODR = 200 Hz  | Idd <sub>ACC-NM</sub>               |            | 130       |           | μΑ   |
|  | ODR = 800 Hz  |                                     |            | 240       |           | ·    |
|  | ODR = 200 Hz<br>Accelerometer OSR = 4<br>Magnetometer OSR = 2 |                                     |            | 440       |           |      |
| Hybrid mode  | ODR = 100 Hz<br>Accelerometer OSR = 4<br>Magnetometer OSR = 2 | Idd <sub>ACC+MAG</sub>              |            | 240       |           | μА   |
|  | ODR = 25 Hz<br>Accelerometer OSR = 4<br>Magnetometer OSR = 2  | 2                                   |            | 80        |           |      |
| Magnetic mode  | ODR = 400 Hz, OSR = 2   | - Idd <sub>MAG</sub>                |            | 575       |           | μΑ   |
| Wagnette Mede  | ODR = 12.5 Hz, OSR = 2  | IddMAG                              |            | 40        |           | μιτ  |
| Current during boot sequence, 0.9 mS max duration using recommended regulator bypass capacitor | VDD = 2.5 V   | Idd <sub>BOOT</sub>                 |            |           | 3         | mA   |
| Value of capacitors on BYP and magnetic reset pins   | -40 °C to 85 °C   | C <sub>BYP</sub> , C <sub>RST</sub> | 75         | 100       | 470       | nF   |
| Standby mode current @ 25 °C   | Standby mode  | Idd <sub>STBY</sub>                 |            | 2         |           | μA   |
| Standby mode current over-temperature range  | Standby mode  | Idd <sub>STBY</sub>                 |            |           | 10        | μA   |
| Digital high-level input voltage RST pin   |   | VIH <sub>RST</sub>                  | 1.04       |           |           | V    |
| Digital low-level input voltage RST pin  |   | VIL <sub>RST</sub>                  |            |           | 0.68      | V    |
| Digital high-level input voltage SCL, SDA, SA0, SA1  |   | VIH                                 | 0.75*VDDIO |           |           | V    |
| Digital low-level input voltage SCL, SDA, SA0, SA1   |   | VIL                                 |            |           | 0.3*VDDIO | V    |
| High-level output voltage INT1, INT2   | I <sub>O</sub> = 500 μA                                       | VOH                                 | 0.9*VDDIO  |           |           | V    |
| Low-level output voltage INT1, INT2  | I <sub>O</sub> = 500 μA                                       | VOL                                 |            |           | 0.1*VDDIO | V    |
| Low-level output voltage SDA   | I <sub>O</sub> = 500 μA                                       | VOL <sub>SDA</sub>                  |            |           | 0.1*VDDIO | V    |
| OOL ODA six last and   | 25 °C   |                                     |            | 1.0       |           | - 1  |
| SCL, SDA pin leakage   | -40 °C to 85 °C   |                                     |            | 4.0       |           | nA   |
| SCL, SDA pin capacitance   |   |                                     |            | 3         |           | pf   |
| VDD rise time  |   |                                     | 0.001      |           | 1000      | ms   |
| Boot time <sup>(1)</sup>   |   | T <sub>BOOT</sub>                   |            |           | 1000      | μs   |
| Turn-on time 1 <sup>(2)</sup>  |   | $T_{POR \rightarrow ACT}$           |            | 2/ODR + 2 |           | ms   |
| Turn-on time 2 <sup>(3)</sup>  |   | $T_{STBY \rightarrow ACT}$          |            | 2/ODR + 1 |           | ms   |
| Operating temperature range  |   | T <sub>OP</sub>                     | -40        |           | +85       | °C   |

<sup>1.</sup> Time from VDDIO on and VDD > VDD min until  $I^2C/SPI$  interface ready for operation.

<sup>2.</sup> Time to obtain valid data from power-down mode to Active mode.

<sup>3.</sup> Time to obtain valid data from Standby mode to Active mode.

Values in the following table are based on limited number of samples and are for reference only. Output data rates do not exist for the shaded cells.

Table 6. IDD (μA) table versus operating modes (VDD + VDDIO), VDD = VDDIO = 2.4 V

| Mode    | Acc | only | Mag  | only |        | Hybrid |        |  |
|---------|-----|------|------|------|--------|--------|--------|--|
| ODR     | NM  | LP   | OS0  | OS7  | NM/OS0 | LP/OS0 | NM/OS7 |  |
| 800     | 239 | 239  | 1072 | 1072 |        |        |        |  |
| 400     | 239 | 121  | 552  | 1002 | 648    | 647    | 648    |  |
| 200     | 121 | 62   | 289  | 966  | 412    | 339    | 607    |  |
| 100     | 68  | 33   | 156  | 947  | 220    | 183    | 512    |  |
| 50      | 33  | 18   | 90   | 939  | 123    | 105    | 465    |  |
| 25      |     |      |      |      | 74     | 66     | 442    |  |
| 12.5    | 33  | 7    | 37   | 932  |        |        |        |  |
| 6.25    | 33  | 7    | 37   | 931  | 51     | 35     | 437    |  |
| 3.125   |     |      |      |      | 51     | 35     | 437    |  |
| 1.5625  | 33  | 7    | 36   | 931  |        |        |        |  |
| 0.78125 |     |      |      |      | 51     | 35     | 436    |  |
| stby    |     | •    | •    | 2    |        |        | •      |  |

NM = Accelerometer OSR Normal Mode (CTRL\_REG2[mods] = 0b00).

LP = Accelerometer OSR Low Power (CTRL\_REG2[mods] = 0b11).

OS0 = Magnetometer OSR set to 0 (M\_CTRL\_REG1[m\_os] = 0b000). OS7 = Magnetometer OSR set to 7 (M\_CTRL\_REG1[m\_os] = 0b111).

# 4.5 Absolute maximum ratings

Stresses above those listed as "absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Freescale recommends that customers using magnetic sensor components adopt industry standard safe handling practices and procedures for magnetic products. To avoid potential damage to the magnetic transducer contained within this product, it is recommended to only handle the device with non-magnetic tools and fixtures.

**Table 7. Maximum ratings** 

| Rating  | Symbol                                       | Value               | Unit |
|---|--|---------------------|------|
| Maximum acceleration (all axes, 100 μs)   | 9 <sub>max</sub>                             | 5,000               | g    |
| Supply voltage, IO voltage  | VDD <sub>max</sub> /<br>VDDIO <sub>max</sub> | -0.3 to +3.6        | V    |
| Input voltage on any control pin (SA0/MISO, SA1/CS_B, SCL/SCLK, SDA/MOSI, RST)  | VIN <sub>max</sub>                           | -0.3 to VDDIO + 0.3 | V    |
| Drop-Test height  | D <sub>drop</sub>                            | 1.8                 | m    |
| Maximum exposed magnetic field without perming (sensor characteristics may be restored using the magnetic reset function) |  | 10,000              | μТ   |
| Maximum exposed field without permanent damage  |  | 0.1                 | Т    |
| Storage temperature range   | T <sub>STG</sub>                             | -40 to +125         | °C   |

#### Table 8. ESD and latchup protection characteristics

| Rating                       | Symbol          | Value | Unit |
|------------------------------|-----------------|-------|------|
| Human Body Model             | НВМ             | ±2000 | V    |
| Machine Model                | MM              | ±200  | V    |
| Charge Device Model          | CDM             | ±500  | V    |
| Latchup current at T = 85 °C | I <sub>LU</sub> | ±100  | mA   |



This device is sensitive to mechanical shock. Improper handling can cause permanent damage to the part or cause the part to otherwise fail.



This device is sensitive to ESD, improper handling can cause permanent damage to the part.

# 5 Digital Interfaces

# 5.1 I<sup>2</sup>C interface characteristics

Table 9. I<sup>2</sup>C slave timing values<sup>(1)</sup>

| Parameter   | Symbol              | I <sup>2</sup> C Fas                   | st Mode            | Unit |
|---|---------------------|--|--------------------|------|
| raidilletei   | Syllibol            | Min                                    | Max                | Onit |
| SCL Clock Frequency   | f <sub>SCL</sub>    | 0                                      | 400                | kHz  |
| Bus Free Time between STOP and START condition  | t <sub>BUF</sub>    | 1.3                                    |                    | μs   |
| (Repeated) START Hold Time  | t <sub>HD;STA</sub> | 0.6                                    |                    | μs   |
| (Repeated) START Setup Time   | t <sub>SU;STA</sub> | 0.6                                    |                    | μs   |
| STOP Condition Setup Time   | t <sub>SU;STO</sub> | 0.6                                    |                    | μs   |
| SDA Data Hold Time  | t <sub>HD;DAT</sub> | 0.05                                   | 0.9 <sup>(2)</sup> | μs   |
| SDA Valid Time <sup>(3)</sup>   | t <sub>VD;DAT</sub> |  | 0.9 <sup>(2)</sup> | μs   |
| SDA Valid Acknowledge Time <sup>(4)</sup>   | t <sub>VD;ACK</sub> |  | 0.9 <sup>(2)</sup> | μs   |
| SDA Setup Time  | t <sub>SU;DAT</sub> | 100                                    |                    | ns   |
| SCL Clock Low Time  | t <sub>LOW</sub>    | 1.3                                    |                    | μs   |
| SCL Clock High Time   | t <sub>HIGH</sub>   | 0.6                                    |                    | μs   |
| SDA and SCL Rise Time   | t <sub>r</sub>      | 20 + 0.1 C <sub>b</sub> <sup>(5)</sup> | 300                | ns   |
| SDA and SCL Fall Time   | t <sub>f</sub>      | 20 + 0.1 C <sub>b</sub> <sup>(5)</sup> | 300                | ns   |
| Pulse width of spikes on SDA and SCL that must be suppressed by internal input filter | t <sub>SP</sub>     | 0                                      | 50                 | ns   |

- 1. All values referred to VIH (min) and VIL (max) levels.
- 2. This device does not stretch the LOW period ( $t_{\text{LOW}}$ ) of the SCL signal.
- 3.  $t_{VD;DAT}$  = time for Data signal from SCL LOW to SDA output.
- 4.  $t_{VD;ACK}$  = time for Acknowledgement signal from SCL LOW to SDA output (HIGH or LOW, depending on which one is worse).
- 5.  $C_b$  = total capacitance of one bus line in pF.

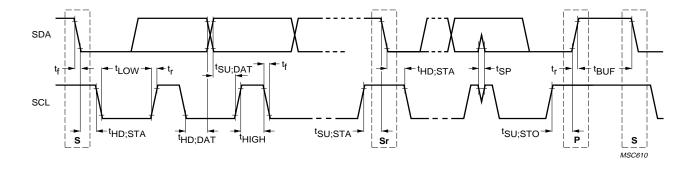


Figure 5. I<sup>2</sup>C slave timing diagram

# 5.1.1 General I<sup>2</sup>C operation

There are two signals associated with the I<sup>2</sup>C bus: the Serial Clock Line (SCL) and the Serial Data line (SDA). The latter is a bidirectional line used for sending and receiving the data to/from the interface. External pullup resistors connected to VDDIO are required for SDA and SCL. When the bus is free both the lines are high. The I<sup>2</sup>C interface is compliant with fast mode (400 kHz), and normal mode (100 kHz) I<sup>2</sup>C standards. Operation at frequencies higher than 400 kHz is possible, but depends on several factors including the pullup resistor values, and total bus capacitance (trace + device capacitance). See Table 10 for more information.

A transaction on the bus is started through a start condition (ST) signal, which is defined as a HIGH-to-LOW transition on the data line while the SCL line is held HIGH. After the ST signal has been transmitted by the master, the bus is considered busy. The next byte of data transmitted contains the slave address in the first seven bits, and the eighth bit, the read/write bit, indicates whether the master is receiving data from the slave or transmitting data to the slave. When an address is sent, each device in the system compares the first seven bits after the ST condition with its own address. If they match, the device considers itself addressed by the master. The ninth clock pulse, following the slave address byte (and each subsequent byte) is the acknowledge (ACK). The transmitter must release the SDA line during the ACK period. The receiver must then pull the data line low so that it remains stable low during the high period of the acknowledge clock period.

The number of bytes per transfer is unlimited. If a receiver can't receive another complete byte of data until it has performed some other function, it can hold the clock line, SCL low to force the transmitter into a wait state. Data transfer only continues when the receiver is ready for another byte and releases the data line. This delay action is called clock stretching. Not all receiver devices support clock stretching. Not all master devices recognize clock stretching. This part does not use clock stretching.

A low to high transition on the SDA line while the SCL line is high is defined as a stop condition (SP) signal. A write or burst write is always terminated by the master issuing the SP signal. A master should properly terminate a read by not acknowledging a byte at the appropriate time in the protocol. A master may also issue a repeated start signal (SR) during a transfer

The slave addresses that may be assigned to the FXOS8700CQ part are 0x1C, 0x1D, 0x1E, or 0x1F. The selection is made through the logic level of the SA1 and SA0 inputs.

| SA1 | SA0 | Slave address |
|-----|-----|---------------|
| 0   | 0   | 0x1E          |
| 0   | 1   | 0x1D          |
| 1   | 0   | 0x1C          |
| 1   | 1   | 0x1F          |

Table 10. I<sup>2</sup>C slave address

# 5.1.2 I<sup>2</sup>C Read/Write operations

#### Single-byte read

The master (or MCU) transmits a start condition (ST) to the FXOS8700CQ, followed by the slave address, with the R/W bit set to "0" for a write, and the FXOS8700CQ sends an acknowledgement. Then the master (or MCU) transmits the address of the register to read and the FXOS8700CQ sends an acknowledgement. The master (or MCU) transmits a repeated start condition (SR), followed by the slave address with the R/W bit set to "1" for a read from the previously selected register. The FXOS8700CQ then acknowledges and transmits the data from the requested register. The master does not acknowledge (NAK) the transmitted data, but transmits a stop condition to end the data transfer.

#### Multiple-byte read

When performing a multi-byte or "burst" read, the FXOS8700CQ automatically increments the register address read pointer after a read command is received. Therefore, after following the steps of a single-byte read, multiple bytes of data can be read from sequential registers after each FXOS8700CQ acknowledgment (AK) is received until a no acknowledge (NAK) occurs from the master followed by a stop condition (SP) signaling an end of transmission.

#### Single-byte write

To start a write command, the master transmits a start condition (ST) to the FXOS8700CQ, followed by the slave address with the R/W bit set to "0" for a write, and the FXOS8700CQ sends an acknowledgement. Then the master (or MCU) transmits the address of the register to write to, and the FXOS8700CQ sends an acknowledgement. Then the master (or MCU) transmits the 8-bit data to write to the designated register and the FXOS8700CQ sends an acknowledgement that it has received the data. Since this transmission is complete, the master transmits a stop condition (SP) to end the data transfer. The data sent to the FXOS8700CQ is now stored in the appropriate register.

### Multiple-byte write

The FXOS8700CQ automatically increments the register address write pointer after a write command is received. Therefore, after following the steps of a single-byte write, multiple bytes of data can be written to sequential registers after each FXOS8700CQ acknowledgment (ACK) is received.

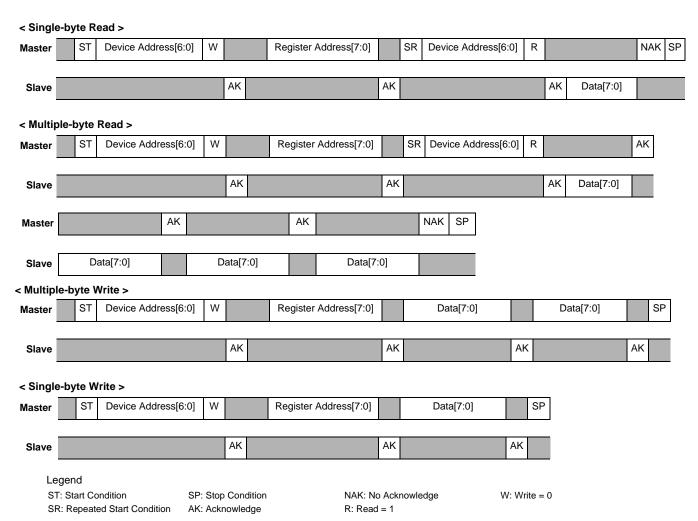


Figure 6. I<sup>2</sup>C timing diagram

#### 5.2 SPI Interface characteristics

SPI interface is a classical master/slave serial port. The FXOS8700CQ is always considered as the slave and thus is never initiating the communication.

Table 11 and Figure 7 describe the timing requirements for the SPI system.

Table 11. SPI timing

| Function                              | Symbol | Min  | Max | Unit |
|---------------------------------------|--------|------|-----|------|
| Operating Frequency                   | Of     | _    | 1   | MHz  |
| SCLK Period                           | tSCLK  | 1000 | _   | ns   |
| SCLK High time                        | tCLKH  | 500  | _   | ns   |
| SCLK Low time                         | tCLKL  | 500  | _   | ns   |
| CS_B lead time                        | tSCS   | 65   | _   | ns   |
| CS_B lag time                         | tHCS   | 65   | _   | ns   |
| MOSI data setup time                  | tSET   | 25   | _   | ns   |
| MOSI data hold time                   | tHOLD  | 75   | _   | ns   |
| MISO data valid (after SCLK low edge) | tDDLY  | _    | 500 | ns   |
| Width CS High                         | tWCS   | 100  | _   | ns   |

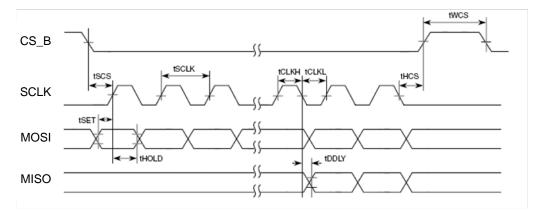


Figure 7. SPI Timing Diagram

#### 5.2.1 General SPI operation

#### **NOTE**

FXOS8700CQ only supports a point-to-point SPI protocol, with only one master (MCU) and one slave device (FXOS8700CQ) present on the bus. FXOS8700CQ does not tri-state the MISO pin when the CS\_B pin is deasserted (logic high), which can lead to a bus conflict if multiple slave devices are present on the bus.

Do not connect more than one master and one slave device on the SPI bus.

The CS\_B pin is driven low at the start of a SPI transaction, held low for the duration of the transaction, and driven high after the transaction is complete. During a transaction the master toggles the SPI clock (SCLK) and transmits data on the MOSI pin.

A write operation is initiated by transmitting a 1 for the R/W bit. Then the 8-bit register address, ADDR[7:0] is encoded in the first and second serialized bytes. Data to be written starts in the third serialized byte. The order of the bits is as follows:

Byte 0: R/W,ADDR[6],ADDR[5],ADDR[4],ADDR[3],ADDR[2],ADDR[1],ADDR[0],

Byte 1: ADDR[7],X,X,X,X,X,X,X,

Byte 2: DATA[7],DATA[6],DATA[5],DATA[4],DATA[3],DATA[2],DATA[1],DATA[0].

Multiple bytes of DATA may be transmitted. The X indicates a bit that is ignored by the part. The register address is autoincremented so that the next clock edges will latch the data for the next register. When desired, the rising edge on CS\_B stops the SPI communication.

The FXOS8700CQ SPI configuration is as follows:

Polarity: rising/fallingPhase: sample/setupOrder: MSB first

Data is sampled during the rising edge of SCLK and set up during the falling edge of SCLK.

#### 5.2.2 SPI READ/WRITE operations

A READ operation is initiated by transmitting a 0 for the R/W bit. Then the 8-bit register address, ADDR[7:0] is encoded in the first and second serialized bytes. Subsequent bits are ignored by the part. The read data is deserialized from the MISO pin.

Similarly a WRITE operation is initiated by transmitting a 1 for the R/W bit. After the first and second serialized bytes multipledata bytes can be transmitted into consecutive registers, starting from the indicated register address in ADDR[7:0].

An SPI transaction is started by asserting the CS\_B pin (high-to-low transition), and ended by deasserting the CS\_B pin (low-to-high transition).

| R/W bit followed by ADDR [6:0] ADDR[7] followed by 7 | "don't care" bits Data0* | Data1 | _ | Datan |
|--|--------------------------|-------|---|-------|
|  |                          |       |   |       |

<sup>\*</sup> Data bytes must be transmitted to the slave (FXOS8700CQ) using the MOSI pin by the master when R/W = 1. Data bytes will be transmitted by the slave (FXOS8700CQ) to the master using the MISO pin when R/W = 0. The first two bytes are always transmitted by the master using the MOSI pin. That is, a transaction is always initiated by master. 1

### Figure 8. SPI single-burst READ/WRITE transaction diagram

The registers embedded inside FXOS8700CQ are accessed through either an I<sup>2</sup>C, or a SPI serial interface. To enable either interface the VDDIO line must be connected to the interface supply voltage. If VDD is not present and VDDIO is present FXOS8700CQ is in shutdown mode and communications on the interface are ignored. If VDDIO is held high, VDD can be powered off and the communications pins will be in a high impedance state. This will allow communications to continue on the bus with other devices.

Table 12. Serial interface pin descriptions

| Pin Name | Pin Description  |
|----------|--|
| VDDIO    | Digital interface power  |
| SA1/CS_B | I <sup>2</sup> C second least significant bit of device address/SPI chip select                  |
| SCL/SCLK | I <sup>2</sup> C/SPI serial clock  |
| SDA/MOSI | I <sup>2</sup> C serial data/SPI master serial data out slave serial data in                     |
| SA0/MISO | I <sup>2</sup> C least significant bit of the device address/SPI master serial data in slave out |

#### 5.2.3 I<sup>2</sup>C/SPI auto detection

Table 13. I<sup>2</sup>C/SPI auto detection

| SA0      | Slave address    |
|----------|------------------|
| GND      | I <sup>2</sup> C |
| VDDIO    | I <sup>2</sup> C |
| Floating | SPI              |

FXOS8700CQ employs an interface mode, auto-detection circuit that will select either I<sup>2</sup>C or SPI interface mode based on the state of the SA0 pin during power up or when exiting reset. Once set for I<sup>2</sup>C or SPI operation, the device will remain in I<sup>2</sup>C or SPI mode until the device is reset or powered down and the auto-detection process is repeated. Please note that when SPI interface mode is desired, care must be taken to ensure that no other slave device drives the common SA0/MISO pin during the 1 ms period after a hard or soft reset or powerup event.

# 5.2.4 Power supply sequencing and I<sup>2</sup>C/SPI mode auto-detection

FXOS8700CQ does not have any specific power supply sequencing requirements between VDD and VDDIO voltage supplies to ensure normal operation. To ensure correct operation of the I<sup>2</sup>C/SPI auto-detection function, VDDIO should be applied before or at the same time as VDD. If this order cannot be maintained, the user should either toggle the RST line or power cycle the VDD rail in order to force the auto-detect function to restart and correctly identify the desired interface. FXOS8700CQ will indicate completion of the reset sequence by toggling the INT1 pin from logic high to low to high over a 500 ns period. If the INT1 pin was already low prior to the reset event, it will only go high.

# 6 Modes of Operation

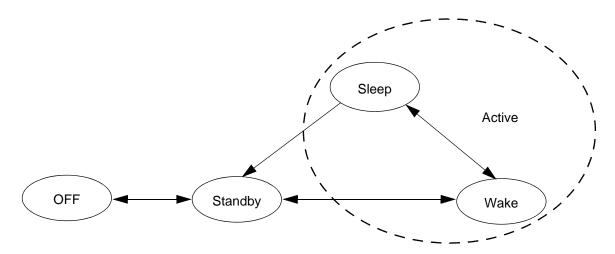


Figure 9. FXOS8700CQ power mode transition diagram

Table 14. Mode of operation description

| Mode                   | I <sup>2</sup> C/SPI Bus state                                 | VDD    | VDDIO   | Function description   |
|------------------------|--|--------|---|--|
| OFF                    | Powered down   | <1.8 V | VDDIO can be > VDD                                  | The device is powered off. All analog and digital blocks are shutdown. I <sup>2</sup> C bus inhibited. |
| Standby                | I <sup>2</sup> C/SPI communication with FXOS8700CQ is possible | ON     | VDDIO = High<br>VDD = High<br>Active bit is cleared | Only digital blocks are enabled. Analog subsystem is disabled. Internal clocks disabled.               |
| Active<br>(Wake/Sleep) | I <sup>2</sup> C/SPI communication with FXOS8700CQ is possible | ON     | VDDIO = High<br>VDD = High<br>Active bit is set     | All blocks are enabled (digital and analog).   |

All register contents are preserved when transitioning from Active-to-Standby mode, but some registers are reset when transitioning from Standby-to-Active. These registers are noted in Table 15, "Register Address Map," on page 25. The Sleep and Wake modes are active modes. For more information on how to use the Sleep and Wake modes and configuring the device to transition between them, please refer to Section 7, "Embedded Functionality" or Freescale application note AN4074.

# 7 Embedded Functionality

FXOS8700CQ is a low-power, digital output, 6-axis sensor with both I<sup>2</sup>C and SPI interfaces. Extensive embedded functionality is provided to detect inertial and magnetic events at low power, with the ability to notify the host processor of an event using either of the two programmable interrupt pins. The embedded functionality includes:

- · 8-bit or 14-bit accelerometer data which includes high-pass filtered data, and 8-bit or 16-bit magnetometer data
- Four different oversampling options for the accelerometer output data, and eight for the magnetometer. The oversampling settings allow the end user to optimize the resolution versus power trade-off in a given application.
- · A low-noise accelerometer mode that functions independently of the oversampling modes for even higher resolution
- Low-power, auto-wake/sleep function for conserving power in portable battery powered applications
- Accelerometer pulse-detection circuit which can be used to detect directional single and double taps
- Accelerometer directional motion- and freefall-event detection with programmable threshold and debounce time
- Acceleration transient detection with programmable threshold and debounce time. Transient detection can employ either
  a high-pass filter or use the difference between reference and current sample values.
- Orientation detection with programmable hysteresis for smooth transitions between portrait/landscape orientations
- Accelerometer vector-magnitude change event detection with programmable reference, threshold, and debounce time values
- · Magnetic threshold event detection with programmable reference, threshold, and debounce time
- Magnetometer vector-magnitude change event detection with programmable reference, threshold and debounce time values
- · Magnetic min/max detection circuit which can also be used for autonomous calibration of magnetic hard-iron offset

Many different configurations of the above functions are possible to suit the needs of the end application. Separate application notes are available to further explain the different configuration settings and potential use cases.

# 7.1 Factory calibration

FXOS8700CQ's integrated accelerometer and magnetometer sensors are factory calibrated for sensitivity and offset on each axis. The trim values are stored in Non-Volatile Memory (NVM). On power-up, the trim parameters are read from NVM and applied to the internal compensation circuitry. After mounting the device to the PCB, the user may further adjust the accelerometer and magnetometer offsets through the OFF\_X/Y/Z and M\_OFF\_X/Y/Z registers, respectively. For more information on device calibration, refer to Freescale application note, AN4399.

#### 7.2 8-bit or 14-bit accelerometer data

The measured acceleration data is stored in the OUT\_X\_MSB, OUT\_X\_LSB, OUT\_Y\_MSB, OUT\_Y\_LSB, OUT\_Z\_MSB, and OUT\_Z\_LSB registers as 2's complement 14-bit numbers. The most significant 8-bits of each axis are stored in the OUT\_X, Y, Z\_MSB registers, so applications needing only 8-bit results simply read these three registers and ignore the OUT\_X,Y, Z\_LSB registers. To do this, the *f\_read* mode bit in CTRL\_REG1 must be set.

When the full-scale range is set to 2 g, the measurement range is -2 g to +1.999 g, and each count corresponds to 0.244 mg at ±14-bits resolution. When the full-scale is set to 8 g, the measurement range is -8 g to +7.996 g, and each count corresponds to 0.976 mg. The resolution is reduced by a factor of 64 if only the 8-bit results are used (CTRL\_REG1[f\_read] = 1). For further information on the different data formats and modes, please refer to Freescale application note AN4076.

# 7.3 Accelerometer low-power modes versus high-resolution modes

FXOS8700CQ can be optimized for lower power or higher resolution of the accelerometer output data. High resolution is achieved by setting the Inoise bit in register 0x2A. This improves the resolution (by lowering the noise), but be aware that the full-scale range setting is restricted to  $\pm 2~g$  or  $\pm 4~g$  when this bit is set. This will affect all internal embedded functions (scaling of thresholds, etc.) and reduce noise. Another method for improving the resolution of the data is through oversampling. One of the oversampling schemes of the output data can be activated when CTRL\_REG2[mods] = 0b10 which will improve the resolution of the output data without affecting the internal embedded functions or fixing the dynamic range.

There is a trade-off between low power and high resolution. Low power can be achieved when the oversampling rate is reduced. When CTRL\_REG2[mods] = 0b10, the lowest power is achieved, at the expense of higher noise. In general, the lower the selected ODR and OSR, the lower the power consumption. For more information on how to configure the device in low-power or high-resolution modes and understand the benefits and trade-offs, please refer to Freescale application note AN4075.

## 7.4 Auto-Wake/Sleep mode

FXOS8700CQ can be configured to transition between sample rates (with their respective current consumptions) based on the status of the embedded interrupt event generators in the device. The advantage of using the Auto-Wake/Sleep is that the system can automatically transition to a higher sample rate (higher current consumption) when needed but spends the majority of the time in the Sleep mode (lower current) when the device does not require higher sampling rates. Auto-Wake refers to the device being triggered by one of the interrupt event functions to transition to a higher sample rate. This may also interrupt the processor to transition from a sleep mode to a higher power mode.

Sleep mode occurs when none of the enabled interrupt event functions has detected an interrupt within the user-defined, timeout period. The device will then transition to the specified lower sample rate. It may also alert the processor to go into a lower power mode to save power during this period of inactivity. Please refer to AN4074 for more detailed information on configuring the Auto-Wake/Sleep function.

### 7.5 Hybrid mode

FXOS8700CQ uses a single common Analog-to-Digital Converter (ADC) for both the accelerometer and magnetometer. When operating in hybrid mode (M\_CTRL\_REG1[m\_hms] = 0b11), both the accelerometer and magnetometer sensors are actively measured by the ADC at an ODR equal to one half of the setting made in CTRL\_REG1[dr] when operating in accelerometer-only mode (M\_CTRL\_REG1[m\_hms] = 0b00 (default)) or magnetometer-only mode (M\_CTRL\_REG1[m\_hms] = 0b01). While the ODR is common to both sensors when operating in hybrid mode, the OSR settings for each sensor are independent and may be set using the CTRL\_REG2[mods] for the accelerometer and M\_CTRL\_REG1[m\_os] for the magnetometer, respectively.

#### 7.6 Accelerometer Freefall and Motion event detection

FXOS8700CQ integrates a programmable threshold based acceleration detection function capable of detecting either motion or freefall events depending upon the configuration. For further details and examples on using the embedded freefall and motion detection functions, please refer to Freescale application note AN4070.

#### 7.6.1 Freefall detection

The detection of "Freefall" involves the monitoring of the X, Y, and Z axes for the condition where the acceleration magnitude is **below** a user-specified threshold for a user-definable amount of time. Typically, the usable threshold ranges are between ±100 mg and ±500 mg.

#### 7.6.2 Motion detection

Motion detection is often used to alert the main processor that the device is currently in use. When the acceleration exceeds a set threshold for a set amount of time, the motion interrupt is asserted. A motion can be a fast moving shake or a slow moving tilt. This will depend on the threshold and timing values configured for the event. The motion detection function can analyze static acceleration changes or faster jolts. The timing value is set by a configurable debounce counter. The debounce counter acts like a filter to indicate whether the condition exists for longer than a set amount of time (that is, 100 ms or longer). There is also directional data available in the source register to detect the direction of the motion that generated the interrupt. This is useful for applications such as directional shake or flick detection, and can also assist gesture detection algorithms by indicating that a motion gesture has started.

#### 7.7 Transient detection

FXOS8700CQ integrates an acceleration transient detection function that incorporates a high-pass filter. Acceleration data goes through the high-pass filter, eliminating the DC tilt offset and low frequency acceleration changes. The high-pass filter cutoff can be set by the user to four different frequencies which are dependent on the selected output data rate (ODR). A higher cutoff frequency ensures that DC and slowly changing acceleration data will be filtered out, allowing only the higher frequencies to pass. The transient detection feature can be used in the same manner as the motion detection by bypassing the high-pass filter. There is an option in the configuration register to do this. This adds more flexibility to cover the various customer use cases.

Many applications use the accelerometer's static acceleration readings (that is, tilt) which measure the change in acceleration due to gravity only. These functions benefit from acceleration data being filtered with a low-pass filter where high-frequency data is considered noise. However, there are many functions where the accelerometer must analyze dynamic acceleration. Functions such as tap, flick, shake and step counting are based on the analysis of the change in the dynamic acceleration. The transient detection function can be routed to either interrupt pin through bit 5 in CTRL\_REG5 register (0x2E). Registers 0x1D – 0x20 are used for configuring the transient detection function. The source register contains directional data to determine the direction of the transient acceleration, either positive or negative. For further information of the embedded transient detection function along with specific application examples and recommended configuration settings, refer to Freescale application note AN4461.

#### 7.8 Pulse detection

FXOS8700CQ has embedded single/double and directional pulse detection. This function employs several timers for programming the pulse width time and the latency between pulses. The detection thresholds are independently programmable for each axis. The acceleration data input to the pulse detection circuit can be put through both high and low-pass filters, allowing for greater flexibility in discriminating between pulse and tap events. The PULSE\_SRC register provides information on the axis, direction (polarity), and single/double event status for the detected pulse or tap. For more information on how to configure the device for pulse detection, please refer to Freescale application note AN4072.

#### 7.9 Orientation detection

FXOS8700CQ has an embedded orientation detection algorithm with the ability to detect all six orientations. The transition angles and hysteresis are programmable, allowing for a smooth transition between portrait and landscape orientations.

The angle at which the device no longer detects the orientation change is referred to as the "Z-lockout angle". The device operates down to 29° from the flat position. All angles are accurate to ±2°.

For further information on the orientation detection function refer to Freescale application note, AN4068.

## 7.10 Acceleration Vector-Magnitude detection

FXOS8700CQ incorporates an acceleration vector-magnitude change detection block that can be configured to generate an interrupt when the acceleration magnitude exceeds a preset threshold for a programmed debounce time. The function can be configured to operate in absolute or relative modes, and can also act as a wake-to-sleep/sleep-to-wake source. This function is useful for detecting acceleration transients when operated in absolute mode, or for detecting changes in orientation when operated in relative mode, refer to Freescale application note AN4692.

### 7.11 Magnetic Vector-Magnitude detection

FXOS8700CQ incorporates a magnetic vector-magnitude change detection block that can be configured to generate an interrupt when the magnetic field magnitude exceeds a preset threshold for a programmed debounce time. The function can be configured to operate in absolute or relative modes, and can also act as a wake-to-sleep/sleep-to-wake source. For more information, refer to Freescale application note AN4458.

# 7.12 Magnetic Threshold detection

FXOS8700CQ incorporates a magnetic threshold event detection block that can be configured to generate an interrupt when the magnetic field on the enabled axes is above or below a programmed threshold.

Two logic combinations are possible for the detection: all of the enabled axes below their respective thresholds (AND condition), or any of the enabled axes above their respective thresholds (OR condition). Even detection may be filtered using a dedicated debounce counter to avoid spurious event detection. The thresholds for each axis are individually programmable and the function can also act as a wake-to-sleep/sleep-to-wake source.

# 7.13 Magnetic Min/Max detection (autonomous calibration)

FXOS8700CQ incorporates a magnetic min/max detection circuit that can be used to automatically track the minimum and maximum field values measured on each of the X, Y, and Z axes. The stored minimum and maximum values may optionally be used to determine the magnetic hard-iron compensation and load the offset registers with the appropriate correction values. For more information, refer to Freescale application note AN4459.

# 8 Register Map

Table 15. Register Address Map

|                                    |      | Register            |   | Auto-Increm  | ent Address  |   | Default  |   |   |
|------------------------------------|------|---------------------|---|--|--|---|--|---|---|
| Name                               | Туре | Register<br>Address | STATUS[f_mode] = 00,<br>CTRL_REG1[f_read] = 0 | $\begin{split} &STATUS[f\_mode] > 00, \\ &CTRL\_REG1[f\_read] = 0 \end{split}$ | $\begin{split} &STATUS[f\_mode] = 00, \\ &CTRL\_REG1[f\_read] = 1 \end{split}$ | STATUS[f_mode] > 00,<br>CTRL_REG1[f_read] = 1                               | Hex<br>Value   | Con   | nment   |
| STATUS <sup>(1)(2)</sup>           | R    | 0x00                | 0x01  |  |  |   |  | status or (DR_S                             | data-ready<br>FIFO status<br>FATUS or<br>ATUS)                          |
| OUT_X_MSB <sup>(1)(2)(3)</sup>     | R    | 0x01                | 0x02  | 0x01   | 0x03   | 0x01  | Data   | [7:0] are 8<br>MSBs of<br>14-bit<br>sample. | Root pointer<br>to XYZ<br>FIFO data.                                    |
| OUT_X_LSB <sup>(1)(2)(3)</sup>     | R    | 0x02                | 0x  | :03  | 0x   | 00  | Data   |   | 6 LSBs of time sample   |
| OUT_Y_MSB <sup>(1)(2)(3)</sup>     | R    | 0x03                | 0x  | 04   | 0x05   | 0x00  | Data   |   | 8 MSBs of time sample   |
| OUT_Y_LSB <sup>(1)(2)(3)</sup>     | R    | 0x04                | 0x  | :05  | 0x   | 00  | Data   |   | 6 LSBs of time sample   |
| OUT_Z_MSB <sup>(1)(2(3))</sup>     | R    | 0x05                | 0x  | :06  | M_CTRL_REG2[hyb_au<br>M_CTRL_REG2[hyb_au                                       | toinc_mode] = $0 \rightarrow 0x00$ ,<br>utoinc_mode] = $1 \rightarrow 0x33$ | Data   |   | 8 MSBs of time sample   |
| OUT_Z_LSB <sup>(1)(2(3))</sup>     | R    | 0x06                |   | M_CTRL_REG2[hyb_aut<br>M_CTRL_REG2[hyb_aut                                     | toinc_mode] = $0 \rightarrow 0x00$ ,<br>utoinc_mode] = $1 \rightarrow 0x33$    |   | Data   |   | 6 LSBs of time sample   |
| Reserved                           | R    | 0x07-<br>0x08       |   | -  | =  |   | 0x00   |   | do not modify<br>tents  |
| F_SETUP <sup>(1)(4)</sup>          | R/W  | 0x09                |   | 0x   | 0A   |   | 0x00   | FIFC  | setup   |
| TRIG_CFG                           | R/W  | 0x0A                |   | 0x   | 0B   |   | 0x00   | FIFO event trigger configuration register   |   |
| SYSMOD <sup>(1)(2)</sup>           | R    | 0x0B                |   | 0x0C   |  |   |  | Current system mode                         |   |
| INT_SOURCE <sup>(1)(2)</sup>       | R    | 0x0C                | 0x0D  |  |  |   | 0x00   | Interrupt status                            |   |
| WHO_AM_I <sup>(1)</sup>            | R    | 0x0D                | 0x0E  |  |  |   | 0xC7   | Dev   | ice ID  |
| XYZ_DATA_CFG <sup>(1)(5)</sup>     | R/W  | 0x0E                | 0x0F  |  |  |   | 0x00   | range and                                   | on dynamic<br>filter enable<br>tings                                    |
| HP_FILTER_CUTOFF <sup>(1)(4)</sup> | R/W  | 0x0F                | 0x10  |  |  |   | 0x00   | pass and lo<br>enable bits<br>filter cutor  | ection high-<br>ow-pass filter<br>s. High-pass<br>f frequency<br>ection |
| PL_STATUS <sup>(1)(2)</sup>        | R    | 0x10                |   | 0x   | :11  |   | 0x00   |   | pe/Portrait<br>on status  |
| PL_CFG <sup>(1)(4)</sup>           | R/W  | 0x11                |   | 0x   | 12   |   | 0x80   |   | pe/Portrait<br>juration   |
| PL_COUNT <sup>(1)(3)</sup>         | R/W  | 0x12                |   | 0x13   |  |   | 0x00   |   | pe/Portrait<br>e counter  |
| PL_BF_ZCOMP <sup>(1)(4)</sup>      | R/W  | 0x13                | 0x14  |  |  | 0x84  |  | t Trip angle<br>shold                       |   |
| PL_THS_REG <sup>(1)(4)</sup>       | R/W  | 0x14                | 0x15  |  |  | 0x44  | Portrait to Landscape Trip Threshold angle and hysteresis settings |   |   |
| A_FFMT_CFG <sup>(1)(4)</sup>       | R/W  | 0x15                | 0x16  |  |  |   | 0x00   | 0x00 Freefall/Motion function configuration |   |
| A_FFMT_SRC <sup>(1)(2)</sup>       | R    | 0x16                | 0x17  |  |  |   | 0x00   | Freefall/Motion event source register       |   |
| A_FFMT_THS <sup>(1)(3)</sup>       | R/W  | 0x17                | 0x18  |  |  |   | 0x00   | Freefall/Motion threshold register          |   |
| A_FFMT_COUNT <sup>(1)(3)</sup>     | R/W  | 0x18                |   |  | :19  |   | 0x00   |   | ion debounce<br>ınter   |

Table 15. Register Address Map (Continued)

| Reserved                          | R/W | 0x19-<br>0x1C | _    | _    | Reserved, do not modify contents   |
|-----------------------------------|-----|---------------|------|------|--|
| TRANSIENT_CFG <sup>(1)(4)</sup>   | R/W | 0x1D          | 0x1E | 0x00 | FIFO setup   |
| TRANSIENT_SRC <sup>(1)(2)</sup>   | R   | 0x1E          | 0x1F | 0x00 | Transient event status register  |
| TRANSIENT_THS <sup>(1)(3)</sup>   | R/W | 0x1F          | 0x20 | 0x00 | Transient event threshold  |
| TRANSIENT_COUNT(1)(3)             | R/W | 0x20          | 0x21 | 0x00 | Transient debounce counter   |
| PULSE_CFG <sup>(1)(4)</sup>       | R/W | 0x21          | 0x22 | 0x00 | Pulse function configuration   |
| PULSE_SRC <sup>(1)(2)</sup>       | R   | 0x22          | 0x23 | 0x00 | Pulse function source register   |
| PULSE_THSX <sup>(1)(3)</sup>      | R/W | 0x23          | 0x24 | 0x00 | X-axis pulse threshold   |
| PULSE_THSY <sup>(1)(3)</sup>      | R/W | 0x24          | 0x25 | 0x00 | Y-axis pulse threshold   |
| PULSE_THSZ <sup>(1)(3)</sup>      | R/W | 0x25          | 0x26 | 0x00 | Z-axis pulse threshold   |
| PULSE_TMLT <sup>(1)(4)</sup>      | R/W | 0x26          | 0x27 | 0x00 | Time limit for pulse detection   |
| PULSE_LTCY <sup>(1)(4)</sup>      | R/W | 0x27          | 0x28 | 0x00 | Latency time for second pulse detection  |
| PULSE_WIND <sup>(1)(4)</sup>      | R/W | 0x28          | 0x29 | 0x00 | Window time for second pulse detection   |
| ASLP_COUNT <sup>(1)(4)</sup>      | R/W | 0x29          | 0x2A | 0x00 | In activity counter setting for Auto-Sleep   |
| CTRL_REG1 <sup>(1)(4)</sup>       | R/W | 0x2A          | 0x2B | 0x00 | System ODR,<br>accelerometer OSR,<br>operating mode  |
| CTRL_REG2 <sup>(1)(4)</sup>       | R/W | 0x2B          | 0x2C | 0x00 | Self-Test, Reset,<br>accelerometer OSR and<br>Sleep mode settings                                  |
| CTRL_REG3 <sup>(1)(4)</sup>       | R/W | 0x2C          | 0x2D | 0x00 | Sleep mode interrupt<br>wake enable, interrupt<br>polarity, push-pull/open-<br>drain configuration |
| CTRL_REG4 <sup>(1)(4)</sup>       | R/W | 0x2D          | 0x2E | 0x00 | Interrupt enable register  |
| CTRL_REG5 <sup>(1)(4)</sup>       | R/W | 0x2E          | 0x2F | 0x00 | Interrupt pin (INT1/INT2)<br>map   |
| OFF_X <sup>(1)(5)</sup>           | R/W | 0x2F          | 0x30 | 0x00 | X-axis accelerometer offset adjust   |
| OFF_Y(1)(5)                       | R/W | 0x30          | 0x31 | 0x00 | Y-axis accelerometer offset adjust   |
| OFF_Z(1)(5)                       | R/W | 0x31          | 0x32 | 0x00 | Z-axis accelerometer offset adjust   |
| M_DR_STATUS                       | R   | 0x32          | 0x33 | 0x00 | Magnetic data ready  |
| M_OUT_X_MSB <sup>(1)(3)(6)</sup>  | R   | 0x33          | 0x34 | Data | MSB of 16-bit magnetic data for X-axis   |
| M_OUT_X_LSB <sup>(1)(3)(6))</sup> | R   | 0x34          | 0x35 | Data | LSB of 16-bit magnetic data for X-axis   |
| M_OUT_Y_MSB <sup>(1)(3)(6)</sup>  | R   | 0x35          | 0x36 | Data | MSB of 16-bit magnetic data for Y-axis   |
| M_OUT_Y_LSB <sup>(1)(3)(6)</sup>  | R   | 0x36          | 0x37 | Data | LSB of 16-bit magnetic data for Y-axis   |
| M_OUT_Z_MSB <sup>(1)(3)(6)</sup>  | R   | 0x37          | 0x38 | Data | MSB of 16-bit magnetic data for Z-axis   |
| M_OUT_Z_LSB <sup>(1)(3)(6)</sup>  | R   | 0x38          | 0x39 | Data | LSB of 16-bit magnetic data for Z-axis   |
| CMP_X_MSB <sup>(1)(5)</sup>       | R   | 0x39          | 0x3A | Data | Bits [13:8] of integrated X axis accerleration data  |

**Table 15. Register Address Map (Continued)** 

| J                           |     |      |      |      |   |
|-----------------------------|-----|------|------|------|---|
| CMP_X_LSB <sup>(1)(5)</sup> | R   | 0x3A | 0x3B | Data | Bits [7:0] of integrated X-<br>axis accerleration data                                |
| CMP_Y_MSB <sup>(1)(5)</sup> | R   | 0x3B | 0x3C | Data | Bits [13:8] of integrated Y-<br>axis accerleration data                               |
| CMP_Y_LSB <sup>(1)(5)</sup> | R   | 0x3C | 0x3D | Data | Bits [7:0] of integrated Y-<br>axis accerleration data                                |
| CMP_Z_MSB <sup>(1)(5)</sup> | R   | 0x3D | 0x3E | Data | Bits [13:8] of integrated Z-<br>axis accerleration data                               |
| CMP_Z_LSB <sup>(1)(5)</sup> | R   | 0x3E | 0x3F | Data | Bits [7:0] of integrated Z-<br>axis accerleration data                                |
| M_OFF_X_MSB <sup>(7)</sup>  | R/W | 0x3F | 0x40 | 0x00 | MSB of magnetometer of<br>X-axis offset   |
| M_OFF_X_LSB <sup>(7)</sup>  | R/W | 0x40 | 0x41 | 0x00 | LSB of magnetometer of<br>X-axis offset   |
| M_OFF_Y_MSB <sup>(7)</sup>  | R/W | 0x41 | 0x42 | 0x00 | MSB of magnetometer of<br>Y-axis offset   |
| M_OFF_Y_LSB <sup>(7)</sup>  | R/W | 0x42 | 0x43 | 0x00 | LSB of magnetometer of<br>Y-axis offset   |
| M_OFF_Z_MSB <sup>(7)</sup>  | R/W | 0x43 | 0x44 | 0x00 | MSB of magnetometer of<br>Z-axis offset   |
| M_OFF_Z_LSB <sup>(7)</sup>  | R/W | 0x44 | 0x45 | 0x00 | LSB of magnetometer of Z-axis offset  |
| MAX_X_MSB <sup>(1)(7)</sup> | R   | 0x45 | 0x46 | Data | Magnetometer X-axis maximum value MSB   |
| MAX_X_LSB <sup>(1)(7)</sup> | R   | 0x46 | 0x47 | Data | Magnetometer X-axis maximum value LSB   |
| MAX_Y_MSB <sup>(1)(7)</sup> | R   | 0x47 | 0x48 | Data | Magnetometer Y-axis maximum value MSB   |
| MAX_Y_LSB <sup>(1)(7)</sup> | R   | 0x48 | 0x49 | Data | Magnetometer Y-axis maximum value LSB   |
| MAX_Z_MSB <sup>(1)(7)</sup> | R   | 0x49 | 0x4A | Data | Magnetometer Z-axis maximum value MSB   |
| MAX_Z_LSB <sup>(1)(7)</sup> | R   | 0x4A | 0x4B | Data | Magnetometer Z-axis maximum value LSB   |
| MIN_X_MSB <sup>(1)(7)</sup> | R   | 0x4B | 0x4C | Data | Magnetometer X-axis minimum value MSB   |
| MIN_X_LSB <sup>(1)(7)</sup> | R   | 0x4C | 0x4D | Data | Magnetometer X-axis minimum value LSB   |
| MIN_Y_MSB <sup>(1)(7)</sup> | R   | 0x4D | 0x4E | Data | Magnetometer Y-axis minimum value MSB   |
| MIN_Y_LSB <sup>(1)(7)</sup> | R   | 0x4E | 0x4F | Data | Magnetometer Y-axis minimum value LSB   |
| MIN_Z_MSB <sup>(1)(7)</sup> | R   | 0x4F | 0x50 | Data | Magnetometer Z-axis minimum value MSB   |
| MIN_Z_LSB <sup>(1)(7)</sup> | R   | 0x50 | 0x51 | Data | Magnetometer Z-axis minimum value LSB   |
| TEMP <sup>(1)</sup>         | R   | 0x51 | 0x52 | Data | Device temperature, valid<br>range of -128 to 127 °C<br>when M_CTRL1[m_hms]<br>> 0b00 |
| M_THS_CFG <sup>(1)(4)</sup> | R/W | 0x52 | 0x53 | 0x00 | Magnetic threshold detection function configuration                                   |
| M_THS_SRC <sup>(1)(2)</sup> | R   | 0x53 | 0x54 | Data | Magnetic threshold event source register  |
| M_THS_X_MSB <sup>(1)</sup>  | R/W | 0x54 | 0x55 | 0x00 | X-axis magnetic threshold MSB   |
| M_THS_X_LSB <sup>(1)</sup>  | R/W | 0x55 | 0x56 | 0x00 | X-axis magnetic threshold LSB   |

Table 15. Register Address Map (Continued)

| M_THS_Y_MSB <sup>(1)</sup>    | R/W | 0x56 | 0x57 | 0x00 | Y-axis magnetic<br>threshold MSB                                |
|-------------------------------|-----|------|------|------|---|
| M_THS_Y_LSB <sup>(1)</sup>    | R/W | 0x57 | 0x58 | 0x00 | Y-axis magnetic<br>threshold LSB                                |
| M_THS_Z_MSB <sup>(1)</sup>    | R/W | 0x58 | 0x59 | 0x00 | Z-axis magnetic threshold MSB                                   |
| M_THS_Z_LSB <sup>(1)</sup>    | R/W | 0x59 | 0x5A | 0x00 | Z-axis magnetic threshold LSB                                   |
| M_THS_COUNT <sup>(1)(3)</sup> | R/W | 0x5A | 0x5B | 0x00 | Magnetic threshold debounce counter                             |
| M_CTRL_REG1                   | R/W | 0x5B | 0x5C | 0x00 | Control for magnetic sensor functions                           |
| M_CTRL_REG2                   | R/W | 0x5C | 0x5D | 0x00 | Control for magnetic sensor functions                           |
| M_CTRL_REG3                   | R/W | 0x5D | 0x5E | 0x00 | Control for magnetic sensor functions                           |
| M_INT_SRC                     | R   | 0x5E | 0x5F | 0x00 | Magnetic interrupt source                                       |
| A_VECM_CFG                    | R/W | 0x5F | 0x60 | 0x00 | Acceleration vector-<br>magnitude configuration<br>register     |
| A_VECM_THS_MSB                | R/W | 0x60 | 0x61 | 0x00 | Acceleration vector-<br>magnitude threshold<br>MSB              |
| A_VECM_THS_LSB                | R/W | 0x61 | 0x62 | 0x00 | Acceleration vector-<br>magnitude threshold LSB                 |
| A_VECM_CNT                    | R/W | 0x62 | 0x63 | 0x00 | Acceleration vector-<br>magnitude debounce<br>count             |
| A_VECM_INITX_MSB              | R/W | 0x63 | 0x64 | 0x00 | Acceleration vector-<br>magnitude X-axis<br>reference value MSB |
| A_VECM_INITX_LSB              | R/W | 0x64 | 0x65 | 0x00 | Acceleration vector-<br>magnitude X-axis<br>reference value LSB |
| A_VECM_INITY_MSB              | R/W | 0x65 | 0x66 | 0x00 | Acceleration vector-<br>magnitude Y-axis<br>reference value MSB |
| A_VECM_INITY_LSB              | R/W | 0x66 | 0x67 | 0x00 | Acceleration vector-<br>magnitude Y-axis<br>reference value LSB |
| A_VECM_INITZ_MSB              | R/W | 0x67 | 0x68 | 0x00 | Acceleration vector-<br>magnitude Z-axis<br>reference value MSB |
| A_VECM_INITZ_LSB              | R/W | 0x68 | 0x69 | 0x00 | Acceleration vector-<br>magnitude Z-axis<br>reference value LSB |
| M_VECM_CFG                    | R/W | 0x69 | 0x6A | 0x00 | Magnetic vector-<br>magnitude configuration<br>register         |
| M_VECM_THS_MSB                | R/W | 0x6A | 0x6B | 0x00 | Magnetic vector-<br>magnitude threshold<br>MSB                  |
| M_VECM_THS_LSB                | R/W | 0x6B | 0x6C | 0x00 | Magnetic vector-<br>magnitude threshold LSB                     |
| M_VECM_CNT                    | R/W | 0x6C | 0x6D | 0x00 | Magnetic vector-<br>magnitude debounce<br>count                 |
| M_VECM_INITX_MSB              | R/W | 0x6D | 0x6E | 0x00 | Magnetic vector-<br>magnitude reference<br>value X-axis MSB     |

**Table 15. Register Address Map (Continued)** 

| M_VECM_INITX_LSB | R/W | 0x6E | 0x6F | 0x00 | Magnetic vector-<br>magnitude reference<br>value X-axis LSB |
|------------------|-----|------|------|------|---|
| M_VECM_INITY_MSB | R/W | 0x6F | 0x70 | 0x00 | Magnetic vector-<br>magnitude reference<br>value Y-axis MSB |
| M_VECM_INITY_LSB | R/W | 0x70 | 0x71 | 0x00 | Magnetic vector-<br>magnitude reference<br>value Y-axis LSB |
| M_VECM_INITZ_MSB | R/W | 0x71 | 0x72 | 0x00 | Magnetic vector-<br>magnitude reference<br>value Z-axis MSB |
| M_VECM_INITZ_LSB | R/W | 0x72 | 0x73 | 0x00 | Magnetic vector-<br>magnitude reference<br>value Z-axis LSB |
| A_FFMT_THS_X_MSB | R/W | 0x73 | 0x74 | 0x00 | X-axis FMT threshold<br>MSB                                 |
| A_FFMT_THS_X_LSB | R/W | 0x74 | 0x75 | 0x00 | X-axis FFMT threshold LSB                                   |
| A_FFMT_THS_Y_MSB | R/W | 0x75 | 0x76 | 0x00 | Y-axis FFMT threshold<br>MSB                                |
| A_FFMT_THS_Y_LSB | R/W | 0x76 | 0x77 | 0x00 | Y-axis FFMT threshold<br>LSB                                |
| A_FFMT_THS_Z_MSB | R/W | 0x77 | 0x78 | 0x00 | Z-axis FFMT threshold<br>MSB                                |
| A_FFMT_THS_Z_LSB | R/W | 0x78 | 0X79 | 0x00 | Z-axis FFMT threshold<br>LSB                                |
| Reserved         |     | 0x79 | _    | _    | Reserved, do not modify                                     |

- 1. Register contents are preserved when transitioning from Active-to-Standby mode.
- 2. Register contents are reset when transitioning from Standby-to-Active mode.
- 3. Hybrid auto-increment mode may be used to read out acceleration and magnetic data from registers x1-x6 using a burst read transaction. When M\_CTRL\_REG2[hyb\_autoinc\_mode] = 1, the user may do a burst read of 12 bytes starting from OUT\_X\_MSB (address 0x1) to read out both the current accelerometer and magnetometer data in one contiguous operation.
- 4. Register contents can be modified anytime in Standby or Active mode. A write to this register will cause a reset of the corresponding internal system debounce counter.
- 5. Modification of this register's contents can only occur when device is in Standby mode, except the FS[1:0] bit fields in XYZ\_DATA\_CFG register.
- 6. To ensure that valid data is read from these registers, the user must first read the M\_OUT\_X\_MSB register in either burst or single-read mode. Reading of the M\_OUT\_X\_MSB register triggers the update of the M\_OUT\_X/Y/Z registers with the current time-aligned output data.
- 7. To ensure that valid data is read from these registers, the user must first read the MSB register of each register pair in either burst or single-read mode. Reading of the LSB register without first reading the MSB register will result in invalid data.

#### **NOTE**

The auto-increment addressing is only enabled when registers are read using burst read mode when configured for either  $I^2C$  or SPI. The auto-increment address is automatically reset to 0x00 in  $I^2C$  mode when a stop condition is detected. In SPI mode there is no stop condition and the auto-increment address is not automatically reset to 0x00.

# 9 Example FXOS8700CQ Driver Code

#### 9.1 Introduction

It is very straightforward to configure the FXOS8700CQ and start receiving data from the three accelerometer and three magnetometer channels. Unfortunately, since every hardware platform will be different, it is not possible to provide completely portable software drivers. This section therefore provides real FXOS8700CQ driver code for a Kinetis uC board running under the MQX operating system. The I<sup>2</sup>C functions s\_i2c\_read\_regs and s\_i2c\_write\_regs are not provided here and should be replaced with the corresponding low level I<sup>2</sup>C driver code on the development platform.

#### 9.2 FXOS8700CQ Addresses

This section lists the  $I^2C$  address of the FXOS8700CQ. The  $I^2C$  address depends on the logic level of FXOS8700CQ's SA0 and SA1 address selection pins, so the actual  $I^2C$  address may be 0x1C, 0x1D, 0x1E or 0x1F.

Please see Table 10 for the available I<sup>2</sup>C addresses and SA1/SA0 settings.

#### Example 1.

```
// FXOS8700CQ I2C address #define FXOS8700CQ_SLAVE_ADDR 0x1E // with pins SA0=0, SA1=0
```

Some of the key FXOS8700CQ internal register addresses are listed below.

#### Example 2.

```
// FXOS8700CQ internal register addresses
#define FXOS8700CQ_STATUS 0x00
#define FXOS8700CQ_WHOAMI 0x00
#define FXOS8700CQ_XYZ_DATA_CFG 0x0E
#define FXOS8700CQ_CTRL_REG1 0x2A
#define FXOS8700CQ_M_CTRL_REG1 0x5B
#define FXOS8700CQ_M_CTRL_REG2 0x5C
#define FXOS8700CQ_WHOAMI_VAL 0xC7
```

The reference driver code shown in this example does a block read of the FXOS8700CQ status byte and three 16-bit accelerometer channels plus three 16-bit magnetometer channels for a total of 13 bytes in a single I<sup>2</sup>C read operation.

#### Example 3.

```
// number of bytes to be read from the FXOS8700CQ
#define FXOS8711CQFXOS8701CQFXOS8700CQ_READ_LEN 13// status plus 6 channels = 13
bytes
```

#### 9.3 Sensor data structure

The high and low bytes of the three accelerometer and three magnetometer channels are placed into a structure of type SRAWDATA containing three signed short integers.

### Example 4.

```
typedef struct
{
  int16_t x;
  int16_t y;
  int16_t z;
} SRAWDATA;
```

### 9.4 FXOS8700CQConfiguration function

This function configures the FXOS8700CQ for 200-Hz hybrid mode meaning that both accelerometer and magnetometer data are provided at the 200-Hz rate. The code is self-explanatory and can be easily customized for different settings.

#### Example 5.

```
// function configures FXOS8700CQcombination accelerometer and magnetometer sensor
 static mgx int s FXOS8700CO start(MOX FILE PTR aFP)
  uint8_t databyte;
  // read and check the FXOS8700CQ WHOAMI register
  if (s_i2c_read_regs(aFP, FXOS8700CQ_SLAVE_ADDR, FXOS8700CQ_WHOAMI, &databyte,
     (uint8_t) 1) != 1)
    return (I2C_ERROR);
  if (databyte != FXOS8700CQ WHOAMI VAL)
    return (I2C_ERROR);
  // write 0000 0000 = 0x00 to accelerometer control register 1 to place FXOS8700CQ
into
  // standby
  // [7-1] = 0000 000
  // [0]: active=0
  databyte = 0x00;
  if (s_i2c_write_regs(aFP, FXOS8700CQ_SLAVE_ADDR, FXOS8700CQ_CTRL_REG1, &databyte,
     (uint8 t) 1) != 1)
    return (I2C_ERROR);
  }
  // write 0001 1111 = 0x1F to magnetometer control register 1
  // [7]: m_acal=0: auto calibration disabled
  // [6]: m_rst=0: no one-shot magnetic reset
  // [5]: m_ost=0: no one-shot magnetic measurement
  // [4-2]: m_os=111=7: 8x oversampling (for 200Hz) to reduce magnetometer noise
  // [1-0]: m_hms=11=3: select hybrid mode with accel and magnetometer active
  databyte = 0x1F;
  if (s_i2c_write_regs(aFP, FXOS8700CQ_SLAVE_ADDR, FXOS8700CQ_M_CTRL_REG1,
    &databyte, (uint8_t) 1) != 1)
    return (I2C ERROR);
  // write 0010 0000 = 0x20 to magnetometer control register 2
  // [7]: reserved
  // [6]: reserved
  // [5]: hyb_autoinc_mode=1 to map the magnetometer registers to follow the
  // accelerometer registers
  // [4]: m_maxmin_dis=0 to retain default min/max latching even though not used
  // [3]: m_maxmin_dis_ths=0
  // [2]: m_maxmin_rst=0
  // [1-0]: m rst cnt=00 to enable magnetic reset each cycle
  databyte = 0x20;
```

```
if (s i2c write regs(aFP, FXOS8700CQ SLAVE ADDR, FXOS8700CQ M CTRL REG2,
  &databyte, (uint8_t) 1) != 1)
  return (I2C_ERROR);
// write 0000 0001= 0x01 to XYZ_DATA_CFG register
// [7]: reserved
// [6]: reserved
// [5]: reserved
// [4]: hpf out=0
// [3]: reserved
// [2]: reserved
// [1-0]: fs=01 for accelerometer range of +/-4g range with 0.488mg/LSB
databyte = 0x01;
if (s_i2c_write_regs(aFP, FXOS8700CQ_SLAVE_ADDR, FXOS8700CQ_XYZ_DATA_CFG,
  &databyte, (uint8 t) 1) != 1)
  return (I2C_ERROR);
}
// write 0000 1101 = 0x0D to accelerometer control register 1
// [7-6]: aslp rate=00
// [5-3]: dr=001 for 200Hz data rate (when in hybrid mode)
// [2]: lnoise=1 for low noise mode
// [1]: f_read=0 for normal 16 bit reads
// [0]: active=1 to take the part out of standby and enable sampling
databyte = 0x0D;
if (s_i2c_write_regs(aFP, FXOS8700CQ_SLAVE_ADDR, FXOS8700CQ_CTRL_REG1, &databyte,
  (uint8_t) 1) != 1)
  return (I2C ERROR);
// normal return
return (I2C OK);
```

#### 9.5 Data Read function

This function performs a block read of the status, accelerometer and magnetometer measurement registers and places the bytes read into the structures of type SRAWDATA as signed short integers.

Note that this function assumes that the hyb\_autoinc\_mode bit has been set to enable the reading of all accelerometer and magnetometer data in a single burst read operation.

#### Example 6.

```
{
  // copy the 14 bit accelerometer byte data into 16 bit words
  pAccelData->x = (int16_t)(((Buffer[1] << 8) | Buffer[2]))>> 2;
  pAccelData->y = (int16_t)(((Buffer[3] << 8) | Buffer[4]))>> 2;
  pAccelData->z = (int16_t)(((Buffer[5] << 8) | Buffer[6]))>> 2;
  // copy the magnetometer byte data into 16 bit words
  pMagnData->x = (Buffer[7] << 8) | Buffer[8];</pre>
  pMagnData->y = (Buffer[9] << 8) | Buffer[10];</pre>
  pMagnData->z = (Buffer[11] << 8) | Buffer[12];</pre>
}
else
  // return with error
  return (I2C_ERROR);
}
// normal return
return (I2C_OK);
```

# 10 Registers by Functional Blocks

# 10.1 Device configuration

### 10.1.1 STATUS (0x00) register

#### Table 16. STATUS register

|   |   |   | DR_STATUS | or F_STATUS |   |   |   |
|---|---|---|-----------|-------------|---|---|---|
| 0 | 0 | 0 | 0         | 0           | 0 | 0 | 0 |

#### **Table 17. STATUS Description**

| Field                      | Description               |
|----------------------------|---------------------------|
| $F\_SETUP[f\_mode] = 0b00$ | register 0x00 → DR_STATUS |
| F_SETUP[f_mode] > 0b00     | register 0x00 → F_STATUS  |

The STATUS register aliases allow for the contiguous burst read of both status and current acceleration sample/FIFO data using the auto-increment addressing mechanism in both 8- and 14-bit modes.

### 10.1.2 DR\_STATUS (0x00) register

Data-Ready Status when  $F_SETUP[f_mode] = 0x00$ 

This STATUS register provides the acquisition status information on a per-sample basis, and reflects real-time updates to the OUT\_X, OUT\_Y, and OUT\_Z registers.

When the FIFO subsystem data output register driver is disabled (F\_SETUP[f\_mode] = 0b00), this register indicates the real-time status information of the accelerometer X, Y, and Z axes sample data.

#### Table 18. DR\_STATUS register

| zyxow | zow | yow | xow | zyxdr | zdr | ydr | xdr |
|-------|-----|-----|-----|-------|-----|-----|-----|
| 0     | 0   | 0   | 0   | 0     | 0   | 0   | 0   |

#### Table 19. DR\_STATUS description

| Field | Description  |
|-------|--|
| zyxow | <ul> <li>zyxow is set to 1 whenever new data is acquired before completing the retrieval of the previous set. This event occurs when the content of at least one acceleration data register (that is, OUT_X, OUT_Y, and OUT_Z) has been overwritten. zyxow is cleared when the high-bytes of the acceleration data (OUT_X_MSB, OUT_Y_MSB, and OUT_Z_MSB) are read.</li> <li>X, Y, Z-axis data overwrite.</li> <li>No data overwrite has occurred</li> <li>Previous X, Y, Z data was overwritten by new X, Y, Z data before it was completely read</li> </ul> |
| zow   | zow is set to 1 whenever a new Z-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. zow is cleared anytime OUT_Z_MSB register is read.  Z-axis data overwrite.  0: No data overwrite has occurred  1: Previous Z-axis data was overwritten by new Z-axis data before it was read  |
| yow   | yow is set to 1 whenever a new Y-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. yow is cleared anytime OUT_Y_MSB register is read. Y-axis data overwrite.  0: No data overwrite has occurred 1: Previous Y-axis data was overwritten by new Y-axis data before it was read  |
| xow   | <ul> <li>xow is set to 1 whenever a new X-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. xow is cleared anytime OUT_X_MSB register is read.</li> <li>X-axis data overwrite.</li> <li>0: No data overwrite has occurred</li> <li>1: Previous X-axis data was overwritten by new X-axis data before it was read</li> </ul>  |

#### Table 19. DR\_STATUS description (Continued)

|       | <i>zyxdr</i> signals that a new acquisition for any of the enabled channels is available. <i>zyxdr</i> is cleared when the high-bytes of the acceleration data (OUT_X_MSB, OUT_Y_MSB, OUT_Z_MSB) are read. |
|-------|--|
| zyxdr | X, Y, Z-axis new data ready.   |
|       | 0: No new set of data ready  |
|       | 1: New set of data is ready  |
|       | zdr is set to 1 whenever a new Z-axis data acquisition is completed. zdr is cleared anytime the OUT_Z_MSB register is read.  |
| zdr   | Z-axis new data available.   |
| Zui   | 0: No new Z-axis data is ready   |
|       | 1: New Z-axis data is ready  |
|       | ydr is set to 1 whenever a new Y-axis data acquisition is completed. ydr is cleared anytime the OUT_Y_MSB register is read.  |
| ydr   | Y-axis new data available. Default value: 0  |
| yui   | 0: No new Y-axis data ready  |
|       | 1: New Y-axis data is ready  |
|       | xdr is set to 1 whenever a new X-axis data acquisition is completed. xdr is cleared anytime the OUT_X_MSB register is read.  |
| xdr   | X-axis new data available. Default value: 0  |
| XUI   | 0: No new X-axis data ready  |
|       | 1: New X-axis data is ready  |

### 10.1.3 F\_STATUS (0x00) register

FIFO Status when  $F_SETUP[f_mode] = 0x00 > 0x00$ .

If the FIFO subsystem data output register driver is enabled, the status register indicates the current status information of the FIFO subsystem.

#### Table 20. F\_STATUS register

| f_ovf | f_wmrk_flag | f_cnt[5:0] |
|-------|-------------|------------|
| 0     | 0           | 0b00_0000  |

#### Table 21. FIFO flag event descriptions

| f_ovf | f_wmrk_flag | Event description  |
|-------|-------------|--|
| 0     | X           | No FIFO overflow events detected.  |
| 1     | Х           | FIFO overflow event detected.  |
| Х     | 0           | No FIFO watermark event detected.  |
| Х     | 1           | A FIFO Watermark event was detected indicating that a FIFO sample count greater than watermark value has been reached.  If F_SETUP[f_mode] = 0b11, a FIFO trigger event was detected |

The f\_ovf and f\_wmrk\_flag flags remain asserted while the event source is still active, but the user can clear the FIFO interrupt bit in the interrupt source register (INT\_SOURCE) by reading the F\_STATUS register. In this case, the INT\_SOURCE[src\_fifo] bit will be set again when the next data sample enters the FIFO.

Therefore the  $f\_ovf$  bit will remain asserted while the FIFO has overflowed and the  $f\_wmrk\_flag$  bit will remain asserted while the  $f\_cnt$  value is equal to or greater than then  $f\_wmrk$  value.

Table 22. FIFO sample count bit description

| Field       | Description   |  |
|-------------|---|--|
| f antifical | These bits indicate the number of acceleration samples currently stored in the FIFO buffer. Count 0b00_0000 indicates that the FIFO is empty. |  |
| f_cnt[5:0]  | FIFO sample counter. Default value 0b00_0000.   |  |
|             | (0b00_0001 to 0b10_0000 indicates 1 to 32 samples stored in FIFO  |  |

### 10.1.4 TRIG\_CFG (0x0A) register

FIFO trigger configuration register. After the interrupt flag of the enabled event in TRIG\_CFG is set, the FIFO (when configured in Trigger mode) is gated at the time of the interrupt event preventing the further collection of data samples. This allows the host processor to analyze the data leading up to the event detection (up to 32 samples). For detailed information on how to utilize the FIFO and the various trigger events, please see AN4073 available on the Freescale website.

#### Table 23. TRIG\_CFG register

| _ | _ | trig_trans | trig_Indprt | trig_pulse | trig_ffmt | trig_a_vecm | _ |
|---|---|------------|-------------|------------|-----------|-------------|---|
| 0 | 0 | 0          | 0           | 0          | 0         | 0           | 0 |

#### Table 24. TRIG\_CFG bit descriptions

| Field       | Description   |  |
|-------------|---|--|
| trig_trans  | Transient interrupt FIFO trigger enable.                      |  |
| trig_Indprt | .andscape/Portrait orientation interrupt FIFO trigger enable. |  |
| trig_pulse  | Pulse interrupt FIFO trigger enable                           |  |
| trig_ffmt   | Freefall/motion interrupt FIFO trigger enable                 |  |
| trig_a_vecm | Acceleration vector-magnitude FIFO trigger enable.            |  |

### 10.1.5 SYSMOD (0x0B) register

#### Table 25. SYSMOD register

| fgerr | fgt[4:0] | sysmod[1:0] |
|-------|----------|-------------|
| 0b0   | 0b0_0000 | 0b00        |

#### Table 26. SYSMOD bit description

| Field       | Description   |  |  |
|-------------|---|--|--|
| fgerr       | FIFO gate error. Default value: 0. 0: No FIFO gate error detected. 1: FIFO gate error was detected. Emptying the FIFO buffer clears the <i>fgerr</i> bit in the SYSMOD register. See CTRL_REG3 [Interrupt CTRL register] (0x2C) for more information on configuring the FIFO Gate function. |  |  |
| fgt[4:0]    | Number of ODR time units since fgerr was asserted. Reset when fgerr is cleared  |  |  |
| sysmod[1:0] | System mode. Default value: 0b00. 0b00: Standby mode 0b01: Wake mode 0b01: Sleep mode   |  |  |

The system mode register indicates the current device operating mode. Applications using the Auto-Sleep/Auto-Wake mechanism should use this register to synchronize their application with the device operating mode. The system mode register also indicates the status of the FIFO gate error flag and the time elapsed since the FIFO gate error flag was asserted.

# 10.1.6 INT\_SOURCE (0x0C) register

Interrupt source register. The bits that are set (logic '1') indicate which function has asserted its interrupt and conversely bits that are cleared (logic '0') indicate which function has not asserted its interrupt. Additional interrupt flags for magnetic interrupt events are located in the M\_INT\_SRC register (0x5E).

Reading the INT\_SOURCE register does not clear any interrupt status bits (except for src\_a\_vecm, see below); the respective interrupt flag bits are reset by reading the appropriate source register for the function that generated the interrupt.

Table 27. INT\_SOURCE register

| ſ | src_aslp | src_fifo | src_trans | src_Indprt | src_pulse | src_ffmt | src_a_vecm | src_drdy |
|---|----------|----------|-----------|------------|-----------|----------|------------|----------|
| ſ | 0        | 0        | 0         | 0          | 0         | 0        | 0          | 0        |

# Table 28. INT\_SOURCE bit descriptions

| Field      | Description   |
|------------|---|
| src_aslp   | Auto-Sleep/Wake interrupt status bit: logic '1' indicates that an interrupt event that can cause a Wake-to-Sleep or Sleep-to-Wake system mode transition has occurred and logic '0' indicates that no Wake-to-Sleep or Sleep-to-Wake system mode transition interrupt event has occurred.  The "Wake-to-Sleep" transition occurs when a period of inactivity that exceeds the user-specified time limit (ASLP_COUNT) has been detected, thus causing the system to transition to a user-specified low ODR setting.  A "Sleep-to-Wake" transition occurs when the user-specified interrupt event has awakened the system, thus causing the system to transition to the user-specified higher ODR setting.  Reading the SYSMOD register will clear the <i>src_aslp</i> bit. |
| src_fifo   | FIFO interrupt status bit: logic '1' indicates that a FIFO interrupt event such as an overflow or watermark (F_STATUS[f_cnt] = F_STATUS[f_wmrk]) event has occurred and logic '0' indicates that no FIFO interrupt event has occurred. This bit is cleared by reading the F_STATUS register.  |
| src_trans  | Transient interrupt status bit: logic '1' indicates that an acceleration transient value greater than user-specified threshold has occurred. and logic '0' indicates that no transient event has occurred.  This bit is asserted whenever TRANSIENT_SRC[ea] is asserted and the functional block interrupt has been enabled. This bit is cleared by reading the TRANSIENT_SRC register.   |
| src_Indprt | Landscape/Portrait orientation interrupt status bit: logic '1' indicates that an interrupt was generated due to a change in the device orientation status and logic '0' indicates that no change in orientation status was detected.  This bit is asserted whenever PL_STATUS[newlp] is asserted and the functional block interrupt has been enabled.  This bit is cleared by reading the PL_STATUS register.   |
| src_pulse  | Pulse interrupt status bit: logic '1' indicates that an interrupt was generated due to single- and/or double- pulse event and logic '0' indicates that no pulse event was detected.  This bit is asserted whenever PULSE_SRC[ea] is asserted and the functional block interrupt has been enabled.  This bit is cleared by reading the PULSE_SRC register.   |
| src_ffmt   | Freefall/motion interrupt status bit: logic '1' indicates that the freefall/motion function interrupt is active and logic '0' indicates that no freefall or motion event was detected.  This bit is asserted whenever A_FFMT_SRC[ea] is asserted and the functional block interrupt has been enabled.  This bit is cleared by reading the A_FFMT_SRC register.  |
| src_a_vecm | Accelerometer vector-magnitude interrupt status bit: logic '1' indicates that an interrupt was generated due to acceleration vector-magnitude function and logic '0' indicates that no interrupt has been generated. This bit is cleared by reading this register (INT_SOURCE).   |
| src_drdy   | Data-ready interrupt status bit. In acceleration only mode this bit indicates that new accelerometer data is available to read. In magnetometer only mode, $src\_drdy$ indicates that new magnetic data is available to be read. In hybrid mode, this bit signals that new acceleration and/or magnetic data is available.  The $src\_drdy$ interrupt flag is cleared by reading out the acceleration data in accelerometer only mode and by reading out the magnetic data in magnetometer only or hybrid modes. In hybrid mode and with M_CTRL_REG2[hyb_autoinc_mode] = 1, all of the sensor data can be read out in a 12-byte burst read starting at register 0x01 (OUT_X_MSB).   |

# 10.1.7 WHO\_AM\_I (0x0D) register

#### Table 29. WHO\_AM\_I register

| who_am_i[7:0] |
|---------------|
| 0xC7          |

Device identification register. This register contains the device identifier which is set to 0xC4 for preproduction devices and 0xC7 for production devices.

# 10.1.8 CTRL\_REG1 (0x2A) register

#### **NOTE**

Except for Standby mode selection, the device must be in Standby mode to change any of the fields within CTRL\_REG1 (0x2A).

#### Table 30. CTRL\_REG1 register

| aslp_rate[1:0] | dr[2:0] | Inoise | f_read | active |
|----------------|---------|--------|--------|--------|
| 0b00           | 0b001   | 0      | 0      | 0      |

# Table 31. CTRL\_REG1 bit descriptions

| Field          | Description   |
|----------------|---|
| aslp_rate[1:0] | Configures the auto-wake sample frequency when the device is in Sleep mode.  See Table 32 for more information.   |
| dr[2:0]        | Output Data Rate (ODR) selection. See Table 32 for more information.  |
| Inoise         | Reduced noise and full-scale range mode (analog gain times 2).  0: Normal mode  1: Reduced noise mode; Note that the FSR setting is restricted to ±2 g or ±4 g mode. This feature cannot be used in ±8 g mode.  |
| f_read         | Fast-read mode: Data format is limited to the 8-bit MSB for accelerometer output data. The auto-address pointer will skip over the LSB addresses for each axes sample data when performing a burst read operation.  0: Normal mode  1: Fast-read mode |
| active         | Standby/Active. 0: Standby mode 1: Active mode  |

Table 32. Sleep mode ODR selection

| aslp_rate[1] | aslp_rate[0] | Frequency (Hz) |
|--------------|--------------|----------------|
| 0            | 0            | 50             |
| 0            | 1            | 12.5           |
| 1            | 0            | 6.25           |
| 1            | 1            | 1.56           |

It is important to note that when the device is in Auto-Sleep mode, the system ODR and data rate for all the system functional blocks is overridden by the sleep data rate set by the aslp\_rate field. When hybrid mode is enabled, the frequency is one-half of what is shown in Table 32. For example, with aslp\_rate = 0b00 the frequency is 25 Hz.

Table 32 shows the various system output data rates (ODR) that may be selected using the dr[2:0] bits. The selected ODR is reduced by a factor of two when the device is operated in hybrid mode.

Table 33. System Output Data Rate selection

| dr[2] | dr[1] | dr[0] | ODR accelerometer or magnetometer only modes (Hz) | Period accelerometer or magnetometer only modes (ms) | ODR hybrid mode (Hz) | Period hybrid mode (ms) |
|-------|-------|-------|---|--|----------------------|-------------------------|
| 0     | 0     | 0     | 800.0   | 1.25   | 400                  | 2.5                     |
| 0     | 0     | 1     | 400.0   | 2.5  | 200                  | 5                       |
| 0     | 1     | 0     | 200.0   | 5  | 100                  | 10                      |
| 0     | 1     | 1     | 100.0   | 10   | 50                   | 20                      |
| 1     | 0     | 0     | 50.0  | 20   | 25                   | 80                      |
| 1     | 0     | 1     | 12.5  | 80   | 6.25                 | 160                     |
| 1     | 1     | 0     | 6.25  | 160  | 3.125                | 320                     |
| 1     | 1     | 1     | 1.5625  | 640  | 0.7813               | 1280                    |

The active bit selects between Standby mode and Active mode. The default value is 0 (Standby mode) on reset.

The *Inoise* bit selects between normal full dynamic range mode and a high sensitivity, low-noise mode. In low-noise mode the maximum signal that can be measured is  $\pm 4$  g. Note: Any thresholds set above 4 g will not be reached.

The  $f\_read$  bit selects between normal and fast-read modes where the auto-increment counter will also skip over the LSB data bytes when  $f\_read = 1$ . In hybrid mode and with M\_CTRL\_REG2[hyb\_autoinc\_mode] = 1, all of the sensor data MSB's can be read out with a single 6-byte burst read starting at the OUT\_X\_MSB register.

#### NOTE

The f\_read bit can only be changed while F\_SETUP[f\_mode] = 0.

# 10.1.9 CTRL\_REG2 (0x2B) register

Table 34. CTRL\_REG2 register

| st | rst | _ | smods[1:0] | slpe | mods[1:0] |
|----|-----|---|------------|------|-----------|
| 0  | 0   | 0 | 0b00       | 0    | 0b00      |

Table 35. CTRL\_REG2 bit descriptions

| Field      | Description   |  |  |
|------------|---|--|--|
| st         | The <i>st</i> bit activates the accelerometer self-test function. When <i>st</i> is set to 1, a change will occur in the device output levels for each axis, allowing the host application to check the functionality of the transducer and measurement signal chain. Self-Test Enable:  0: Self-Test disabled  1: Self-Test enabled.   |  |  |
| rst        | The <i>rst</i> bit is used to initiate a software reset. The reset mechanism can be enabled in both Standby and Active modes. When the <i>rst</i> bit is set, the boot mechanism resets all functional block registers and loads the respective internal registers with their default values. Refer to FXOS8700CQER for further information and a suggested work-around. After setting the <i>rst</i> bit, the system will automatically transition to Standby mode. Therefore, if the system was already in Standby mode, the reboot process will immediately begin; else if the system was in Active mode the boot mechanism will automatically transition the system from Active mode to Standby mode, only then can the reboot process begin. A system reset can also be initiated by pulsing the external RST pin high.  The I <sup>2</sup> C and SPI communication systems are also reset to avoid corrupted data transactions. On issuing a Software Reset command over an I <sup>2</sup> C interface, the device immediately resets and does not send any acknowledgment (ACK) of the written byte to the Master. The host application has to implement the I <sup>2</sup> C driver in such a way that it does not look for an ACK following a soft reset command. Also, the host application should allow 1 ms between issuing a software (setting <i>rst</i> bit) or hardware (pulsing RST pin) reset and attempting communications with the device over the I <sup>2</sup> C or SPI interfaces. When the SPI interface mode is desired and multiple devices are present on the bus, make sure that the bus is quiet (all slave device MISO pins are high-z) during this 1 ms period to ensure the device does not inadvertently enter I <sup>2</sup> C mode. See Section 5.2.3 for further information about the interface mode auto-detection circuit.  At the end of the boot process, the <i>rst</i> bit is hardware cleared.  0: Device reset disabled  1: Device reset enabled. |  |  |
| smods[1:0] | Accelerometer Sleep mode OSR mode selection. This setting, along with the CTRL_REG1[aslp_rate] ODR setting determines the Sleep mode power and noise for acceleration measurements. See Table 32 and Table 36 for more information.   |  |  |

# Table 35. CTRL\_REG2 bit descriptions

| slpe <sup>(1)</sup> | Auto-Sleep mode enable: 0: Auto-Sleep is not enabled 1: Auto-Sleep is enabled.   |
|---------------------|--|
| I modeliiii         | Accelerometer Wake mode OSR mode selection. This setting, along with the ODR selection (CTRL_REG1[dr]) determines the Wake mode power and noise for acceleration measurements. See Table 36 and Table 37 for more information. |

<sup>1.</sup> When slpe = 1, a transition between Sleep mode and Wake mode (or vice-versa) results in a FIFO flush and resets all of the internal functions debounce counters. All functional block status information is preserved except where otherwise indicated. For further information, refer to the CTRL\_REG3 register description (fifo\_gate bit).

Table 36. CTRL\_REG2[(s)mods] oversampling modes

| (s)mods[1] | (s)mods[0] | Power mode           |
|------------|------------|----------------------|
| 0          | 0          | Normal               |
| 0          | 1          | Low Noise, Low Power |
| 1          | 0          | High Resolution      |
| 1          | 1          | Low Power            |

Table 37. Oversampling Ratio versus oversampling mode

| Accelerometer OSR |        |                      |                 |           |
|-------------------|--------|----------------------|-----------------|-----------|
| ODR (Hz)          | Normal | Low Noise, Low Power | High Resolution | Low Power |
| 1.5625            | 128    | 32                   | 1024            | 16        |
| 6.25              | 32     | 8                    | 256             | 4         |
| 12.5              | 16     | 4                    | 128             | 2         |
| 50                | 4      | 4                    | 32              | 2         |
| 100               | 4      | 4                    | 16              | 2         |
| 200               | 4      | 4                    | 8               | 2         |
| 400               | 4      | 4                    | 4               | 2         |
| 800               | 2      | 2                    | 2               | 2         |

# 10.1.10 CTRL\_REG3 [Interrupt Control Register] (0x2C) register

# Table 38. CTRL\_REG3 register

| fifo_gate | wake_trans | wake_Indprt | wake_pulse | wake_ffmt | wake_a_vecm | ipol | pp_od |
|-----------|------------|-------------|------------|-----------|-------------|------|-------|
| 0         | 0          | 0           | 0          | 0         | 0           | 0    | 0     |

# Table 39. CTRL\_REG3 bit descriptions

| Field       | Description  |
|-------------|--|
|             | 0: FIFO gate is bypassed. FIFO is flushed upon the system mode transitioning from Wake-to-Sleep mode or from Sleep-to-Wake mode.   |
| fifo_gate   | 1: The FIFO input buffer is blocked from accepting new samples when transitioning from "Wake-to-Sleep" mode or from "Sleep-to-Wake" mode until the FIFO is flushed <sup>(1)</sup> . Although the system transitions from "Wake-to-Sleep" or from "Sleep-to-Wake" the contents of the FIFO buffer are preserved and new data samples are ignored until the FIFO is emptied by the host application. |
|             | If the <i>fifo_gate</i> bit is set to logic '1' and the FIFO buffer is not emptied before the arrival of the next sample, then the SYSMOD[ <i>fgerr</i> ] will be asserted. The SYSMOD[ <i>fgerr</i> ] bit remains asserted as long as the FIFO buffer remains unemptied.  |
|             | Emptying the FIFO buffer clears the SYS_MOD[fgerr] register.   |
| wake_tran   | Transient function is disabled in Sleep mode     Transient function is enabled in Sleep mode and can generate an interrupt to wake the system  |
| wake_Indprt | O: Orientation function is disabled Sleep mode.     Crientation function is enabled in Sleep mode and can generate an interrupt to wake the system   |
| wake_pulse  | O: Pulse function is disabled in Sleep mode     Pulse function is enabled in Sleep mode and can generate an interrupt to wake the system   |
| wake_ffmt   | Treefall/motion function is disabled in Sleep mode     Treefall/motion function is enabled in Sleep mode and can generate an interrupt to wake the system  |
| wake_a_vecm | O: Acceleration vector-magnitude function is disabled in Sleep mode     1: Acceleration vector-magnitude function is enabled in Sleep mode and can generate an interrupt to wake the system  |
| ipol        | The <i>ipol</i> The bit selects the logic polarity of the interrupt signals output on the INT1 and INT2 pins. INT1/INT2 interrupt logic polarity: 0: Active low (default) 1: Active high   |
| pp_od       | INT1/INT2 push-pull or open-drain output mode selection. The open-drain configuration can be used for connecting multiple interrupt signals on the same interrupt line but will require an external pullup resistor to function correctly.  0: Push-pull (default)  1: Open-drain  |

<sup>1.</sup> The FIFO contents are flushed whenever the system ODR changes in order to prevent the mixing of FIFO data from different ODR periods.

The wake enable bits for the magnetic threshold and magnetic vector-magnitude functions are located in registers 0x52 (MAG\_THS\_CFG) and 0x69 (M\_VECM\_CFG), respectively.

# 10.1.11 CTRL\_REG4 [Interrupt Enable Register] (0x2D) register

# Table 40. CTRL\_REG4 register

| int_en_aslp | int_en_fifo | int_en_trans | int_en_Indprt | int_en_pulse | int_en_ffmt | int_en_a_vecm | int_en_drdy |
|-------------|-------------|--------------|---------------|--------------|-------------|---------------|-------------|
| 0           | 0           | 0            | 0             | 0            | 0           | 0             | 0           |

# Table 41. Interrupt Enable Register bit descriptions

| Field         | Description   |
|---------------|---|
| int_en_aslp   | Sleep interrupt enable 0: Auto-Sleep/Wake interrupt disabled 1'b1: Auto-Sleep/Wake interrupt enabled  |
| int_en_fifo   | FIFO interrupt enable 0: FIFO interrupt disabled 1: FIFO interrupt enabled  |
| int_en_trans  | Transient interrupt enable 0: Transient interrupt disabled 1: Transient interrupt enabled   |
| int_en_Indprt | Orientation interrupt enable 0: Orientation (Landscape/Portrait) interrupt disabled 1: Orientation (Landscape/Portrait) interrupt enabled               |
| int_en_pulse  | Pulse interrupt enable 0: Pulse detection interrupt disabled 1: Pulse detection interrupt enabled   |
| int_en_ffmt   | Freefall/motion interrupt enable 0: Freefall/motion interrupt disabled 1: Freefall/motion interrupt enabled   |
| int_en_a_vecm | Acceleration vector-magnitude interrupt enable  0: Acceleration vector-magnitude interrupt disabled  1: Acceleration vector-magnitude interrupt enabled |
| int_en_drdy   | Data-ready interrupt enable  0: Data-ready interrupt disabled  1: Data-ready interrupt enabled  |

The corresponding functional block interrupt enable bit allows the functional block to route its event detection flag to the system's interrupt controller. The interrupt controller routes the enabled interrupt signals to either the INT1 or INT2 pins depending on the settings made in CTRL\_REG5. Please note that the interrupt enable bits for the magnetic threshold and vector-magnitude interrupts are located in registers 0x52 (MAG\_THS\_CFG), and 0x69 (M\_VECM\_CFG), respectively.

# 10.1.12 CTRL\_REG5 [Interrupt Routing Configuration Register] (0x2E) register

# Table 42. CTRL\_REG5 register

| int_cfg_aslp | int_cfg_fifo | int_cfg_trans | int_cfg_Indprt | int_cfg_pulse | int_cfg_ffmt | int_cfg_a_vecm | int_cfg_drdy |
|--------------|--------------|---------------|----------------|---------------|--------------|----------------|--------------|
| 0            | 0            | 0             | 0              | 0             | 0            | 0              | 0            |

# **Table 43. Interrupt Routing Configuration bit descriptions**

| Field          | Description  |
|----------------|--|
| int_cfg_aslp   | Sleep interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin                          |
| int_cfg_fifo   | FIFO interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin                           |
| int_cfg_trans  | Transient detection interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin            |
| int_cfg_Indprt | Orientation detection interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin          |
| int_cfg_pulse  | Pulse detection interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin                |
| int_cfg_ffmt   | Freefall/motion detection interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin      |
| int_cfg_a_vecm | Acceleration vector-magnitude interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin. |
| int_cfg_drdy   | Data-ready interrupt routing 0: Interrupt is routed to INT2 pin 1: Interrupt is routed to INT1 pin                     |

Please note that the routing configuration for the magnetic-threshold interrupt is controlled by  $m\_ths\_int\_cfg$  bit located in register 0x52 (MAG\_THS\_CFG), and the magnetic vector-magnitude function routing is controlled by  $m\_vecm\_int\_cfg$  bit in register 0x69 (M\_VECM\_CFG).

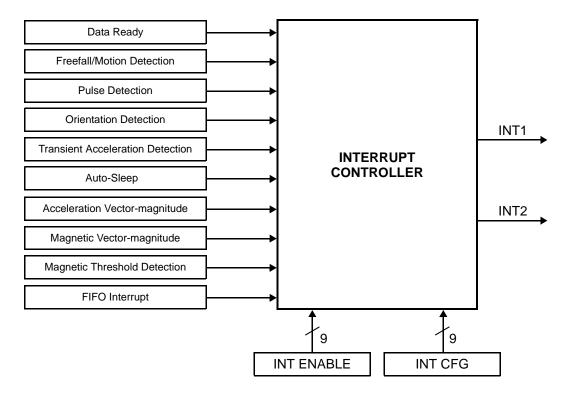


Figure 10. Interrupt controller block diagram

The system's interrupt controller uses the corresponding bit field in the CTRL\_REG5 register to determine the routing for the INT1 and INT2 interrupt pins. For example, if the  $int\_cfg\_drdy$  bit value is logic '0' the functional block's interrupt is routed to INT2, and if the bit value is logic '1' then the interrupt is routed to INT1. All interrupt signals routed to either INT1 or INT2 are logically OR'ed together as illustrated in Figure 11, thus one or more functional blocks can assert an interrupt pin simultaneously; therefore a host application responding to an interrupt should read the INT\_SOURCE register to determine the source(s) of the interrupt(s).

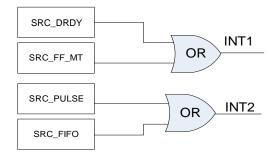


Figure 11. INT1/INT2 PIN Control Logic

# 10.2 Auto-Sleep trigger

# 10.2.1 ASLP\_COUNT (0x29) register

The ASLP\_COUNT register sets the minimum time period of event flag inactivity required to initiate a change from the current active mode ODR value specified in CTRL\_REG1[dr] to the Sleep mode ODR value specified in CTRL\_REG1[aslp\_rate], provided that CTRL\_REG2[slpe] = 1.

See Table 47 for functional blocks that may be monitored for inactivity in order to trigger the return-to-sleep event.

#### Table 44. ASLP\_COUNT register

| aslp_cnt[7:0] |  |
|---------------|--|
| 0b0000_0000   |  |

#### Table 45. ASLP\_COUNT bit description

| Field         | Description              |
|---------------|--------------------------|
| aslp_cnt[7:0] | See Table 46 for details |

#### Table 46. ASLP\_COUNT relationship with ODR

| Output Data Rate (ODR) | Maximum inactivity time (s) | ODR time step (ms) | ASLP_COUNT step (ms) |
|------------------------|-----------------------------|--------------------|----------------------|
| 800                    | 81                          | 1.25               | 320                  |
| 400                    | 81                          | 2.5                | 320                  |
| 200                    | 81                          | 5                  | 320                  |
| 100                    | 81                          | 10                 | 320                  |
| 50                     | 81                          | 20                 | 320                  |
| 12.5                   | 81                          | 80                 | 320                  |
| 6.25                   | 81                          | 160                | 320                  |
| 1.56                   | 63                          | 640                | 640                  |

Please note that when the device is operated in hybrid mode, the effective ODR is half of what is selected in CTRL\_REG1[*dr*]. For example, with ODR = 800 Hz and the device set to hybrid mode, the ASLP COUNT time step becomes 640 ms.

Table 47. Sleep/Wake mode gates and triggers

| Interrupt source | Event restarts time and delays Return-to-Sleep | Event will Wake-from-Sleep |
|------------------|--|----------------------------|
| SRC_FIFO         | Yes  | No                         |
| SRC_TRANS        | Yes  | Yes                        |
| SRC_LNDPRT       | Yes  | Yes                        |
| SRC_PULSE        | Yes  | Yes                        |
| SRC_FFMT         | Yes  | Yes                        |
| SRC_ASLP         | No*  | No*                        |
| SRC_Mag          | Yes  | Yes                        |
| SRC_DRDY         | No   | No                         |
| SRC_AVECM        | Yes  | Yes                        |
| SRC_MVECM        | Yes  | Yes                        |
| SRC_MTHS         | Yes  | Yes                        |

<sup>\*</sup> If the fifo\_gate bit is set to logic '1', the assertion of the SRC\_ASLP interrupt does not prevent the system from transitioning to Sleep or from Wake mode; instead it prevents the FIFO buffer from accepting new sample data until the host application flushes the FIFO buffer.

The interrupt sources listed in Table 47 affect the auto-sleep, return to sleep and wake from sleep mechanism only if they have been previously enabled. The functional block event flags that are bypassed while the system is in Auto-Sleep mode are temporary disabled (see Section 10.1.10, "CTRL\_REG3 [Interrupt Control Register] (0x2C) register," on page 41 for more information) and are automatically re-enabled when the device returns from Auto-Sleep mode (that is, wakes up), except for the data ready function.

If any of the interrupt sources listed under the Return-to-Sleep column is asserted before the sleep counter reaches the value specified in ASLP\_COUNT, then all sleep mode transitions are terminated and the internal sleep counter is reset. If none of the interrupts listed under the Return-to-Sleep column are asserted within the time limit specified by the ASLP\_COUNT register, the system will transition to the Auto-Sleep mode and use the ODR value specified in CTRL\_REG1[aslp\_rate].

If any of the interrupt sources listed under the "Wake-from-Sleep" column is asserted, then the system will transition out of the low sample rate Auto-Sleep mode to the user-specified Wake mode sample rate provided that the specific wake event function is enabled in register CTRL\_REG3.

If the Auto-Sleep interrupt is enabled, a transition from Active mode to Sleep mode and (vice-versa) will generate an interrupt. This interrupt is cleared by reading the SYSMOD (0x0B) register.

If CTRL\_REG3[fifo\_gate] = 1, a transition into Auto-Sleep mode will preserve the FIFO contents and set SYSMOD[fger] (FIFO Gate error), and prevent the further collection of accelerometer data into the FIFO. The system will wait for the FIFO buffer to be emptied by the host application before new samples can be acquired.

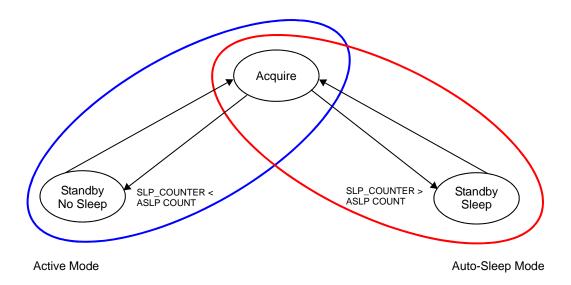


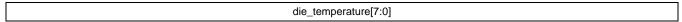
Figure 12. Auto-Sleep state transition diagram

# 10.3 Temperature

# 10.3.1 TEMP (0x51) register

Eight-bit 2's complement sensor temperature value with 0.96 °C/LSB sensitivity. Temperature data is only valid between -40 °C and 125 °C. The temperature sensor output is only valid when M\_CTRL\_REG1[m\_hms] > 0b00. Please note that the temperature sensor is uncalibrated and its output for a given temperature will vary from one device to the next.

# Table 48. TEMP register



# 10.4 Accelerometer output data registers

# 10.4.1 OUT\_X\_MSB (0x01), OUT\_X\_LSB (0x02), OUT\_Y\_MSB (0x03), OUT\_Y\_LSB (0x04), OUT\_Z\_MSB (0x05), OUT\_Z\_LSB (0x06) registers

These registers contain the X-axis, Y-axis, and Z-axis 14-bit left-justified sample data expressed as 2's complement numbers.

The sample data output registers store the current sample data if the FIFO buffer function is disabled, but if the FIFO buffer function is enabled the sample data output registers then point to the head of the FIFO buffer which contains up to the previous 32 X, Y, and Z data samples.

The data is read out in the following order: Xmsb, Xlsb, Ymsb, Ylsb, Zmsb, Zlsb for CTRL\_REG1[f\_read] = 0, and Xmsb, Ymsb, Zmsb for CTRL\_REG1[f\_read] = 1. If the device is operating in hybrid mode and M\_CTRL\_REG2[h\_yb\_autoinc\_mode] = 1, The data read out order is acceleration Xmsb, Xlsb, Ymsb, Ylsb, Zmsb, and Zlsb followed by magnetic data Xmsb, Xlsb, Ymsb, Ylsb, Zmsb, Zlsb. Similarly, for CTRL\_REG1[f\_read] = 1, only the MSB's of the acceleration and magnetic data are read out in the same axis order.

If the CTRL\_REG1[f\_read] bit is set, auto-increment will skip over the LSB registers. This will shorten the data acquisition from six bytes to three bytes. If the LSB registers are directly addressed, the LSB information can still be read regardless of the CTRL\_REG1[f\_read] register setting.

If the FIFO data output register driver is enabled ( $F_SETUP[f_mode] > 0b00$ ), register 0x01 points to the head of the FIFO buffer, while registers 0x02, 0x03, 0x04, 0x05, 0x06 return a value of zero when read directly.

The DR\_STATUS registers, OUT\_X\_MSB, OUT\_X\_LSB, OUT\_Y\_MSB, OUT\_Y\_LSB, OUT\_Z\_MSB, and OUT\_Z\_LSB are located in the auto-incrementing address range of 0x00 to 0x06, allowing all of the acceleration data to be read in a single-burst read of six bytes starting at the OUT\_X\_MSB register. If the device is operating in hybrid mode and M\_CTRL\_REG2[hyb\_autoinc\_mode] = 1, the magnetometer data can also be read out in the same axis and endian order by executing a burst read of 12 bytes starting at register OUT\_X\_MSB.

# xd[13:6] Table 50. OUT\_X\_LSB register xd[5:0] — — Table 51. OUT\_Y\_MSB register yd[13:6] Table 52. OUT\_Y\_LSB register yd[5:0] — — Table 53. OUT\_Z\_MSB register zd[13:6] Table 54. OUT\_Z\_LSB register — —

Table 49. OUT\_X\_MSB register

#### 10.5 Accelerometer FIFO

# 10.5.1 F\_SETUP (0x09) register

#### Table 55. F\_SETUP register

| f_mode[1:0] | f_wmrk[5:0] |
|-------------|-------------|
| 0           | 0b00_0000   |

#### Table 56. F\_SETUP bit descriptions

| Field                            | Description   |
|----------------------------------|---|
| f_mode[1:0] <sup>(1)(2)(3)</sup> | FIFO buffer operating mode. <b>0b00:</b> FIFO is disabled. <b>0b01:</b> FIFO contains the most recent samples when overflowed (circular buffer). Oldest sample is discarded to be replaced by new sample. <b>0b10:</b> FIFO stops accepting new samples when overflowed. <b>0b11:</b> FIFO trigger mode.  The FIFO is flushed whenever the FIFO is disabled, during an automatic ODR change (Auto-Wake/Sleep), or on a transition from Standby mode to Active mode.  Disabling the FIFO (f_mode = 0b00) resets the F_STATUS[f_ovf], F_STATUS[f_wmrk_flag], F_STATUS[f_cnt] status flags to zero.  A FIFO overflow event (that is, F_STATUS[f_cnt] = 32) will assert the F_STATUS[f_ovf] flag. |
| f_wmrk[5:0] <sup>(2)</sup>       | FIFO sample count watermark.  These bits set the number of FIFO samples required to trigger a watermark interrupt. A FIFO watermark event flag F_STATUS[f_wmk_flag] is raised when FIFO sample count F_STATUS[f_cnt] value is equal to or greater than the f_wmrk watermark.  Setting the f_wmrk to 0b00_0000 will disable the FIFO watermark event flag generation.  This field is also used to set the number of pre-trigger samples in trigger mode (f_mode = 0b11).   |

- 1. This bit field can be written in Active mode.
- 2. This bit field can be written in Standby mode.
- 3. The FIFO mode (f\_mode) cannot be switched between operational modes (0b01, 0b10 and 0b11).

A FIFO sample count exceeding the watermark event does not stop the FIFO from accepting new data.

The FIFO update rate is dictated by the selected system ODR. In Active mode the ODR is set by CTRL\_REG1[dr] and when Auto-Sleep is active, the ODR is set by CTRL\_REG1[aslp\_rate] bit fields.

When data is read from the FIFO buffer, the oldest sample data in the buffer is returned and also deleted from the front of the FIFO, while the FIFO sample count is decremented by one. It is assumed that the host application will use the I<sup>2</sup>C or SPI burst read transactions to dump the FIFO contents. If the FIFO X, Y, and Z data is not completely read in one burst read transaction, the next read will start at the next FIFO location X-axis data. If the Y or Z data is not read out in the same burst transaction as the X-axis data, it will be lost.

In Trigger mode, the FIFO is operated as a circular buffer and will contain up to the 32 most recent acceleration data samples. The oldest sample is discarded and replaced by the current sample, until a FIFO trigger event occurs. After a trigger event occurs, the FIFO will continue to accept samples only until overflowed, after which point the newest sample data is discarded. For more information on using the FIFO buffer and the various FIFO operating modes, please refer to Freescale application note AN4073.

# 10.6 Accelerometer sensor data configuration

# 10.6.1 XYZ\_DATA\_CFG (0x0E) register

The XYZ\_DATA\_CFG register is used to configure the desired acceleration full-scale range, and also to select whether the output data is passed through the high-pass filter.

# Table 57. XYZ\_DATA\_CFG register

| _ | _ | _ | hpf_out | _ | _ | fs[1:0] |
|---|---|---|---------|---|---|---------|
| 0 | 0 | 0 | 0       | 0 | 0 | 0b00    |

# Table 58. XYZ\_DATA\_CFG bit descriptions

| Field   | Description   |
|---------|---|
| hpf_out | Enable high-pass filter on acceleration output data  1: Output data is high-pass filtered  0: High-pass filter is disabled. |
| fs[1:0] | Accelerometer full-scale range selection. See Table 59  |

#### Table 59.

| fs[1] | fs[0] | Sensitivity   | Full-Scale range |
|-------|-------|---------------|------------------|
| 0     | 0     | ±0.244 mg/LSB | ±2 g             |
| 0     | 1     | ±0.488 mg/LSB | ±4 g             |
| 1     | 0     | ±0.976 mg/LSB | ±8 g             |
| 1     | 1     | Reserved      | _                |

# 10.7 Accelerometer High-Pass filter

# 10.7.1 HP\_FILTER\_CUTOFF (0x0F) register

High-pass filter cutoff frequency setting register.

# Table 60. HP\_FILTER\_CUTOFF register

| _ | _ | pulse_hpf_byp | pulse_lpf_en | _ | _ | sel[1:0] |
|---|---|---------------|--------------|---|---|----------|
| 0 | 0 | 0             | 0            | 0 | 0 | 0b0      |

# Table 61. HP\_FILTER\_CUTOFF bit descriptions

| Field         | Description  |
|---------------|--|
| pulse_hpf_byp | Bypass high-pass filter for pulse processing function  0: HPF enabled for pulse processing  1: HPF bypassed for pulse processing |
| pulse_lpf_en  | Enable low-pass filter for pulse processing function  0: LPF disabled for pulse processing  1: LPF enabled for pulse processing  |
| sel[1:0]      | HPF cutoff frequency selection See Table 62.   |

Table 62. HP\_FILTER\_CUTOFF

|          |        |       | High-Pa         | ss cutoff freque | ncy (Hz)   |       |                 |           |
|----------|--------|-------|-----------------|------------------|------------|-------|-----------------|-----------|
|          |        | sel = | 0b00            |                  | sel = 0b01 |       |                 |           |
| ODR (Hz) | Normal | LPLN  | High resolution | Low power        | Normal     | LPLN  | High resolution | Low power |
| 800      | 16     | 16    | 16              | 16               | 8          | 8     | 8               | 8         |
| 400      | 16     | 16    | 16              | 8                | 8          | 8     | 8               | 4         |
| 200      | 8      | 8     | 16              | 4                | 4          | 4     | 8               | 2         |
| 100      | 4      | 4     | 16              | 2                | 2          | 2     | 8               | 1         |
| 50       | 2      | 2     | 16              | 1                | 1          | 1     | 8               | 0.5       |
| 12.5     | 2      | 0.5   | 16              | 0.25             | 1          | 0.25  | 8               | 0.125     |
| 6.25     | 2      | 0.25  | 16              | 0.125            | 1          | 0.125 | 8               | 0.063     |
| 1.56     | 2      | 0.063 | 16              | 0.031            | 1          | 0.031 | 8               | 0.016     |
|          |        | sel = | 0b10            |                  | sel = 0b11 |       |                 |           |
| ODR (Hz) | Normal | LPLN  | High resolution | Low power        | Normal     | LPLN  | High resolution | Low power |
| 800      | 4      | 4     | 4               | 4                | 2          | 2     | 2               | 2         |
| 400      | 4      | 4     | 4               | 2                | 2          | 2     | 2               | 1         |
| 200      | 2      | 2     | 4               | 1                | 1          | 1     | 2               | 0.5       |
| 100      | 1      | 1     | 4               | 0.5              | 0.5        | 0.5   | 2               | 0.25      |
| 50       | 0.5    | 0.5   | 4               | 0.25             | 0.25       | 0.25  | 2               | 0.125     |
| 12.5     | 0.5    | 0.125 | 4               | 0.063            | 0.25       | 0.063 | 2               | 0.031     |
| 6.25     | 0.5    | 0.063 | 4               | 0.031            | 0.25       | 0.031 | 2               | 0.016     |
| 1.56     | 0.5    | 0.016 | 4               | 0.008            | 0.25       | 0.008 | 2               | 0.004     |

Please note that when the part is operated in hybrid mode, the ODR is reduced by a factor of two, which also affects the filter cutoff frequency. For example, an ODR setting of 400 Hz in accelerometer only mode with HP\_FILTER\_CUTOFF[sel] = 0b10 sets the cutoff frequency at 4 Hz. If the part is operated in Hybrid mode, the effective ODR becomes 200 Hz and the cutoff frequency is now 2 Hz for the same ODR and HP\_FILTER\_CUTOFF[sel] settings.

# 10.8 Portrait/Landscape Detection

The FXOS8700CQ is capable of detecting six orientations: Landscape Left, Landscape Right, Portrait Up, and Portrait Down with Z-lockout feature as well as Face Up and Face Down orientation as shown in Figures 13, 14 and 15. For more details on the meaning of the different user-configurable settings and for example code, please refer to Freescale application note AN4068.

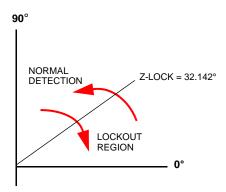


Figure 13. Illustration of Z-tilt angle lockout transition

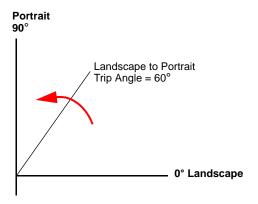


Figure 14. Illustration of landscape to portrait transition

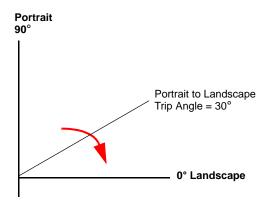


Figure 15. Illustration of portrait to landscape transition

# 10.8.1 PL\_STATUS (0x10) register

This status register can be read to get updated information on any change in orientation by reading bit 7, or the specifics of the orientation by reading the other bits. For further understanding of Portrait Up, Portrait Down, Landscape Left, Landscape Right, Back and Front orientations please refer to Figure 15. The interrupt is cleared when reading the PL\_STATUS register.

# Table 63. PL\_STATUS register

| newlp | lo | _ |   | _ | lapo[1:0] | bafro |
|-------|----|---|---|---|-----------|-------|
| 0     | 0  | 0 | 0 | 0 | 0b00      | 0     |

# Table 64. PL\_STATUS bit descriptions

| Field                    | Description  |
|--------------------------|--|
| newlp                    | Landscape/Portrait status change flag. 0: No change 1: BAFRO and/or LAPO and/or Z-tilt lockout value has changed   |
| lo                       | Z-tilt angle lockout.  0: Lockout condition has not been detected.  1: Z-tilt lockout trip angle has been exceeded. Lockout condition has been detected.   |
| lapo[1:0] <sup>(1)</sup> | Landscape/Portrait orientation.  0b00: Portrait up: equipment standing vertically in the normal orientation  0b01: Portrait down: equipment standing vertically in the inverted orientation  0b10: Landscape right: equipment is in landscape mode to the right  0b11: Landscape left: equipment is in landscape mode to the left. |
| bafro                    | Back or front orientation.  0: Front: equipment is in the front facing orientation.  1: Back: equipment is in the back facing orientation.   |

<sup>1.</sup> The default powerup state is bafro(Undefined), lapo(Undefined), and no lockout for orientation function.

The *newlp* bit is set to 1 after the first orientation detection after a Standby to Active transition, and whenever a change in *lo*, *bafro*, or *lapo* occurs. The *newlp* bit is cleared anytime the PL\_STATUS register is read. *lapo*, *bafro* and *lo* continue to change when *newlp* is set. The current orientation is locked if the absolute value of the acceleration experienced on any of the three axes is greater than 1.25 *g*.

# 10.8.2 PL\_CFG (0x11) register

This register enables the Portrait/Landscape function and sets the behavior of the debounce counter.

# Table 65. PL\_CFG register

| dbcntm | pl_en | _ | _ | _ | _ | _ | _ |
|--------|-------|---|---|---|---|---|---|
| 1      | 0     | 0 | 0 | 0 | 0 | 0 | 0 |

# Table 66. PL\_CFG bit descriptions

| Field  | Description   |
|--------|---|
| dbcntm | Debounce counter mode selection.  0: Decrements debounce whenever condition of interest is no longer valid.  1: Clears counter whenever condition of interest is no longer valid. |
| pl_en  | Portrait/Landscape detection enable.  0: Portrait/Landscape detection is disabled.  1: Portrait/Landscape detection is enabled.   |

# 10.8.3 PL\_COUNT (0x12) register

This register sets the debounce count for the orientation state transition. The minimum debounce latency is determined by the system ODR value and the value of the PL\_COUNT register. Any change to the system ODR or a transition from Active-to-Standby (or vice-versa) resets the internal landscape/portrait internal debounce counters. When the device is operated in hybrid mode, the effective ODR will be half of what is selected by the user, which will also affect the debounce time. For example, if an ODR of 400 Hz is selected and the part is also in hybrid mode, the effective ODR is 200 Hz, and the effective debounce time step is 5 ms instead of 2.5 ms.

# Table 67. PL\_COUNT register

| dbnce[7:0]  |  |
|-------------|--|
| 0b0000_0000 |  |

# Table 68. PL\_Count Relationship with the ODR

|          |        | Max time | range (s)       |           | Time step (ms) |      |                 |           |
|----------|--------|----------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal | LPLN     | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.319  | 0.319    | 0.319           | 0.319     | 1.25           | 1.25 | 1.25            | 1.25      |
| 400      | 0.638  | 0.638    | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5       |
| 200      | 1.28   | 1.28     | 0.638           | 1.28      | 5              | 5    | 2.5             | 5         |
| 100      | 2.55   | 2.55     | 0.638           | 2.55      | 10             | 10   | 2.5             | 10        |
| 50       | 5.1    | 5.1      | 0.638           | 5.1       | 20             | 20   | 2.5             | 20        |
| 12.5     | 5.1    | 20.4     | 0.638           | 20.4      | 20             | 80   | 2.5             | 80        |
| 6.25     | 5.1    | 20.4     | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |
| 1.56     | 5.1    | 20.4     | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |

# 10.8.4 PL\_BF\_ZCOMP (0x13) register

Back/Front and Z-tilt angle compensation register

# Table 69. PL\_BF\_ZCOMP register

| bkfr[1:0] — |   | _ | _ | zlock[2:0] |  |
|-------------|---|---|---|------------|--|
| 0b10        | 0 | 0 | 0 | 0b100      |  |

# Table 70. PL\_BF\_ZCOMP bit descriptions

| Field      | Description   |
|------------|---|
| zlock[2:0] | Z-lock angle threshold. range is from approximately 13° to 44°. Step size is approximately 4°. See Table 71 for more information. Default value: $0x04 \rightarrow \sim 28^{\circ}$ . Maximum value: $0x07 \rightarrow \sim 44^{\circ}$ . |
| bkfr[1:0]  | Back/front trip angle threshold. See Table 72 for more information. Default: $0b10 \rightarrow \pm 70^{\circ}$ . Step size is 5°. Range: $\pm (65^{\circ}$ to 80°).   |

# Table 71. Z-lockout angle definitions

| zlock | Resultant angle (min) for positions between Landscape and Portrait | Resultant angle (max) for ideal Landscape or Portrait |
|-------|--|---|
| 0b000 | 13.6°  | 14.5°   |
| 0b001 | 17.1°  | 18.2°   |
| 0b010 | 20.7°  | 22.0°   |
| 0b011 | 24.4°  | 25.9°   |
| 0b100 | 28.1°  | 30.0°   |
| 0b101 | 32.0°  | 34.2°   |
| 0b110 | 36.1°  | 38.7°   |
| 0b111 | 40.4°  | 43.4°   |

# Table 72. Back/Front orientation definitions

| bkfr | Back → Front Transition | Front → Back Transition |
|------|-------------------------|-------------------------|
| 0b00 | Z < 80° or Z > 280°     | Z > 100° and Z < 260°   |
| 0b01 | Z < 75° or Z > 285°     | Z > 105° and Z < 255°   |
| 0b10 | Z < 70° or Z > 290°     | Z > 110° and Z < 250°   |
| 0b11 | Z < 65° or Z > 295°     | Z > 115° and Z < 245°   |

# 10.8.5 PL\_THS\_REG (0x14) register

Portrait to landscape trip threshold registers.

Table 73. PL\_THS\_REG register

| pl_ths[4:0] | hys[2:0] |
|-------------|----------|
| 0b0_1000    | 0b100    |

Table 74. Threshold angle lookup table

| pl_ths[4:0] value | Threshold angle (approx.) |
|-------------------|---------------------------|
| 0x07              | 15°                       |
| 0x09              | 20°                       |
| 0x0C              | 30°                       |
| 0x0D              | 35°                       |
| 0x0F              | 40°                       |
| 0x10              | 45°                       |
| 0x13              | 55°                       |
| 0x14              | 60°                       |
| 0x17              | 70°                       |
| 0x19              | 75°                       |

Table 75. Trip angles versus hysteresis settings

| hys[2:0] value | Landscape to Portrait trip angle | Portrait to Landscape trip angle |
|----------------|----------------------------------|----------------------------------|
| 0b000          | 45°                              | 45°                              |
| 0b001          | 49°                              | 41°                              |
| 0b010          | 52°                              | 38°                              |
| 0b011          | 56°                              | 34°                              |
| 0b100          | 59°                              | 31°                              |
| 0b101          | 62°                              | 28°                              |
| 0b110          | 66°                              | 24°                              |
| 0b111          | 69°                              | 21°                              |

Table 76. Portrait/Landscape ideal orientation definitions

| Position | Description            |
|----------|------------------------|
| PU       | y ~ -1 g, x ~ 0        |
| PD       | y ~ +1 g, x ~ 0        |
| LR       | y ~ 0, x ~ +1 <i>g</i> |
| LL       | y ~ 0, x ~ -1 g        |

# 10.9 Freefall and Motion detection

The Freefall/Motion detection block can be configured to detect low-g (freefall) or high-g (motion) events utilizing the A\_FFMT\_CFG[ $a\_ffmt\_oae$ ] bit.

In low-g detect mode (A\_FFMT\_CFG[a\_ffmt\_oae] = 0) a low-g condition will need to occur on all enabled axes (ex. X, Y and Z) for the A\_FFMT\_SRC[a\_ffmt\_ea] bit to be affected. And, in high-g detect mode (A\_FFMT\_CFG[a\_ffmt\_oae] = 1) a high-g condition occurring in any of the enabled axes (ex. X, Y or Z) will suffice to affect the A\_FFMT\_SRC[a\_ffmt\_ea] bit.

The detection threshold(s) are programed in register 0x17 (A\_FFMT\_THS) for common threshold operation, and 0x73-0x78 (A\_FFMT\_THS\_X/Y/Z) for individual axis threshold operation.

A\_FFMT\_CFG[a\_ffmt\_ele] bit determines the behavior of A\_FFMT\_SRC[a\_ffmt\_ea] bit in response to the desired acceleration event (low-g/high-g). When A\_FFMT\_CFG[a\_ffmt\_ele] = 1, the freefall or motion event is latched and the

A\_FFMT\_SRC[a\_ffmt\_ea] flag can only be cleared by reading the A\_FFMT\_SRC register. When A\_FFMT\_CFG[a\_ffmt\_ele] = 0, freefall or motion events are not latched, and the A\_FFMT\_SRC[a\_ffmt\_ea] bit reflects the real-time status of the event detection.

A\_FFMT\_THS[a\_ffmt\_dbcntm] bit determines the debounce filtering behavior of the logic which sets the A\_FFMT\_SRC[a\_ffmt\_ea] bit. See Figure 17 for details.

It is possible to enable/disable each axis used in the freefall/motion detection function by configuring bits A\_FFMT\_CFG[a\_ffmt\_xefe], A\_FFMT\_CFG[a\_ffmt\_yefe], and A\_FFMT\_CFG[a\_ffmt\_zefe].

The freefall/motion detection function has the option to use a common 7-bit unsigned threshold for each of the X, Y, Z axes, or individual unsigned 13-bit thresholds for each axis. When A\_FFMT\_THS\_X\_MSB[a\_ffmt\_ths\_xyz\_en] = 0, the 7-bit threshold value stored in register 0x17 is used as a common 7-bit threshold for the X, Y, and Z axes. When a\_ffmt\_ths\_xyz\_en = 1, each axis may be programmed with an individual 13-bit threshold (stored in the A\_FFMT\_X/Y/Z MSB and LSB registers).

# 10.9.1 A\_FFMT\_CFG (0x15) register

Freefall/motion configuration register.

# Table 77. A\_FFMT\_CFG register

| a_ffmt_ele | a_ffmt_oae | a_ffmt_zefe | a_ffmt_yefe | a_ffmt_xefe | _ | _ | _ |
|------------|------------|-------------|-------------|-------------|---|---|---|
| 0          | 0          | 0           | 0           | 0           | 0 | 0 | 0 |

#### Table 78. A\_FFMT\_CFG bit descriptions

| Field       | Description   |
|-------------|---|
| a_ffmt_ele  | a_ffmt_ele denotes whether the enabled event flag will be latched in the A_FFMT_SRC register or the event flag status in the A_FFMT_SRC will indicate the real-time status of the event. If a_ffmt_ele bit is set to a logic '1', then the event flags are frozen when the a_ffmt_ea bit gets set, and are cleared by reading the A_FFMT_SRC source register.  0: Event flag latch disabled 1: Event flag latch enabled                       |
| a_ffmt_oae  | <ul> <li>a_ffmt_oae bit allows the selection between motion (logical OR combination of high-g X, Y, Z-axis event flags) and freefall (logical AND combination of low-g X, Y, Z-axis event flags) detection.</li> <li>Motion detect/freefall detect logic selection.</li> <li>Freefall flag (Logical AND combination of low-g X, Y, Z-axis event flags)</li> <li>Motion flag (Logical OR combination of high-g X, Y, Z event flags)</li> </ul> |
| a_ffmt_zefe | a_ffmt_zefe enables the detection of a high- or low-g event when the measured acceleration data on Z-axis is above/below the threshold set in the A_FFMT_THS register. If the a_ffmt_ele bit is set to logic '1' in the A_FFMT_CFG register, new event flags are blocked from updating the A_FFMT_SRC register.  0: Event detection disabled  1: Raise event flag on measured Z-axis acceleration above/below threshold.                      |
| a_ffmt_yefe | a_ffmt_yefe enables the detection of a high- or low-g event when the measured acceleration data on Y-axis is above/below the threshold set in the A_FFMT_THS register. If the a_ffmt_ele bit is set to logic '1' in the A_FFMT_CFG register, new event flags are blocked from updating the A_FFMT_SRC register.  0: Event detection disabled  1: Raise event flag on measured Y-axis acceleration above/below threshold.                      |
| a_ffmt_xefe | a_ffmt_xefe enables the detection of a high- or low-g event when the measured acceleration data on X-axis is above/below the threshold set in the A_FFMT_THS register. If the a_ffmt_ele bit is set to logic '1' in the A_FFMT_CFG register, new event flags are blocked from updating the A_FFMT_SRC register.  0: Event detection disabled  1: Raise event flag on measured X-axis acceleration above/below threshold.                      |

# 10.9.2 A\_FFMT\_SRC (0x16) register

Freefall/motion source register. Read-only register.

This register keeps track of the acceleration event which is triggering (or has triggered, in case of A\_FFMT\_CFG[a\_ffmt\_ele] = 1) the event flag. In particular A\_FFMT\_SRC[a\_ffmt\_ea] is set to a logic '1' when the logical combination of acceleration event flags specified in A\_FFMT\_CFG register is true. This bit is used in combination with the values in CTRL\_REG4[int\_en\_ffmt] and CTRL\_REG5[int\_cfg\_ffmt] register bits to generate the freefall/motion interrupts.

# Table 79. A\_FFMT\_SRC register

| a_ffmt_ea | _ | a_ffmt_zhe | a_ffmt_zhp | a_ffmt_yhe | a_ffmt_yhp | a_ffmt_xhe | a_ffmt_xhp |
|-----------|---|------------|------------|------------|------------|------------|------------|
| 0         | 0 | 0          | 0          | 0          | 0          | 0          | 0          |

# Table 80. A\_FFMT\_SRC bit descriptions

| Field      | Description  |
|------------|--|
| a_ffmt_ea  | Event active flag.  0: No event flag has been asserted  1: One or more event flag has been asserted. See the description of the A_FFMT_CFG[a_ffmt_oae] bit to determine the effect of the 3-axis event flags on the a_ffmt_ea bit. |
| a_ffmt_zhe | Z-high event flag. 0: Event detected 1: Z-high event has been detected This bit always reads zero if the a_ffmt_zefe control bit is set to zero  |
| a_ffmt_zhp | Z-high event polarity flag.  0: Z event was positive $g$ 1: Z event was negative $g$ This bit read always zero if the a_ffmt_zefe control bit is set to zero   |
| a_ffmt_yhe | Y-high event flag.  0: No event detected  1: Y-high event has been detected  This bit read always zero if the a_ffmt_yefe control bit is set to zero   |
| a_ffmt_yhp | Y-high event polarity flag.  0: Y event detected was positive <i>g</i> 1: Y event was negative <i>g</i> This bit always reads zero if the <i>a_ffmt_yefe</i> control bit is set to zero  |
| a_ffmt_xhe | X-high event flag. 0: No event detected 1: X-high event has been detected This bit always reads zero if the a_ffmt_xefe control bit is set to zero   |
| a_ffmt_xhp | X-high event polarity flag.  0: X event was positive <i>g</i> 1: X event was negative <i>g</i> This bit always reads zero if the <i>a_ffmt_xefe</i> control bit is set to zero   |

# 10.9.3 A\_FFMT\_THS (0x17), A\_FFMT\_ THS\_X\_MSB (0x73), A\_FFMT\_THS\_X\_LSB (0x74), A\_FFMT\_THS\_Y\_MSB (0x75), A\_FFMT\_THS\_Y\_LSB (0x76), A\_FFMT\_THS\_Z\_MSB (0x77), A\_FFMT\_THS\_Z\_LSB (0x78) registers

Freefall/motion detection threshold registers.

# Table 81. A\_FFMT\_THS (0x17) register

| a_ffmt_dbcntm | ths[6:0]   |
|---------------|------------|
| 0             | 0b000_0000 |

# Table 82. A\_FFMT\_THS (0x17) bit descriptions

| Field         | Description   |
|---------------|---|
| a_ffmt_dbcntm | The ASIC uses a_ffmt_dbcntm to set the acceleration FFMT debounce counter clear mode independent of the value of the a_ffmt_ths_xyz_en.  a_ffmt_dbcntm bit configures the way in which the debounce counter is reset when the inertial event of interest is momentarily not true.  When a_ffmt_dbcntm bit is a logic '1', the debounce counter is cleared to 0 whenever the inertial event of interest is no longer true (part b, Figure 17) while if the a_ffmt_dbcntm bit is set to logic '0' the debounce counter is decremented by 1 whenever the inertial event of interest in longer true (part c, Figure 17) until the debounce counter reaches 0 or the inertial event of interest become active.  The decrementing of the debounce counter acts to filter out irregular spurious events which might impede the correct detection of inertial events. |
| ths[6:0]      | Freefall/motion detection threshold: default value: 0b000_0000. Resolution is fixed at 63 mg/LSB.   |

# Table 83. A\_FFMT\_THS\_X\_MSB (0x73) register

| a_ffmt_ths_xyz_en | a_ffmt_ths_x[12:6] |
|-------------------|--------------------|
| 0                 | 0b000_0000         |

# Table 84. A\_FFMT\_THS\_X\_MSB (0x73) bit descriptions

| Field              | Description  |
|--------------------|--|
| a_ffmt_ths_xyz_en  | For a_ffmt_ths_xyz_en = 0 the ASIC uses the ffmt_ths[6:0] value located in register x17[6:0] as a common threshold for the X, Y, and Z-axis acceleration detection. The common unsigned 7-bit acceleration threshold has a fixed resolution of 63 mg/LSB, with a range of 0-127 counts.  For a_ffmt_ths_xyz_en = 1 the ASIC ignores the common 7-bit G_FFMT_THS value located in register x17 when executing the FFMT function, and the following independent threshold values are used for each axis:  A_FFMT_THS_X_MSB and A_FFMT_THS_X_LSB are used for the X-axis acceleration threshold,  A_FFMT_THS_Y_MSB and A_FFMT_THS_Y_LSB for the Y-axis acceleration threshold,  A_FFMT_THS_Z_MSB and A_FFMT_THS_Z_LSB for the Z-axis acceleration threshold.  The A_FFMT_THS_X/Y/Z thresholds are 13-bit unsigned values that has a fixed resolution of about 63 mg/LSB. The a_ffmt_ths_xyz_en and a_ffmt_trans_ths_en bits must not be enabled simultaneously. |
| a_ffmt_ths_x[12:6] | 7-bit MSB of X-axis acceleration threshold.  |

#### Table 85. A\_FFMT\_THS\_X\_LSB (0x74) register

| a_ffmt_ths_x[5:0] | _ | _ |
|-------------------|---|---|
| 0b00_0000         | 0 | 0 |

#### Table 86. A\_FFMT\_THS\_Y\_MSB (0x75) register

| a_ffmt_trans_ths_en | a_ffmt_ths_y[12:6] |
|---------------------|--------------------|
| 0                   | 0b000_0000         |

# Table 87. A\_FFMT\_THS\_Y\_LSB (0x76) register

| a_ffmt_ths_y[5:0] |   | _ |
|-------------------|---|---|
| 0b00_0000         | 0 | 0 |

#### Table 88. A\_FFMT\_THS\_Z\_MSB (0x77) register

| _ | a_ffmt_ths_z[12:6] |
|---|--------------------|
| 0 | 0b000_0000         |

# Table 89. A\_FFMT\_THS\_Z\_LSB (0x78) register

| a_ffmt_ths_z[5:0] | _ | _ |
|-------------------|---|---|
| 0b00_0000         | 0 | 0 |

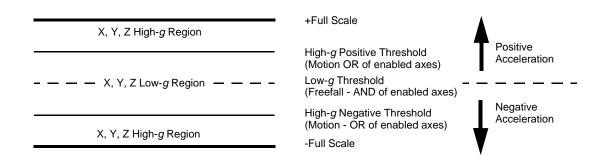


Figure 16. A\_FFMT\_THS high and low-g level

A\_FFMT\_THS contains the unsigned 7-bit threshold value used by the freefall/motion detection functional block and is used to detect either low-g (freefall) or high-g (motion) events depending on the setting of G\_FFMT\_CFG[f\_ffmt\_oae]. If g\_ffmt\_oae = 0, the event is detected when the absolute value of all the enabled axes are below the threshold value. When g\_ffmt\_oae = 1, the event is detected when the absolute value of any of the enabled axes is above the threshold value (see Figure 16 for an illustration of the freefall/motion event detection thresholds). If A\_FFMT\_THS\_X\_MSB[a\_ffmt\_ths\_xyz\_en] = 1, the behavior is identical, except that each axis may be programmed with an individual 13-bit threshold (stored in the A\_FFMT\_X/Y/Z MSB and LSB registers).

# 10.9.4 A\_FFMT\_COUNT (0x18) register

Debounce count register for freefall/motion detection events

This register sets the number of debounce counts for acceleration sample data matching the user-programmed conditions for either a freefall or motion detection event required before the interrupt is triggered.

# Table 90. A\_FFMT\_COUNT register

| a_ffmt_count[7:0] |
|-------------------|
| 0b0000_0000       |

# Table 91. A\_FFMT\_COUNT bit description

| Field             | Description  |
|-------------------|--|
| a_ffmt_count[7:0] | a_ffmt_count defines the minimum number of debounce sample counts required for the detection of a freefall or motion event. A_FFMT_THS[ffmt_dbcntm] determines the behavior of the counter when the condition of interest is momentarily not true. |

When the internal debounce counter reaches the A\_FFMT\_COUNT value a freefall/motion event flag is set. The debounce counter will never increase beyond the A\_FFMT\_COUNT value. The time step used for the debounce sample count depends on the ODR chosen (see Table 92). When the device is operated in hybrid mode, the effective ODR is half of what is selected in CTRL REG1. This has the effect of doubling the time-step values shown in Table 92.

Table 92. A\_FFMT\_COUNT relationship with the ODR

|          | Max time range (s) |       |                 |           | Time step (ms) |      |                 |      |
|----------|--------------------|-------|-----------------|-----------|----------------|------|-----------------|------|
| ODR (Hz) | Normal             | LPLN  | High resolution | Low power | Normal         | LPLN | High resolution | LP   |
| 800      | 0.319              | 0.319 | 0.319           | 0.319     | 1.25           | 1.25 | 1.25            | 1.25 |
| 400      | 0.638              | 0.638 | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5  |
| 200      | 1.28               | 1.28  | 0.638           | 1.28      | 5              | 5    | 2.5             | 5    |
| 100      | 2.55               | 2.55  | 0.638           | 2.55      | 10             | 10   | 2.5             | 10   |
| 50       | 5.1                | 5.1   | 0.638           | 5.1       | 20             | 20   | 2.5             | 20   |
| 12.5     | 5.1                | 20.4  | 0.638           | 20.4      | 20             | 80   | 2.5             | 80   |
| 6.25     | 5.1                | 20.4  | 0.638           | 40.8      | 20             | 80   | 2.5             | 160  |
| 1.56     | 5.1                | 20.4  | 0.638           | 40.8      | 20             | 80   | 2.5             | 160  |

For example, an ODR of 100 Hz and a A\_ FFMT\_COUNT value of 15 would result in minimum debounce response time of 150 ms. If the device is operated in hybrid mode, the effective debounce response time will be 300 ms for the same settings.

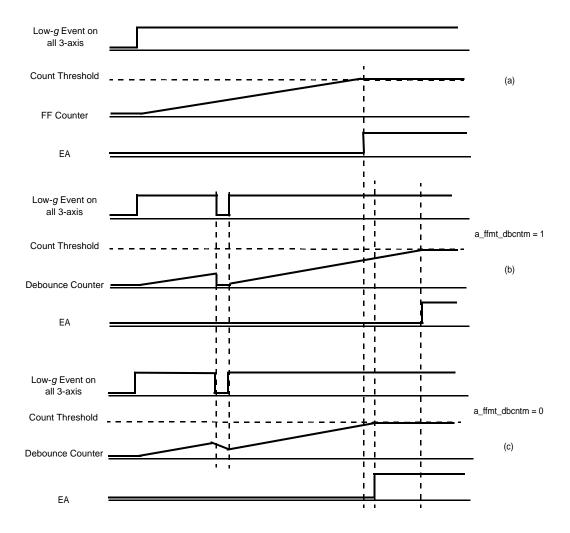


Figure 17. Behavior of the A\_FFMT debounce counter in relation to the a\_ffmt\_dbcntm setting

# 10.10 Accelerometer vector-magnitude function

The accelerometer vector-magnitude function is an inertial event detection function available to assist host software algorithms in detecting motion events.

If  $\sqrt{(a_x_out - a_x_ref)^2 + (a_y_out - a_y_ref)^2 + (a_z_out - a_z_ref)^2} > A_VECM_THS$  for a time period greater than the value stored in A\_VECM\_CNT, the vector-magnitude change event flag is triggered.

a\_x\_out, a\_y\_out, and a\_z\_out are the current accelerometer output values, and a\_x\_ref, a\_y\_ref, and a\_z\_ref are the reference values stored internally in the ASIC for each axis or in A\_VECM\_INIT\_X/Y/Z registers if A\_VECM\_CFG[a\_vecm\_initm] is set.

Please note that the x\_ref, y\_ref, and z\_ref values are not directly visible to the host application through the register interface. Please refer to Freescale application note 4458.

# 10.10.1 A\_VECM\_CFG (0x5F) register

# Table 93. A\_VECM\_CFG register

| _ | a_vecm_ele | a_vecm_initm | a_vecm_updm | a_vecm_en | _ | _ | _ |
|---|------------|--------------|-------------|-----------|---|---|---|
| 0 | 0          | 0            | 0           | 0         | 0 | 0 | 0 |

# Table 94. A\_VECM\_CFG bit descriptions

| Field        | Description  |
|--------------|--|
| a_vecm_ele   | Control bit a_vecm_ele defines the event latch enable mode. Event latching is disabled for a_vecm_ele = 0. In this case, the vector-magnitude interrupt flag is in updated real-time and is cleared when the condition for triggering the interrupt is no longer true. The setting and clearing of the event flag is controlled by the A_VECM_CNT register's programmed debounce time.  For a_vecm_ele = 1, the interrupt flag is latched in and held until the host application reads the INT_SOURCE register (0x0C).   |
| a_vecm_initm | Control bit a_vecm_initm defines how the initial reference values (x_ref, y_ref, and z_ref) are chosen.  For a_vecm_initm = 0 the function uses the current x/y/z accelerometer output data at the time when the vector magnitude function is enabled.  For a_vecm_initm = 1 the function uses the data from A_VECM_INIT_X/Y/Z registers as the initial reference values.  |
| a_vecm_updm  | Control bit a_vecm_updm defines how the reference values are updated once the vector-magnitude function has been triggered.  For a_vecm_updm = 0, the function updates the reference value with the current x, y, and z accelerometer output data values.  For a_vecm_updm = 1, the function does not update the reference values when the interrupt is triggered. Instead the function continues to use the reference values that were loaded when the function was enabled. If both a_vecm_initm and a_vecm_updm are set to logic '1', the host software can manually update the reference values in real time by writing to the A_VECM_INITX,Y,Z registers. |
| a_vecm_en    | The accelerometer vector-magnitude function is enabled by setting a_vecm_en = 1, and disabled by clearing this bit (default). The reference values are loaded with either the current X/Y/Z acceleration values or the values stored in the A_VECM_INIT_X/Y/Z registers, depending on the state of the a_vecm_initm bit.  Note: The vector-magnitude function will only perform correctly up to a maximum ODR of 400 Hz.   |

# 10.10.2 A\_VECM\_THS\_MSB (0x60) register

#### Table 95. A\_VECM\_THS\_MSB register

| a_vecm_dbcntm | _ | _ | a_vecm_ths[12:8] |
|---------------|---|---|------------------|
| 0             | 0 | 0 | 0b0_0000         |

# Table 96. A\_VECM\_THS\_MSB bit descriptions

| Field            | Description   |
|------------------|---|
| a_vecm_dbcntm    | Control bit a_vecm_dbcntm defines how the debounce timer is reset when the condition for triggering the interrupt is no longer true.  When a_vecm_dbcntm = 0 the debounce counter is decremented by 1 when the vector-magnitude result is below the programmed threshold value.  When a_vecm_dbcntm = 1 the debounce counter is cleared when the vector-magnitude result is below the programmed threshold value. |
| a_vecm_ths[12:8] | Five MSBs of the 13-bit unsigned A_VECM_THS value. The resolution is equal to the selected accelerometer resolution set in XYZ_DATA_CFG[fs]   |

# 10.10.3 A\_VECM\_THS\_LSB (0x61) register

# Table 97. A\_VECM\_THS\_LSB register

| a_vecm_ths[7:0] |  |
|-----------------|--|
| 0b0000_0000     |  |

# 10.10.4 A\_VECM\_CNT (0x62) register

# Table 98. A\_VECM\_CNT register

| a_vecm_cnt[7:0] |
|-----------------|
| 0b0000_0000     |

# Table 99. A\_VECM\_CNT bit description

| Field           | Description                                     |  |
|-----------------|---|--|
| a_vecm_cnt[7:0] | Vector-magnitude function debounce count value. |  |

The debounce timer period is determined by the ODR selected in CTRL\_REG1; it is equal to the number indicated in A\_VECM\_CNT register times 1/ODR. For example, a value of 16 in A\_VECM\_CNT with an ODR setting of 400 Hz will result in a debounce period of 40 ms. Note that ODR is halved when in hybrid mode.

# 10.10.5 A\_VECM\_INITX\_MSB (0x63) register

# Table 100. A\_VECM\_INITX\_MSB register

| _ | _ | a_vecm_initx[13:8] |
|---|---|--------------------|
| 0 | 0 | 0b00_0000          |

# Table 101. A\_VECM\_INITX\_MSB bit description

| Field | Description  |  |
|-------|--|--|
|       | Most significant 6 bits of the signed 14-bit initial X-axis value to be used as ref_x when A_VECM_CFG[a_vecm_initm] = 1. |  |
|       | The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution.     |  |

# 10.10.6 A\_VECM\_INITX\_LSB (0x64) register

# Table 102. A\_VECM\_INITX\_LSB register

| a_vecm_initx[7:0] |  |
|-------------------|--|
| 0b0000_0000       |  |

#### Table 103. A\_VECM\_INITX\_LSB bit description

| Field                | Description   |
|----------------------|---|
| 1 3 Vecm Inity17:111 | LSB of the signed 14-bit initial X-axis value to be used as ref_x when A_VECM_CFG[a_vecm_initm] = 1. The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution. |

# 10.10.7 A\_VECM\_INITY\_MSB (0x65) register

# Table 104. A\_VECM\_INITY\_MSB register

| _ | _ | a_vecm_inity[13:8] |
|---|---|--------------------|
| 0 | 0 | 0b00_0000          |

# Table 105. A\_VECM\_INITY\_MSB bit description

| Field              | Description   |  |  |  |
|--------------------|---|--|--|--|
| a_vecm_inity[13:8] | Most significant 6 bits of the signed 14-bit initial Y-axis value to be used as ref_y when A_VECM_CFG[a_vecm_initm] = 1. The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution. |  |  |  |

# 10.10.8 A\_VECM\_INITY\_LSB (0x66) register

# Table 106. A\_VECM\_INITY\_LSB register

| a_vecm_inity[7:0] |  |
|-------------------|--|
|-------------------|--|

# Table 107. A\_VECM\_INITY\_LSB bit description

| Field             | Description   |  |  |  |
|-------------------|---|--|--|--|
| a_vecm_inity[7:0] | LSB of the signed 14-bit initial Y-axis value to be used as ref_y when A_VECM_CFG[a_vecm_initm] = 1. The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution. |  |  |  |

# 10.10.9 A\_VECM\_INITZ\_MSB (0x67) register

# Table 108. A\_VECM\_INITZ\_MSB register

| _ | _ | a_vecm_initz[13:8] |
|---|---|--------------------|
| 0 | 0 | 0b00_0000          |

# Table 109. A\_VECM\_INITZ\_MSB bit description

| Field | Description   |  |  |  |
|-------|---|--|--|--|
|       | Most significant 6 bits of the signed 14-bit initial Z-axis value to be used as ref_z when A_VECM_CFG[a_vecm_initm] = 1. The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution. |  |  |  |

# 10.10.10 A\_VECM\_INITZ\_LSB (0x68) register

# Table 110. A\_VECM\_INITZ\_LSB register

| a_vecm_initz[7:0] |
|-------------------|
| 0b0000_0000       |

# Table 111. A\_VECM\_INITZ\_LSB bit description

| Field | Description   |  |  |  |
|-------|---|--|--|--|
|       | LSB of the signed 14-bit initial Z-axis value to be used as ref_z when A_VECM_CFG[a_vecm_initm] = 1. The resolution is determined by the settings made in XYZ_DATA_CFG[fs], and is equal to the accelerometer resolution. |  |  |  |

# 10.11 Transient (AC) acceleration detection

The transient detection function is similar to the freefall/motion detection function with the exception that a high-pass filter can be used to eliminate the DC offset from the acceleration data. There is an option to disable the high-pass filter, which causes the transient detection function to work in a similar manner to the motion detection function.

The transient detection function can be configured to signal an interrupt when the high-pass filtered acceleration delta values for any of the enabled axes exceeds the threshold programmed in TRANSIENT\_THS for the debounce time programmed in TRANSIENT\_COUNT. For more information on how to use and configure the transient detection function please refer to Freescale application note AN4461.

# 10.11.1 TRANSIENT\_CFG (0x1D) register

# Table 112. TRANSIENT\_ CFG register

| _ | _ | _ | tran_ele | tran_zefe | tran_yefe | tran_xefe | tran_hpf_byp |
|---|---|---|----------|-----------|-----------|-----------|--------------|
| 0 | 0 | 0 | 0        | 0         | 0         | 0         | 0            |

#### Table 113. TRANSIENT\_ CFG bit descriptions

| Field        | Description   |
|--------------|---|
| tran_ele     | Transient event flag latch enable.  0: Event flag latch disabled: the transient interrupt flag reflects the real-time status of the function.  1: Event flag latch enabled: the transient interrupt event flag is latched and a read of the TRANSIENT_SRC register is required to clear the event flag. |
| tran_zefe    | Z-axis transient event flag enable. 0: Z-axis event detection disabled 1: Z-axis event detection enabled. Raise event flag on Z-axis acceleration value greater than threshold.   |
| tran_yefe    | Y-axis transient event flag enable. 0: Y-axis event detection disabled 1: Y-axis event detection enabled. Raise event flag on Y-axis acceleration value greater than threshold.   |
| tran_xefe    | X-axis transient event flag enable. 0: X-axis event detection disabled 1: X-axis event detection enabled. Raise event flag on X-axis acceleration value greater than threshold.   |
| tran_hpf_byp | Transient function high-pass filter bypass.  0: High-pass filter is applied to accelerometer data input to the transient function.  1: High-pass filter is not applied to accelerometer data input to the transient function.   |

# 10.11.2 TRANSIENT\_SRC (0x1E) register

Transient event flag source register. This register provides the event status of the enabled axes and polarity (directional) information.

# Table 114. TRANSIENT\_ CFG register

| _ | tran_ea | tran_zef | tran_zpol | tran_yef | tran_ypol | tran_xef | trans_xpol |
|---|---------|----------|-----------|----------|-----------|----------|------------|
| 0 | 0       | 0        | 0         | 0        | 0         | 0        | 0          |

# Table 115. TRANSIENT\_SRC bit descriptions

| Field     | Description   |
|-----------|---|
| tran_ea   | Transient event active flag. 0: No transient event active flag has been asserted. 1: One or more transient event active flags has been asserted.  |
| tran_zef  | Z-axis transient event active flag. 0: Z-axis event flag is not active. 1: Z-axis event flag is active; Z-axis acceleration has exceeded the programmed threshold for the debounce time specified in TRANS_COUNT. |
| tran_zpol | Z-axis event flag polarity. 0: Z-axis event was above positive threshold value. 1: Z-axis event was below negative threshold value.   |
| tran_yef  | Y-axis transient event active flag. 0: Y-axis event flag is not active. 1: Y-axis event flag is active; Y-axis acceleration has exceeded the programmed threshold for the debounce time specified in TRANS_COUNT. |
| tran_ypol | Y-axis event flag polarity. 0: Y-axis event was above positive threshold value. 1: Y-axis event was below negative threshold value.   |
| tran_xef  | X-axis transient event active flag. 0: X-axis event flag is not active. 1: X-axis event flag is active; X-axis acceleration has exceeded the programmed threshold for the debounce time specified in TRANS_COUNT. |
| tran_xpol | X-axis event flag polarity. 0: X-axis event was above positive threshold value. 1: X-axis event was below negative threshold value.   |

When TRANSIENT\_CFG[tran\_ele] = 1, the TRANSIENT\_SRC event flag(s) and polarity bits are latched when the interrupt event is triggered, allowing the host application to determine which event flag(s) originally triggered the interrupt. When TRANSIENT\_CFG[tran\_ele] = 0, events which occur after the event that originally triggered the interrupt will update the flag and polarity bits, but once set, the flags can only be cleared by reading the TRANSIENT\_SRC register.

# 10.11.3 TRANSIENT\_THS (0x1F) register

The TRANSIENT\_THS register determines the debounce counter behavior and also sets the transient event detection threshold. It is possible to use A\_FFMT\_THS\_X/Y/Z MSB and LSB registers to set transient acceleration thresholds for individual axes using the a\_ffmt\_trans\_ths\_en bit in A\_FFMT\_THS\_Y\_MSB register. For a\_ffmt\_trans\_ths\_en = 1, register 0x1F[6:0] is used as the 7-bit, X-axis transient threshold, registers 0x75[0] and 0x76[7:2] as the 7-bit, Y-axis threshold and registers 0x77[0] and 0x78[7:2] as the 7-bit, Z-axis threshold.

# Table 116. TRANSIENT\_THS register

| tr_dbcntm | tr_ths[6:0] |
|-----------|-------------|
| 0         | 0b000_0000  |

#### Table 117. TRANSIENT\_THS bit descriptions

| Field Description |  |
|-------------------|--|
| tr_dbcntm         | Debounce counter mode selection.  0: Decrements debounce counter when the transient event condition is not true during the current ODR period.  1: Clears debounce counter when the transient event condition is not true during the current ODR period. |
| tr_ths[6:0]       | Transient event threshold. This register has a resolution of 63 mg/LSB regardless of the full-scale range setting made in $XYZ_DATA_CFG[fs]$ . If $CTRL_REG1[Inoise] = 1$ , the maximum acceleration measurement range is $\pm 4$ g.                     |

The tr\_ths[6:0] value is a 7-bit unsigned number, with a fixed resolution of 63 mg/LSB corresponding to a  $\pm 8$  g measurement range. The resolution does not change with the full-scale range setting made in XYZ\_DATA\_CFG[fs]. If CTRL\_REG1[Inoise] = 1, the measurement range is fixed at  $\pm 4$  g, regardless of the settings made in XYZ\_DATA\_CFG.

# 10.11.4 TRANSIENT\_COUNT (0x20) register

The TRANSIENT\_COUNT register sets the minimum number of debounce counts needed to trigger the transient event interrupt flag when the measured acceleration value exceeds the threshold set in TRANSIENT\_THS for any of the enabled axes.

#### Table 118. TRANSIENT\_COUNT register

| tr_count[7:0] |  |
|---------------|--|
| 0b0000_0000   |  |

#### Table 119. TRANSIENT\_COUNT bit description

| Field         | Description                              |
|---------------|--|
| tr_count[7:0) | Transient function debounce count value. |

The time step for the transient detection debounce counter is set by the value of the system ODR and power mode as shown in Table 120. When the device is operated in hybrid mode, the effective ODR is half of what is selected in CTRL\_REG1, which also doubles the time-step values shown in Table 120.

#### Table 120. TRANSIENT\_COUNT relationship with the ODR

|          | Max time range (s) |       |                 |           | Time step (ms) |      |                 |           |
|----------|--------------------|-------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal             | LPLN  | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.319              | 0.319 | 0.319           | 0.319     | 1.25           | 1.25 | 1.25            | 1.25      |
| 400      | 0.638              | 0.638 | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5       |
| 200      | 1.28               | 1.28  | 0.638           | 1.28      | 5              | 5    | 2.5             | 5         |
| 100      | 2.55               | 2.55  | 0.638           | 2.55      | 10             | 10   | 2.5             | 10        |
| 50       | 5.1                | 5.1   | 0.638           | 5.1       | 20             | 20   | 2.5             | 20        |
| 12.5     | 5.1                | 20.4  | 0.638           | 20.4      | 20             | 80   | 2.5             | 80        |
| 6.25     | 5.1                | 20.4  | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |
| 1.56     | 5.1                | 20.4  | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |

An ODR of 100 Hz and a TRANSIENT\_COUNT value of 15, when accelerometer OSR is set to normal using CTRL\_REG2, would result in minimum debounce response time of 150 ms. When the device is operated in hybrid mode, these settings would result in an effective debounce time of 300 ms.

# 10.12 Pulse detection

# 10.12.1 PULSE\_CFG (0x21) register

This register configures the pulse event detection function.

# Table 121. PULSE\_CFG register

| pls_dpa | pls_ele | pls_zdpefe | pls_zspefe | pls_ydpefe | pls_yspefe | pls_xdpefe | pls_xspefe |
|---------|---------|------------|------------|------------|------------|------------|------------|
| 0       | 0       | 0          | 0          | 0          | 0          | 0          | 0          |

# Table 122. PULSE\_CFG bit descriptions

| Field      | Description   |
|------------|---|
| pls_dpa    | Double-pulse abort.  0: Double-pulse detection is not aborted if the start of a pulse is detected during the time period specified by the PULSE_LTCY register.  1: Setting the pls_dpa bit momentarily suspends the double-tap detection if the start of a pulse is detected during the time period specified by the PULSE_LTCY register and the pulse ends before the end of the time period specified by the PULSE_LTCY register. |
| pls_ele    | Pulse event flag latch enable. When enabled, a read of the PULSE_SRC register is needed to clear the event flag.  0: Event flag latch disabled  1: Event flag latch enabled   |
| pls_zdpefe | Event flag enable on double-pulse event on Z-axis.  0: Event detection disabled  1: Raise event flag on detection of double-pulse event on Z-axis   |
| pls_zspefe | Event flag enable on single-pulse event on Z-axis.  0: Event detection disabled  1: Raise event flag on detection of single-pulse event on Z-axis   |
| pls_ydpefe | Event flag enable on double-pulse event on Y-axis.  0: Event detection disabled  1: Raise event flag on detection of double-pulse event on Y-axis   |
| pls_yspefe | Event flag enable on single-pulse event on Y-axis.  0: Event detection disabled  1: Raise event flag on detection of single-pulse event on Z-axis.  |
| pls_xdpefe | Event flag enable on double-pulse event on X-axis.  0: Event detection disabled  1: Raise event flag on detection of double-pulse event on X-axis.  |
| pls_xspefe | Event flag enable on single-pulse event on X-axis.  0: Event detection disabled  1: Raise event flag on detection of single-pulse event on X-axis.  |

# 10.12.2 PULSE\_SRC (0x22) register

This register indicates the status bits for the pulse detection function.

# Table 123. PULSE\_SRC register

| pls src ea | pls src axz  | pls src axv   | pls src axx  | pls src dpe | pls src polz | pls src polv | pls src polx |
|------------|--------------|---------------|--------------|-------------|--------------|--------------|--------------|
| p.o_o.o_oa | p.o_o.o_a.x_ | p.o_o. o_a.ty | p.o_o.o_a.a. | p.o_o.o_apo | p.o_o.o_po.z | p.o_o.o_po.y | p.o_o.o_po.x |

# Table 124. PULSE\_SRC bit descriptions

| Field        | Description   |
|--------------|---|
| pls_src_ea   | Event active flag. 0: No interrupt has been generated 1: One or more interrupt events have been generated                                     |
| pls_src_axz  | Z-axis event flag. 0: No interrupt. 1: Z-axis event has occurred  |
| pls_src_axy  | Y-axis event flag. 0: No interrupt. 1: Y-axis event has occurred  |
| pls_src_axx  | X-axis event flag. 0: No interrupt. 1: X-axis event has occurred.   |
| pls_src_dpe  | Double pulse on first event.  0: Single-pulse event triggered interrupt.  1: Double-pulse event triggered interrupt.                          |
| pls_src_polz | Pulse polarity of Z-axis event.  0: Pulse event that triggered interrupt was positive.  1: Pulse event that triggered interrupt was negative. |
| pls_src_poly | Pulse polarity of Y-axis event.  0: Pulse event that triggered interrupt was positive.  1: Pulse event that triggered interrupt was negative. |
| pls_src_polx | Pulse polarity of X-axis event.  0: Pulse event that triggered interrupt was positive.  1: Pulse event that triggered interrupt was negative. |

# 10.12.3 PULSE\_THSX (0x23) register

#### Table 125. PULSE\_THSX register

|   | pls_thsx[6:0] |
|---|---------------|
| 0 | 0b000_0000    |

# Table 126. PULSE\_THSX bit description

| Field         | Description                 |
|---------------|-----------------------------|
| pls_thsx[6:0] | Pulse threshold for X-axis. |

The PULSE\_THSX, PULSE\_THSY and PULSE\_THSZ registers define the thresholds used by the system to start the pulse-event detection procedure. Threshold values for each axis are unsigned 7-bit numbers with a fixed resolution of 0.063 *g*/LSB, corresponding to an 8 *g* acceleration full-scale range. The full-scale range is fixed at 8 *g* for the pulse detection function, regardless of the settings made in XYZ\_DATA\_CFG[*f*s].

# 10.12.4 PULSE\_THSY (0x24) register

# Table 127. PULSE\_THSY register

| _ | pls_thsy[6:0] |
|---|---------------|
| 0 | 0b000_0000    |

# Table 128. PULSE\_THSY bit description

| Field         | Description                 |
|---------------|-----------------------------|
| pls_thsy[6:0] | Pulse threshold for Y-axis. |

# 10.12.5 PULSE\_THSZ (0x25) register

# Table 129. PULSE\_THSZ register

| _ | pls_thsz[6:0] |
|---|---------------|
| 0 | 0b000_0000    |

# Table 130. PULSE\_THSZ bit description

| Field         | Description                 |
|---------------|-----------------------------|
| pls_thsz[6:0] | Pulse threshold for Z-axis. |

# 10.12.6 PULSE\_TMLT (0x26) register

# Table 131. PULSE\_TMLT register

| pls_tmlt[7:0] |  |
|---------------|--|
| 0b0000_0000   |  |

# Table 132. PULSE\_TMLT bit description

| Field         | Description  |
|---------------|--|
| pls_tmlt[7:0] | pls_tmlt[7:0] defines the maximum time interval that can elapse between the start of the acceleration on the selected channel exceeding the specified threshold and the end when the channel acceleration goes back below the specified threshold. |

Minimum time step for the pulse-time limit is defined in Tables 133 and 134. Maximum time for a given ODR is "Minimum time step x 255".

# Table 133. Time step for PULSE\_TMLT with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 1

|          |        | Max time | range (s)       |           | Time step (ms) |      |                 |           |
|----------|--------|----------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal | LPLN     | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.319  | 0.319    | 0.319           | 0.319     | 1.25           | 1.25 | 1.25            | 1.25      |
| 400      | 0.638  | 0.638    | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5       |
| 200      | 1.28   | 1.28     | 0.638           | 1.28      | 5              | 5    | 2.5             | 5         |
| 100      | 2.55   | 2.55     | 0.638           | 2.55      | 10             | 10   | 2.5             | 10        |
| 50       | 5.1    | 5.1      | 0.638           | 5.1       | 20             | 20   | 2.5             | 20        |
| 12.5     | 5.1    | 20.4     | 0.638           | 20.4      | 20             | 80   | 2.5             | 80        |
| 6.25     | 5.1    | 20.4     | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |
| 1.56     | 5.1    | 20.4     | 0.638           | 40.8      | 20             | 80   | 2.5             | 160       |

Table 134. Time step for PULSE\_TMLT with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 0

|          |        | Max time | range (s)       |           | Time step (ms) |       |                 |           |
|----------|--------|----------|-----------------|-----------|----------------|-------|-----------------|-----------|
| ODR (Hz) | Normal | LPLN     | High resolution | Low power | Normal         | LPLN  | High resolution | Low power |
| 800      | 0.159  | 0.159    | 0.159           | 0.159     | 0.625          | 0.625 | 0.625           | 0.625     |
| 400      | 0.159  | 0.159    | 0.159           | 0.319     | 0.625          | 0.625 | 0.625           | 1.25      |
| 200      | 0.319  | 0.319    | 0.159           | 0.638     | 1.25           | 1.25  | 0.625           | 2.5       |
| 100      | 0.638  | 0.638    | 0.159           | 1.28      | 2.5            | 2.5   | 0.625           | 5         |
| 50       | 1.28   | 1.28     | 0.159           | 2.55      | 5              | 5     | 0.625           | 10        |
| 12.5     | 1.28   | 5.1      | 0.159           | 10.2      | 5              | 20    | 0.625           | 40        |
| 6.25     | 1.28   | 5.1      | 0.159           | 10.2      | 5              | 20    | 0.625           | 40        |
| 1.56     | 1.28   | 5.1      | 0.159           | 10.2      | 5              | 20    | 0.625           | 40        |

Therefore an ODR setting of 400 Hz, when accelerometer OSR is set to normal using CTRL\_REG2, would result in a maximum pulse-time limit of (0.625 ms \* 255) = 159 ms.

# 10.12.7 PULSE\_LTCY (0x27) register

Table 135. PULSE\_LTCY register

| pls_ltcy[7:0] |  |
|---------------|--|
| 0b0000_0000   |  |

Table 136. PULSE\_LTCY bit description

| Field           | Description  |
|-----------------|--|
| DIS ItCVI (*()) | pls_ltcy[7:0] defines the time interval that starts after the first pulse detection where the pulse-detection function ignores the start of a new pulse. |

Minimum time step for the pulse latency is defined in Tables 137 and 138. Maximum time is (time step @ ODR and power mode) x 255.

Table 137. Time step for PULSE\_LTCY with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 1

|          |        | Max time | range (s)       |           | Time step (ms) |      |                 |           |  |
|----------|--------|----------|-----------------|-----------|----------------|------|-----------------|-----------|--|
| ODR (Hz) | Normal | LPLN     | High resolution | Low power | Normal         | LPLN | High resolution | Low power |  |
| 800      | 0.638  | 0.638    | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5       |  |
| 400      | 1.276  | 1.276    | 1.276           | 1.276     | 5              | 5    | 5               | 5         |  |
| 200      | 2.56   | 2.56     | 1.276           | 2.56      | 10             | 10   | 5               | 10        |  |
| 100      | 5.1    | 5.1      | 1.276           | 5.1       | 20             | 20   | 5               | 20        |  |
| 50       | 10.2   | 10.2     | 1.276           | 10.2      | 40             | 40   | 5               | 40        |  |
| 12.5     | 10.2   | 40.8     | 1.276           | 40.8      | 40             | 160  | 5               | 160       |  |
| 6.25     | 10.2   | 40.8     | 1.276           | 81.6      | 40             | 160  | 5               | 320       |  |
| 1.56     | 10.2   | 40.8     | 1.276           | 81.6      | 40             | 160  | 5               | 320       |  |

Table 138. Time step for PULSE\_LTCY with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 0

|          |        | Max time | range (s)       |           | Time step (ms) |      |                 |           |
|----------|--------|----------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal | LPLN     | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.318  | 0.318    | 0.318           | 0.318     | 1.25           | 1.25 | 1.25            | 1.25      |
| 400      | 0.318  | 0.318    | 0.318           | 0.638     | 1.25           | 1.25 | 1.25            | 2.5       |
| 200      | 0.638  | 0.638    | 0.318           | 1.276     | 2.5            | 2.5  | 1.25            | 5         |
| 100      | 1.276  | 1.276    | 0.318           | 2.56      | 5              | 5    | 1.25            | 10        |
| 50       | 2.56   | 2.56     | 0.318           | 5.1       | 10             | 10   | 1.25            | 20        |
| 12.5     | 2.56   | 10.2     | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |
| 6.25     | 2.56   | 10.2     | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |
| 1.56     | 2.56   | 10.2     | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |

# 10.12.8 PULSE\_WIND (0x28) register

# Table 139. PULSE\_WIND register

| pls_wind[7:0] |  |
|---------------|--|
| 0b0000_0000   |  |

Table 140. PULSE\_WIND bit description

| Field         | Description   |
|---------------|---|
| pls_wind[7:0] | pls_wind[7:0] defines the maximum interval of time that can elapse after the end of the latency interval in which the start of the second pulse event must be detected provided the device has been configured for double pulse detection. The detected second pulse width must be shorter than the time limit constraint specified by the PULSE_TMLT register, but the end of the double pulse need not finish within the time specified by the PULSE_WIND register. |

The time step for the pulse-window counter varies with the selected ODR and power modes as defined in Tables 141 and 142. The maximum time value is equal to (time step @ ODR and power mode) x 255. Please note that when the device is operated in hybrid mode, the effective ODR is half of what is selected in CTRL\_REG1, which will double the time-step value from what is shown in Tables 141 and 142.

Table 141. Time step for PULSE\_WIND with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 1

|          | Max time range (s) |       |                 |           | Time step (ms) |      |                 |           |
|----------|--------------------|-------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal             | LPLN  | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.638              | 0.638 | 0.638           | 0.638     | 2.5            | 2.5  | 2.5             | 2.5       |
| 400      | 1.276              | 1.276 | 1.276           | 1.276     | 5              | 5    | 5               | 5         |
| 200      | 2.56               | 2.56  | 1.276           | 2.56      | 10             | 10   | 5               | 10        |
| 100      | 5.1                | 5.1   | 1.276           | 5.1       | 20             | 20   | 5               | 20        |
| 50       | 10.2               | 10.2  | 1.276           | 10.2      | 40             | 40   | 5               | 40        |
| 12.5     | 10.2               | 40.8  | 1.276           | 40.8      | 40             | 160  | 5               | 160       |
| 6.25     | 10.2               | 40.8  | 1.276           | 81.6      | 40             | 160  | 5               | 320       |
| 1.56     | 10.2               | 40.8  | 1.276           | 81.6      | 40             | 160  | 5               | 320       |

Table 142. Time step for PULSE\_WIND with HP\_FILTER\_CUTOFF[pls\_hpf\_en] = 0

|          | Max time range (s) |       |                 |           | Time step (ms) |      |                 |           |
|----------|--------------------|-------|-----------------|-----------|----------------|------|-----------------|-----------|
| ODR (Hz) | Normal             | LPLN  | High resolution | Low power | Normal         | LPLN | High resolution | Low power |
| 800      | 0.318              | 0.318 | 0.318           | 0.318     | 1.25           | 1.25 | 1.25            | 1.25      |
| 400      | 0.318              | 0.318 | 0.318           | 0.638     | 1.25           | 1.25 | 1.25            | 2.5       |
| 200      | 0.638              | 0.638 | 0.318           | 1.276     | 2.5            | 2.5  | 1.25            | 5         |
| 100      | 1.276              | 1.276 | 0.318           | 2.56      | 5              | 5    | 1.25            | 10        |
| 50       | 2.56               | 2.56  | 0.318           | 5.1       | 10             | 10   | 1.25            | 20        |
| 12.5     | 2.56               | 10.2  | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |
| 6.25     | 2.56               | 10.2  | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |
| 1.56     | 2.56               | 10.2  | 0.318           | 20.4      | 10             | 40   | 1.25            | 80        |

# 10.13 Accelerometer offset correction

The 8-bit 2's complement offset correction registers are used to remove the sensor zero g offset on the X, Y, and Z axes after device board mount. The resolution of the offset registers is 2 mg per LSB, with an effective offset adjustment range of -256 mg to +254 mg for each axis. The acceleration vectors represented in these registers will be added to the acceleration vectors acquired by the ASIC from the transducer prior to being written to the output data registers (registers 0x01 through 0x06). For example, to correct for an offset of 60 mg, a value representing -60 mg (= -60 mg / 2 mg/LSB = -30 LSB), which is 0xE2 in 8-bit 2's complement representation, should be written to the offset register.

For more information on how to calibrate the 0 g offset, please refer to Freescale application note AN4069.

#### **NOTE**

Accelerometer offset registers can only be modified when the device is in standby mode (See CTRL\_REG1).

# 10.13.1 OFF\_X (0x2F) register

# Table 143. OFF\_X register

| off_x[7:0]  |
|-------------|
| 0b0000_0000 |

# Table 144. OFF\_X bit description

| Field      | Description   |
|------------|---|
| off_x[7:0] | X-axis offset correction value expressed as an 8-bit 2's complement number. |

# 10.13.2 OFF\_Y (0x30) register

#### Table 145. OFF\_Y register

| off_y[7:0]  |
|-------------|
| 0b0000_0000 |

#### Table 146. OFF\_Y bit description

| Field      | Description   |
|------------|---|
| off_y[7:0] | Y-axis offset correction value expressed as an 8-bit 2's complement number. |

# 10.13.3 OFF\_Z (0x31) register

# Table 147. OFF\_Z register

| off_z[7:0]  |
|-------------|
| 0b0000_0000 |

## Table 148. OFF\_Z bit description

| Field      | Description   |
|------------|---|
| off_z[7:0] | Z-axis offset correction value expressed as an 8-bit 2's complement number. |

# 10.14 Magnetometer data registers

## 10.14.1 M\_DR\_STATUS (0x32) register

Magnetic data-ready status register.

This register indicates the real-time status information of the X, Y, and Z magnetic sample data.

## Table 149. M\_DR\_STATUS register

| xyzow | zow | yow | xow | xyzdr | zdr | ydr | xdr |
|-------|-----|-----|-----|-------|-----|-----|-----|
| 0     | 0   | 0   | 0   | 0     | 0   | 0   | 0   |

## Table 150. M\_DR\_STATUS bit descriptions

| Field | Description  |
|-------|--|
| zyxow | <ul> <li>zyxow is set to one whenever new magnetic data is acquired before completing the retrieval of the previous data set. This event occurs when the content of at least one magnetometer output data register (that is, M_OUT_X/Y/Z) has been overwritten. zyxow is cleared when the most significant bytes of the magnetometer data (M_OUT_X_MSB, M_OUT_Y_MSB, and M_OUT_Z_MSB) are read.</li> <li>X, Y, Z-axis data overwrite:</li> <li>0: No data overwrite has occurred</li> <li>1: Previous X-, Y-, Z-magnetic data was overwritten by new X, Y, Z data before it was completely read</li> </ul> |
| zow   | zow is set to 1 whenever a new Z-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. zow is cleared anytime the M_OUT_Z_MSB register is read.  Z-axis data overwrite:  0: No data overwrite has occurred  1: Previous Z-axis magnetic data was overwritten by new Z-axis data before it was read   |
| yow   | yow is set to 1 whenever a new Y-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. yow is cleared anytime M_OUT_Y_MSB register is read. Y-axis data overwrite:  0: No data overwrite has occurred 1: Previous Y-axis magnetic data was overwritten by new Y-axis data before it was read   |
| xow   | <ul> <li>xow is set to 1 whenever a new X-axis acquisition is completed before the retrieval of the previous data. When this occurs the previous data is overwritten. xow is cleared anytime the M_OUT_X_MSB register is read.</li> <li>X-axis data overwrite:</li> <li>No data overwrite has occurred</li> <li>Previous X-axis magnetic data was overwritten by new X-axis data before it was read</li> </ul>   |
| zyxdr | <ul> <li>zyxdr signals that a new acquisition for the X, Y, and Z axes magnetic data is available. zyxdr is cleared when the most significant bytes of the magnetometer data (M_OUT_X_MSB, M_OUT_Y_MSB, and M_OUT_Z_MSB) are read.</li> <li>X, Y, Z new data available:</li> <li>No new set of X, Y, Z magnetic data is available</li> <li>A new set of X, Y, Z magnetic data is available</li> </ul>  |
| zdr   | <ul> <li>zdr is set to 1 whenever a new Z-axis data acquisition is completed. zdr is cleared anytime the M_OUT_Z_MSB register is read. Z-axis new data available:</li> <li>0: No new Z-axis magnetic data is available</li> <li>1: New Z-axis magnetic data is available</li> </ul>  |
| ydr   | <ul> <li>ydr is set to 1 whenever a new Y-axis data acquisition is completed. ydr is cleared anytime the M_OUT_Y_MSB register is read. Y-axis new data available:</li> <li>0: No new Y-axis magnetic data is available</li> <li>1: New Y-axis magnetic data is available</li> </ul>  |
| xdr   | <ul> <li>xdr is set to 1 whenever a new X-axis data acquisition is completed. xdr is cleared anytime the M_OUT_X_MSB register is read. X-axis new data available:</li> <li>0: No new X-axis magnetic data is available.</li> <li>1: New X-axis magnetic data is available</li> </ul>   |

# 10.14.2 M\_OUT\_X\_MSB (0x33), M\_OUT\_X\_LSB (0x34), M\_OUT\_Y\_MSB (0x35), M\_OUT\_Y\_LSB (0x36), M\_OUT\_Z\_MSB (0x37), M\_OUT\_Z\_LSB (0x38) registers

X-axis, Y-axis, and Z-axis 16-bit magnetic output data expressed as 2's complement numbers, with a resolution of 0.1 μT/LSB.

| Table 151. M_OUT_X_MSB ( | (0x33) register |
|--------------------------|-----------------|
|--------------------------|-----------------|

| m_out_x[15:8] |  |
|---------------|--|
| 0b0000_0000   |  |

#### Table 152. M\_OUT\_X\_LSB (0x34) register

| m_out_x[7:0] |
|--------------|
| 000000_0000  |

#### Table 153. M\_OUT\_Y\_MSB (0x35) register

| m_out_y[15:8] |
|---------------|
| 0b0000_0000   |

#### Table 154. M\_OUT\_Y\_LSB (0x36) register

| m_out_y[7: |   |
|------------|---|
| 0b0000_000 | ) |

#### Table 155. M\_OUT\_Z\_MSB (0x37) register

| m_out_z[15:8] |  |
|---------------|--|
| 0b0000_0000   |  |

#### Table 156. M\_OUT\_Z\_LSB (0x38) register

| m_out_z[7:0] |
|--------------|
| 0b0000_0000  |

# 10.14.3 CMP\_X\_MSB (0x39), CMP\_X\_LSB (0x3A), CMP\_Y\_MSB (0x3B), CMP\_Y\_LSB (0x3C), CMP\_Z\_MSB (0x3D), CMP\_Z\_LSB (0x3E) registers

These registers contain the 2's complement 14-bit decimated acceleration values, and are time aligned with the magnetometer sample data. The decimation is controlled by the ODR (CTRL\_REG1 dr[2:0]) and the magnetometer OSR (M\_CTRL\_REG1 m\_os[2:0]) settings. These registers allow the host application to acquire a complete set of time-aligned magnetic and acceleration data with the same oversampling ratio applied to each axis. Note that unlike the acceleration data available in the OUT\_X/Y/Z registers located at addresses x1-x6, the data in the CMP\_X/Y/Z registers is right justified.

#### Table 157. CMP\_X\_MSB (0x39) register

| _             | _               | cmp_x[13:8] |
|---------------|-----------------|-------------|
|               |                 |             |
| Tabla 150 CMF | 2 V I CD /0~2 A | \ register  |

#### Table 158. CMP\_X\_LSB (0x3A) register

| cmp_x[7:0] |
|------------|
|------------|

## Table 159. CMP\_Y\_MSB (0x3B) register

| _ | _ | cmp_y[13:8] |
|---|---|-------------|
|   |   | 1 – 7       |

#### Table 160. CMP\_Y\_LSB (0x3C) register

| r= 01        |  |
|--------------|--|
| cmp_v[7:0]   |  |
| 0111p_y[1.0] |  |

## Table 161. CMP\_Z\_MSB (0x3D) register

| _ | _ | cmp_z[13:8] |
|---|---|-------------|

#### Table 162. CMP\_Z\_LSB (0x3E) register

cmp\_z[7:0]

# 10.14.4 MAX\_X\_MSB (0x45), MAX\_X\_LSB (0x46), MAX\_Y\_MSB (0x47), MAX\_Y\_LSB (0x48), MAX\_Z\_MSB (0x49), MAX\_Z\_LSB (0x4A) registers

The magnetometer MAX\_X/Y/Z registers are 16-bit 2's complement format with a resolution of 0.1  $\mu$ T/LSB. The registers are read/write and along with the MIN\_X/Y/Z registers are used to calculate the magnetic offset for each axis using the equation (MAX\_X/Y/Z + MIN\_X/Y/Z) /2 when M\_CTRL\_REG2[maxmin\_dis] = 0 (default).

When M\_CTRL\_REG1[m\_acal] = 1 (default 0), the MAG\_OFF\_X/Y/Z registers are automatically updated with the calculated offset values at the end of every measurement cycle (ODR period).

On a POR, or after setting M\_CTRL\_REG2[maxmin\_rst] = 1, the MAX\_X/Y/Z registers are loaded with the hex value 0x8000 (negative full scale).

The host application may write to the MAX\_X/Y/Z registers to change the currently used maximum values for each axis, however, when M\_CTRL\_REG1[ $maxmin\_dis$ ] = 0 (default), the system will overwrite these values when it updates the MAX\_X/Y/Z registers at the end of the next measurement cycle (ODR period).

## Table 163. MAX\_X\_MSB register

| max_x[15:8] |  |
|-------------|--|
| 0b0000_0000 |  |

#### Table 164. MAX\_X\_LSB register

| max_x[7:0]  |  |
|-------------|--|
| 0b0000_0000 |  |

#### Table 165. MAX\_Y\_MSB register

| max_y[15:8] |  |
|-------------|--|
| 0b0000_0000 |  |

#### Table 166. MAX\_Y\_LSB register

| max_y[7:0]  |  |
|-------------|--|
| 0b0000_0000 |  |

#### Table 167. MAX\_Z\_MSB register

| max_z[15:8] |
|-------------|
| 0b0000_0000 |

## Table 168. MAX\_Z\_LSB register

| max_z[7:0]  |  |
|-------------|--|
| 0b0000_0000 |  |

# 10.14.5 MIN\_X\_MSB (0x4B), MIN\_X\_LSB (0x4C), MIN\_Y\_MSB (0x4D), MIN\_Y\_LSB (0x4E), MIN\_Z\_MSB (0x4F), MIN\_Z\_LSB (0x50) registers

The magnetometer MIN\_X/Y/Z registers are 16-bit, 2's complement format with a resolution of 0.1  $\mu$ T/LSB. The registers are read/write and along with the MAX\_X/Y/Z registers are used to calculate the magnetic offset for each axis using the equation (MAX\_X/Y/Z + MIN\_X/Y/Z) /2 when M\_CTRL\_REG2[maxmin\_dis] = 0 (default).

When M\_CTRL\_REG1[m\_acal] = 1 (default 0), the MAG\_OFF\_X/Y/Z registers are automatically updated with the calculated offset values at the end of every measurement cycle (ODR period).

On a POR, or after setting M\_CTRL\_REG2[maxmin\_rst] = 1, the MIN\_X/Y/Z registers are loaded with the hex value 0x7FFF (positive full scale). The host application may write to the MIN\_X/Y/Z registers to change the currently used minimum values for each axis, however, when M\_CTRL\_REG1[maxmin\_dis] = 0 (default), the system will overwrite these values when it updates the MIN\_X/Y/Z registers at the end of the next measurement cycle (ODR period).

## Table 169. MIN\_X\_MSB register

| min_x[15:8] |
|-------------|
| 0b0000_0000 |

#### Table 170. MIN\_X\_LSB register

| min_x[7:0]  |
|-------------|
| 0b0000_0000 |

#### Table 171. MIN\_Y\_MSB register

| min_y[15:8] |
|-------------|
| 0b0000_0000 |

#### Table 172. MIN\_Y\_LSB register

| min_y[7:0]  |
|-------------|
| 0b0000_0000 |

#### Table 173. MIN\_Z\_MSB register

| min_z[15:8] |
|-------------|
| 0b0000_0000 |

#### Table 174. MIN\_Z\_LSB register

| min_z[7:0]  |
|-------------|
| 0b0000_0000 |

## 10.15 Magnetometer offset correction

# 10.15.1 M\_OFF\_X\_MSB (0x3F), M\_OFF\_X\_LSB (0x40), M\_OFF\_Y\_MSB (0x41), M\_OFF\_Y\_LSB (0x42), M\_OFF\_Z\_MSB (0x43), M\_OFF\_Z\_LSB (0x44) registers

The zero-field output for each axis can be adjusted by writing to these registers. The user must set  $M_{CTRL_REG3[m_raw]} = 0$  (default) for the values in these registers to have any effect on the magnetic output data.

Desired offset should to be written into the 15 most-significant bits in each register pair using 2's complement representation. The offset registers have a sensitivity of 0.1  $\mu$ T/LSB and with an effective offset adjustment range of -1638.4  $\mu$ T to +1638.3  $\mu$ T.

The magnetic field vectors represented in these registers will be subtracted from the magnetic field vectors acquired by the ASIC from the transducer prior to being written to the output data registers (registers 0x33 through 0x38). For example, to correct for an offset of 60  $\mu$ T, a value representing 60  $\mu$ T (= 60  $\mu$ T / 0.1  $\mu$ T/LSB = 600 LSB), which is 0x0258 in 15-bit two's complement representation, should be written to the offset registers following a left-shift for proper alignment (0x0258<<1 = 0x04b0).

#### Table 175. M\_OFF\_X\_MSB register

| m_off_x[14:7] |
|---------------|
| 0b0000_0000   |

#### Table 176. M\_OFF\_X\_LSB register

| m_off_x[6:0] | _ |
|--------------|---|
| 0b000_0000   | 0 |

#### Table 177. M\_OFF\_Y\_MSB register

| m_ | _off_y[14:7] |
|----|--------------|
| 0b | 0000_0000    |

#### Table 178. M\_OFF\_Y\_LSB register

| m_off_y[6:0] | _ |
|--------------|---|
| 0b000_0000   | 0 |

#### Table 179. M\_OFF\_Z\_MSB register

| m_off_z[14:7] |
|---------------|
| 0b0000_0000   |

#### Table 180. M\_OFF\_Z\_LSB register

| m_off_z[6:0] |   |
|--------------|---|
| 0b000_0000   | 0 |

## 10.16 Magnetometer threshold function

The magnetometer threshold function works in a similar manner to the freefall/motion detection module but uses magnetic data for the event detection instead of acceleration data. The  $m\_ths\_oae$  bit setting determines the logic used to evaluate the threshold detection function for the enabled axes. With  $m\_ths\_oae = 0$ , the magnetic sample data for each enabled axis must be below the threshold values specified in the MAG\_THS\_X/Y/Z registers for the time period specified in MAG\_THS\_COUNT before the event flag is triggered. For  $m\_ths\_oae = 1$ , any of the enabled axes must be above the threshold values specified in the MAG\_THS\_X/Y/Z registers for the time period specified in MAG\_THS\_COUNT before the event flag is triggered.

## 10.16.1 M\_THS\_CFG (0x52) register

Magnetic-field threshold detection configuration register.

#### Table 181. M\_THS\_CFG register

| m_ths_ele | m_ths_oae | m_ths_zefe | m_ths_yefe | m_ths_xefe | m_ths_wake_en | m_ths_int_en | m_ths_int_cfg |
|-----------|-----------|------------|------------|------------|---------------|--------------|---------------|
| 0         | 0         | 0          | 0          | 0          | 0             | 0            | 0             |

#### Table 182. M\_THS\_CFG bit descriptions

| Field         | Description   |  |  |  |  |
|---------------|---|--|--|--|--|
| m_ths_ele     | Magnetic-threshold event latch enable.  0: Event flag latch disabled. Magnetic-threshold events are not latched, and the event flag will change state with the real-time status of the event detection logic.  1: Event flag latch enabled. Magnetic-threshold events are latched and the event flag can only be cleared by reading the M_THS_SRC register. |  |  |  |  |
| m_ths_oae     | Magnetic-threshold event logic selection.  0: Logical "AND" of enabled axes X, Y, and Z below threshold flags is used to detect the event.  1: Logical "OR" of enabled axes X, Y, and Z above threshold flags is used to detect the event.  |  |  |  |  |
| m_ths_zefe    | Event-flag enable on Z-axis.  0: Z-axis event detection disabled  1: Raise event flag on measured magnetic field value above/below preset threshold for Z-axis  |  |  |  |  |
| m_ths_yefe    | Event-flag enable on Y-axis.  0: Y-axis event detection disabled  1: Raise event flag on measured magnetic field value above/below preset threshold for Y-axis  |  |  |  |  |
| m_ths_xefe    | Event-flag enable on X-axis.  0: X-axis event detection disabled  1: Raise event flag on measured magnetic field value above/below preset threshold for X-axis  |  |  |  |  |
| m_ths_wake_en | O: The system excludes the magnetic-threshold event flag when evaluating the Auto-Sleep/Wake function.     The system includes the magnetic-threshold event flag when evaluating the Auto-Sleep/Wake function.  |  |  |  |  |
| m_ths_int_en  | O: Magnetic-threshold interrupt is disabled.  1: Magnetic-threshold interrupt is enabled.   |  |  |  |  |
| m_ths_int_cfg | O: Magnetic-threshold event flag is output on INT2 pin (logically OR'd with other INT2 interrupt events)  1: Magnetic-threshold event flag is output on INT1 pin (logically OR'd with other INT1 interrupt events)  |  |  |  |  |

The unsigned 15-bit M\_THS\_X/Y/Z registers hold the threshold used for magnetic-event detection. With M\_THS\_CFG  $[m\_ths\_oae] = 0$ , the event is detected when all of the enabled axes are below or equal to their respective threshold values (AND condition). With M\_THS\_CFG  $[m\_ths\_oae] = 1$ , the event is detected when any of the enabled axes is above or equal to their respective threshold value (OR condition). The thresholds for each axis are applied after the magnetic data has been adjusted by the offset values stored in the M\_OFF\_X/Y/Z registers when M\_CTRL\_REG3[ $m\_raw$ ] = 0.

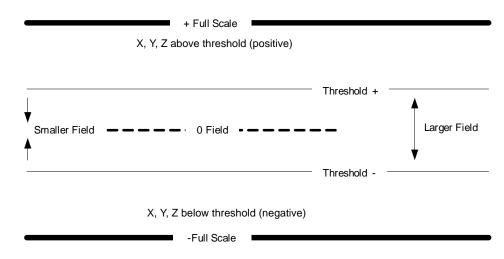


Figure 18. Illustration of magnetic threshold detection

## 10.16.2 M\_THS\_SRC (0x53) register

Magnetic-threshold interrupt source register.

This register keeps track of the magnetic threshold event which is triggering (or has triggered, when M\_THS\_CFG[ $m_ths_ele$ ] = 1) the event flag. In particular, if M\_THS\_SRC[ $m_ths_ele$ ] is set to a logic '1' then the logical combination of magnetic-event flags specified in M\_THS\_CFG is true.

Table 183. M\_THS\_SRC register

| m_ths_ea | _ | m_ths_zhe | m_ths_zhp | m_ths_yhe | m_ths_yhp | m_ths_xhe | m_ths_xhp |
|----------|---|-----------|-----------|-----------|-----------|-----------|-----------|
| 0        | 0 | 0         | 0         | 0         | 0         | 0         | 0         |

Table 184. M\_THS\_SRC bit descriptions

| Field         | Description  |  |
|---------------|--|--|
|               | Event-active flag.   |  |
| m_ths_ea      | 0: No event flag has been asserted   |  |
|               | 1: One or more event flag(s) has been asserted.                                |  |
|               | Z-high event flag.   |  |
| m_ths_zhe     | 0: No event detected   |  |
| 111_013_2116  | 1: Z-high event has been detected  |  |
|               | This bit always reads zero if the <i>m_ths_zefe</i> control bit is set to zero |  |
|               | Z-high event polarity flag.  |  |
| m_ths_zhp     | 0: Z event detected was positive polarity                                      |  |
| 111_t115_211p | 1: Z event detected was negative polarity                                      |  |
|               | This bit always reads zero if the <i>m_ths_zefe</i> control bit is set to zero |  |
|               | Y-high event flag.   |  |
| m_ths_yhe     | 0: No event detected   |  |
| III_tii5_yiie | 1: Y-high event has been detected  |  |
|               | This bit always reads zero if the <i>m_ths_yefe</i> control bit is set to zero |  |
|               | Y-high event polarity flag.  |  |
| m_ths_yhp     | 0: Y event detected was positive polarity                                      |  |
| III_ti15_y11p | 1: Y event detected was negative polarity                                      |  |
|               | This bit always reads zero if the m_ths_yefe control bit is set to zero        |  |
|               | X-high event flag.   |  |
| m_ths_xhe     | 0: No event detected   |  |
| III_UI3_XIIE  | 1: X-high event has been detected  |  |
|               | This bit always reads zero if the m_ths_xefe control bit is set to zero        |  |
|               | X-high event polarity flag.  |  |
| m_ths_xhp     | 0: X event detected was positive polarity                                      |  |
| III_tiIs_XIIP | 1: X event detected was negative polarity.                                     |  |
|               | This bit always reads zero if the <i>m_ths_xefe</i> control bit is set to zero |  |

# 10.16.3 M\_THS\_X\_MSB (0x54), M\_THS\_X\_LSB (0x55), M\_THS\_Y\_MSB (0x56), M\_THS\_Y\_LSB (0x57), M\_THS\_Z\_MSB (0x58), M\_THS\_Z\_LSB (0x59) registers

The M\_THS\_X/Y/Z registers contain the unsigned 15-bit magnetic thresholds used by the magnetic-threshold function. Each register has a resolution of 0.1  $\mu$ T/LSB. The thresholds are evaluated after the magnetic data has been adjusted by the offset value stored in the M\_OFF\_X/Y/Z registers when M\_CTRL\_REG3[m\_raw] = 0.

## Table 185. M\_THS\_X\_MSB register

| m_ths_dbcntm | m_ths_x[14:8] |
|--------------|---------------|
| 0            | 0b000_0000    |

## Table 186. M\_THS\_X\_MSB bit descriptions

| Field  | Description  |  |  |
|--|--|--|--|
| The <i>m_ths_dbcntm</i> bit configures the way in which the debounce counter is reset when the magnetic event momentarily not true.  m_ths_dbcntm When <i>m_ths_dbcntm</i> = 1, the debounce counter is cleared to 0 whenever the magnetic event of interest is not when <i>m_ths_dbcntm</i> = 0, the debounce counter is decremented by 1 whenever the magnetic event of interest into longer true. |  |  |  |
| m_ths_x[14:8]  | Upper 7 bits of the 15-bit unsigned X-axis magnetic threshold. |  |  |

## Table 187. M\_THS\_X\_LSB register

| m_ths_x[7:0] |
|--------------|
| 0b0000_0000  |

## Table 188. M\_THS\_Y\_MSB register

| _ | m_ths_y[14:8] |
|---|---------------|
| 0 | 0b000_0000    |

## Table 189. M\_THS\_Y\_LSB register

| m_ths_y[7:0] |
|--------------|
| 0b0000_0000  |

## Table 190. M\_THS\_Z\_MSB register

| _ | m_ths_z[14:8] |
|---|---------------|
| 0 | 0b000_0000    |

## Table 191. M\_THS\_Z\_LSB register

| m_ths_z[7:0] |  |
|--------------|--|
| 0b0000_0000  |  |

## 10.16.4 M\_THS\_COUNT (0x5A) register

This register sets the number of debounce sample counts required before a magnetic threshold event is triggered. The behavior of the debounce counter is controlled by M\_THS\_X\_MSB [*m\_ths\_dbcntm*].

## Table 192. M\_THS\_COUNT register

| m_ths_cnt[7:0] |  |
|----------------|--|
| 0b0000_0000    |  |

## Table 193. M\_THS\_COUNT bit description

| Field          | Description                              |  |  |
|----------------|--|--|--|
| m_ths_cnt[7:0] | Magnetic threshold debounce count value. |  |  |

When the internal debounce counter reaches the M\_THS\_COUNT value a magnetic event flag is set. The debounce counter will never increase beyond the M\_THS\_COUNT value. The time step used for the debounce sample count depends on the chosen ODR. When hybrid mode is enabled, the effective ODR is reduced by a factor of two, which increases the debounce counter time step by a factor of two from what is shown in Table 194.

Table 194. M\_THS\_COUNT relationship with the ODR

| ODB (U-) | Time step (ms)                     |                           |  |
|----------|------------------------------------|---------------------------|--|
| ODR (Hz) | M_CTRL_REG1[ <i>m_hms</i> ] = 0b01 | M_CTRL_REG1[m_hms] = 0b11 |  |
| 800      | N/A                                | N/A                       |  |
| 400      | 2.5 5                              | 5                         |  |
| 200      | 5                                  | 10                        |  |
| 100      | 10                                 | 20                        |  |
| 50       | 20                                 | 40                        |  |
| 12.5     | 80                                 | 160                       |  |
| 6.25     | 160                                | 320                       |  |
| 1.56     | 641                                | 1282                      |  |

For example, an ODR of 100 Hz and a M\_THS\_COUNT value of 15 would result in a debounce response time of 150 ms. In hybrid mode, the same settings would result in a debounce response time of 300 ms.

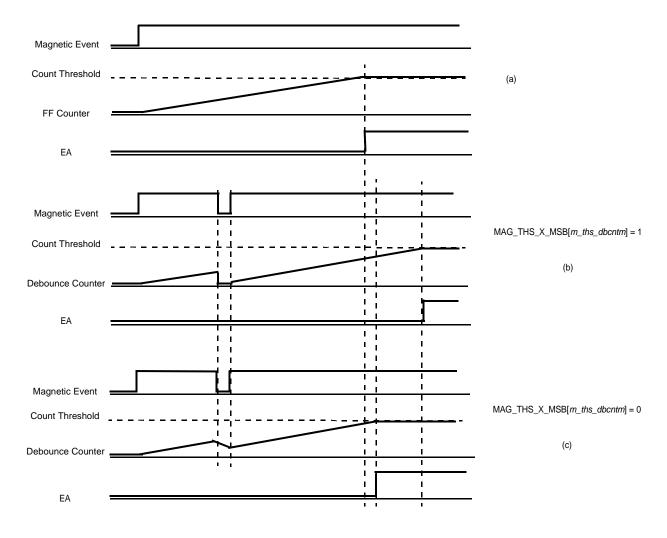


Figure 19. DBCNTM bit function

# 10.17 Magnetometer control registers

## 10.17.1 M\_CTRL\_REG1 (0x5B) register

## Table 195. M\_CTRL\_REG1 register

| m_acal | m_rst | m_ost | m_os[2:0] | m_hms[1:0] |
|--------|-------|-------|-----------|------------|
| 0      | 0     | 0     | 0b000     | 0b00       |

## Table 196. M\_CTRL\_REG1 bit descriptions

| Field  | Description   |
|--------|---|
| m_acal | Magnetic hard-iron offset auto-calibration enable:  0: Auto-calibration feature disabled  1: Auto-calibration feature is enabled; the ASIC uses the maximum and minimum magnetic data to determine the hard iron offset value. The M_OFF_X/Y/Z registers are automatically loaded with (MAX_X/Y/Z + MIN_X/Y/Z)/2 for each axis at the end of every ODR cycle. |
| m_rst  | One-shot magnetic reset degauss control bit:  0: No magnetic sensor reset is active  1: One-shot magnetic reset is enabled, hardware cleared when complete.   |

## Table 196. M\_CTRL\_REG1 bit descriptions (Continued)

| m_ost      | One-shot triggered magnetic measurement mode:  0: No action taken, or one-shot measurement complete.  1: If device is in Active mode no action is taken. If device is in Standby mode, take one set of magnetic measurements, clear this bit, and return to Standby mode. |  |  |  |  |
|------------|---|--|--|--|--|
| m_os[2:0]  | Oversample ratio (OSR) for magnetometer data (see Table 201).   |  |  |  |  |
| m_hms[1:0] | 0b00 = Only accelerometer sensor is active 0b01 = Only magnetometer sensor is active 0b11 = Hybrid mode, both accelerometer and magnetometer sensors are active <sup>(1)</sup>  |  |  |  |  |

<sup>1.</sup> When operating in hybrid mode, the effective ODR for each sensor is half of the frequency selected in the CTRL\_REG1[dr] and CTRL\_REG1[aslp\_rate] bit fields.

The *m\_os*[2:0] OSR setting along with the system ODR value set in CTRL\_REG1 determines the magnetic output data update rate.

When *m\_hms*[1:0] = 2'b11, magnetic output data is available in registers M\_OUT\_X\_MSB (0x33), M\_OUT\_X\_LSB (0x34), M\_OUT\_Y\_MSB (0x35), M\_OUT\_Y\_LSB (0x36), M\_OUT\_Z\_MSB (0x37), and M\_OUT\_Z\_LSB (0x38) along with the time synchronized accelerometer data in CMP\_X\_MSB (0x39), CMP\_X\_LSB (0x3A), CMP\_Y\_MSB (0x3B), CMP\_Y\_LSB (0x3C), CMP\_Z\_MSB (0x3D), and CMP\_Z\_LSB (0x3E).

## 10.17.2 M\_CTRL\_REG2 (0x5C) register

## Table 197. M\_CTRL\_REG2 register

| _ | _ | hyb_autoinc_mode | m_maxmin_dis | m_maxmin_dis_ths | m_maxmin_rst | m_rst_cnt[1:0] |
|---|---|------------------|--------------|------------------|--------------|----------------|
| 0 | 0 | 0                | 0            | 0                | 0            | 0b00           |

#### Table 198. M\_CTRL\_REG2 bit descriptions

| Field            | Description   |
|------------------|---|
| hyb_autoinc_mode | With hyb_autoinc_mode = 1 and fast-read mode is disabled (CTRL_REG1 [f_read] = 0), the register address will automatically advance to register x33 (M_OUT_X_MSB) after reading register x06 (OUT_Z_LSB) in burst-read mode. For hyb_autoinc_mode = 1 and fast read mode enabled (CTRL_REG1[f_read = 1) the register address will automatically advance to register x33 (M_OUT_X_MSB) after reading register x05 (OUT_Z_MSB) during a burst-read mode. Please refer to the register map auto-increment address column for further information. |
| m_maxmin_dis     | Magnetic measurement max/min detection function disable:  0: Magnetic min/max detection function is enabled (default).  1: Magnetic min/max detection function is disabled.  When enabled, the magnetic min/max detection function will update the MAX_X/Y/Z and MIN_X/Y/Z registers at the end of each ODR cycle with the maximum and minimum magnetic measurements from each axis. This is used along with the auto-cal feature (M_CTRL_REG1[m_acal] = 1) as a hardware based hard-iron offset compensation function.                       |
| m_maxmin_dis_ths | Magnetic measurement min/max detection function disable using the magnetic threshold event trigger:  0: No impact to magnetic min/max detection function on a magnetic threshold event  1: Magnetic min/max detection function is disabled when magnetic threshold event is triggered   |
| m_maxmin_rst     | Magnetic measurement min/max detection function reset:  0: No reset sequence is active  1: Setting this bit resets the MIN_X/Y/Z and MAX_X/Y/Z registers to 0x7FFF and 0x8000, respectively (positive and negative full-scale values). This bit is automatically cleared after the reset is completed.  |
| m_rst_cnt[1:0]   | Magnetic sensor reset (degaussing) frequency: 0b00: Automatic magnetic reset at the beginning of each ODR cycle (default). 0b01: Automatic magnetic reset every 16 ODR cycles. 0b10: Automatic magnetic reset every 512 ODR cycles. 0b11: Automatic magnetic reset is disabled. Magnetic reset only occurs automatically on a transition from Standby to Active mode, or can be triggered manually by setting M_CTRL_REG1[m_rst] = 1  |

# 10.17.3 M\_CTRL\_REG3 (0x5D) register

## Table 199. M\_CTRL\_REG3 register

| m_raw | m_aslp_os[2:0] | m_ths_xyz_update | m_st_z | m_st_xy[1:0] |
|-------|----------------|------------------|--------|--------------|
| 0     | 0b000          | 0                | 0      | 0b00         |

## Table 200. M\_CTRL\_REG3 bit descriptions

| Field            | Description  |
|------------------|--|
| m_raw            | Magnetic measurement RAW mode enable:  0: Values stored in the M_OFF_X/Y/Z registers are applied to the magnetic sample data. This bit must be cleared in order for the automatic hard-iron compensation function to have any effect.  1: Values stored in M_OFF_X/Y/Z are not applied to the magnetic sample data; automatic hard-iron compensation function does not have any effect on the output data. |
| m_aslp_os[2:0]   | Defines magnetometer OSR in Auto-Sleep mode. See Table 201.  |
| m_ths_xyz_update | This control bit defines which reference values are updated when the magnetic threshold event detection function triggers.  0: X, Y and Z reference values are all updated when the function triggers on any of the X, Y, or Z axes.  1: Only the reference value for the axis that triggered the detection event is updated.  |
| m_st_z           | Enables Z-axis magnetic self-test function when set.   |
| m_st_xy[1:0]     | Enables both X and Y axes magnetic self-test function simultaneously when set to a value greater than 0b00. X and Y magnetic self-test is disabled when this field is set to 2'b00.  |

## Table 201. M-cell OSR versus ODR

| ODR (Hz) | OSR = 0 | OSR = 1 | OSR = 2 | OSR = 3 | OSR = 4 | OSR = 5 | OSR = 6 | OSR = 7 |
|----------|---------|---------|---------|---------|---------|---------|---------|---------|
| 1.56     | 16      | 16      | 32      | 64      | 128     | 256     | 512     | 1024    |
| 6.25     | 4       | 4       | 8       | 16      | 32      | 64      | 128     | 256     |
| 12.5     | 2       | 2       | 4       | 8       | 16      | 32      | 64      | 128     |
| 50       | 2       | 2       | 2       | 2       | 4       | 8       | 16      | 32      |
| 100      | 2       | 2       | 2       | 2       | 2       | 4       | 8       | 16      |
| 200      | 2       | 2       | 2       | 2       | 2       | 2       | 4       | 8       |
| 400      | 2       | 2       | 2       | 2       | 2       | 2       | 2       | 4       |
| 800      | 2       | 2       | 2       | 2       | 2       | 2       | 2       | 2       |

# 10.17.4 M\_INT\_SRC (0x5E) register

## Table 202. M\_INT\_SRC register

| _ | _ | _ | _ | _ | src_m_ths | src_m_vecm | src_m_drdy |
|---|---|---|---|---|-----------|------------|------------|
| 0 | 0 | 0 | 0 | 0 | 0         | 0          | 0          |

## Table 203. M\_INT\_SRC bit description

| Field      | Description   |  |  |  |  |  |
|------------|---|--|--|--|--|--|
| src_m_ths  | Magnetic threshold interrupt flag: 0: Magnetic threshold event has not been detected. 1: Magnetic threshold event has been detected.                                      |  |  |  |  |  |
| src_m_vecm | Magnetic vector-magnitude interrupt flag:  0: Magnetic vector-magnitude change event has not been detected.  1: Magnetic vector-magnitude change event has been detected. |  |  |  |  |  |
| src_m_drdy | Magnetic data-ready interrupt flag: o: No new magnetic data is available. 1: New magnetic data is available.  |  |  |  |  |  |

## 10.18 Magnetometer vector-magnitude function

The magnetometer vector-magnitude function will generate an interrupt when

 $\sqrt{(m_x\_out - m_x\_ref)^2 + (m_y\_out - m_y\_ref)^2 + (m_z\_out - m_z\_ref)^2} > M_VECM_THS$  value and  $t > M_VECM\_CNT$  value. Where  $m_x\_out$ ,  $m_y\_out$ , and  $m_z\_out$  are the current decimated magnetometer output values, and  $m_x\_ref$ ,  $m_y\_ref$ , and  $m_z\_ref$  are the internally latched reference values. The user may program the  $M_vECM_THS$  and  $M_vECM_CNT$  registers to establish the conditions needed to detect a magnetic vector-magnitude change event. Depending on the values chosen for the reference values, this function may be configured to detect a magnetic field magnitude that is above a preset threshold (with reference values = 0), or a change in magnitude between two magnetic vectors greater than the preset threshold (with reference values non-zero). Please note  $x_ref$ ,  $y_ref$ ,  $z_ref$  are stored internally and are not observable by the user through the register interface. Please refer to Freescale application note AN4458.

## 10.18.1 M\_VECM\_CFG (0x69) register

#### Table 204. M\_VECM\_CFG register

|   | m_vecm_ele | m_vecm_initm | m_vecm_updm | m_vecm_en | m_vecm_wake_en | m_vecm_init_en | m_vecm_init_cfg |
|---|------------|--------------|-------------|-----------|----------------|----------------|-----------------|
| 0 | 0          | 0            | 0           | 0         | 0              | 0              | 0               |

#### Table 205. M\_VECM\_CFG bit descriptions

| Field           | Description  |
|-----------------|--|
| m_vecm_ele      | Magnetic vector-magnitude event latch enable:  0: Event latch disabled  1: Event latch enabled  With event latching enabled, the src_m_vecm interrupt flag may only be cleared by reading the M_INT_SRC register.  With event latching disabled, the src_m_vecm interrupt flag is updated in real time and may be cleared by the ASIC prior to the user reading the flag.  |
| m_vecm_initm    | Magnetic vector-magnitude initialization mode: 0: The ASIC uses the current magnetic output data as the initial reference values at the time the <i>m_vecm_en</i> bit is set. 1: The ASIC uses the data stored in the M_VECM_X/Y/Z_INIT registers as the initial reference values at the time the <i>m_vecm_en</i> bit is set.   |
| m_vecm_updm     | Magnetic vector-magnitude reference value update mode:  0: The function updates the reference values with the current X/Y/Z magnetic data when the event is triggered.  1: The function does not update the reference values when the event is triggered.  Setting m_vecm_initm = 1 and m_vecm_updm = 1 allows the user to manually update the reference values using the M_VECM_INIT_X/Y/Z registers in real time when the function is enabled. |
| m_vecm_en       | Magnetic vector-magnitude function enable: 0: Function is disabled. 1: Function is enabled, the ASIC will update the internal m_x/y/z_ref registers with either the current magnetic output data or the values stored in the M_VECM_INIT_X/Y/Z registers depending on the state of m_vecm_initm.  Note: The magnetic vector-magnitude function will only function correctly up to a maximum ODR of 400 Hz.                                       |
| m_vecm_wake_en  | Magnetic vector-magnitude wake enable:  0: The system excludes the $src\_m\_vecm$ event flag when evaluating the Auto-Sleep function.  1: The system includes the $src\_m\_vecm$ event flag when evaluating the Auto-Sleep function.   |
| m_vecm_int_en   | Magnetic vector-magnitude interrupt enable: 0: Magnetic vector-magnitude interrupt is disabled. 1: Magnetic vector-magnitude interrupt is enabled.   |
| m_vecm_init_cfg | Magnetic vector-magnitude interrupt configuration:  0: Magnetic vector-magnitude interrupt is output on INT2 pin.  1: Magnetic vector-magnitude interrupt is output on INT1 pin.   |

## 10.18.2 M\_VECM\_THS\_MSB (0x6A) register

## Table 206. M\_VECM\_THS\_MSB register

| m_vecm_dbcntm | m_vecm_ths[14:8] |
|---------------|------------------|
| 0             | 0b000_0000       |

## Table 207. M\_VECM\_THS\_MSB bit descriptions

| Field            | Description  |  |
|------------------|--|--|
|                  | Magnetic vector-magnitude debounce counter mode selection:   |  |
| m_vecm_dbcntm    | 0: The debounce counter is decremented by 1 whenever the current vector-magnitude result is below the threshold set in M_VECM_THS. |  |
|                  | 1: The debounce counter is cleared whenever the current vector-magnitude result is below the threshold set in M_VECM_THS.          |  |
| m_vecm_ths[14:8] | Seven most significant bits of 15-bit unsigned magnetic vector-magnitude threshold. Resolution is 0.1 μT/LSB.                      |  |

## 10.18.3 M\_VECM\_THS\_LSB (0x6B) register

## Table 208. M\_VECM\_THS\_LSB register

| m_vecm_ths[7:0] |  |
|-----------------|--|
| 0b0000_0000     |  |

## 10.18.4 M\_VECM\_CNT (0x6C) register

## Table 209. M\_VECM\_CNT register

| m_vecm_cnt[7:0] |
|-----------------|
| 0b0000_0000     |

## Table 210. M\_VECM\_CNT bit description

| Field           | Description                            |
|-----------------|--|
| m_vecm_cnt[7:0] | Vector-magnitude debounce count value. |

The debounce timer period is determined by the ODR selected in CTRL\_REG1; it is equal to the number indicated in M\_VECM\_CNT register times 1/ODR. For example, a value of 16 in M\_VECM\_CNT with an ODR setting of 400 Hz will result in a debounce period of 40 ms. Note that ODR is halved when in hybrid mode.

## 10.18.5 M\_VECM\_INITX\_MSB (0x6D) register

## Table 211. M\_VECM\_INITX\_MSB register

| m_vecm_initx[15:8] |  |
|--------------------|--|
| 0b0000_0000        |  |

## Table 212. M\_VECM\_INITX\_MSB bit description

| Field              | Description   |
|--------------------|---|
| m vecm inity115.81 | MSB of signed 16-bit initial X-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

## 10.18.6 M\_VECM\_INITX\_LSB (0x6E) register

## Table 213. M\_VECM\_INITX\_LSB register

| m_vecm_initx[7:0] |  |
|-------------------|--|
| 0b0000_0000       |  |

## Table 214. M\_VECM\_INITX\_LSB bit description

| Field              | Description   |
|--------------------|---|
| m vecm initxi/:()i | LSB of signed 16-bit initial X-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

## 10.18.7 M\_VECM\_INITY\_MSB (0x6F) register

## Table 215. M\_VECM\_INITY\_MSB register

| m_vecm_inity[15:8] |  |
|--------------------|--|
| 0b0000_0000        |  |

## Table 216. M\_VECM\_INITY\_MSB bit description

| Field              | Description   |
|--------------------|---|
| m vecm initvi15.8i | MSB of signed 16-bit initial Y-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

## 10.18.8 M\_VECM\_INITY\_LSB (0x70) register

## Table 217. M\_VECM\_INITY\_LSB register

| m_vecm_inity[7:0] |
|-------------------|
| 0b0000_0000       |

## Table 218. M\_VECM\_INITY\_LSB bit description

| Field              | Description   |
|--------------------|---|
| m vecm inity(/:()) | LSB of signed 16-bit initial Y-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

# 10.18.9 M\_VECM\_INITZ\_MSB (0x71) register

## Table 219. M\_VECM\_INITZ\_MSB register

| m_vecm_initz[15:8] |  |
|--------------------|--|
| 0b0000_0000        |  |

## Table 220. M\_VECM\_INITZ\_MSB bit description

| Field                 | Description   |
|-----------------------|---|
| I m vecm inital 15.81 | MSB of signed 16-bit initial Z-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

## 10.18.10 M\_VECM\_INITZ\_LSB (0x72) register

## Table 221. M\_VECM\_INITZ\_LSB register

| m_vecm_initz[7:0] |  |
|-------------------|--|
| 0b0000_0000       |  |

## Table 222. M\_VECM\_INITZ\_LSB bit description

| Field               | Description   |
|---------------------|---|
| m Vecm inital (.11) | LSB of signed 16-bit initial Z-axis value used by the magnetic vector-magnitude function when M_VECM_CFG[m_vecm_initm] = 1. |

#### 11 Mounting Guidelines for the Quad Flat No-Lead (QFN) Package

Printed Circuit Board (PCB) layout is a critical portion of the total design. The footprint for the surface mount packages must be the correct size to ensure proper solder connection interface between the PCB and the package. With the correct footprint, the packages will self-align when subjected to a solder reflow process.

These guidelines are for soldering and mounting the Quad Flat No-Lead (QFN) package inertial sensors to PCBs. The purpose is to minimize the stress on the package after board mounting. The FXOS8700CQ uses the QFN package platform. This section describes suggested methods of soldering these devices to the PCB for consumer applications.

Refer to Freescale application note AN4247."Layout Recommendation for PCBs Using a magnetometer Sensor" for a technical discussion on hard and soft-iron magnetic interference and general guidelines on layout and component selection applicable to any PCB using a magnetometer sensor.

Freescale application note AN1902, "Quad Flat Pack No-Lead (QFN) Micro Dual Flat Pack No-Lead (DFN)" discusses the QFN package used by the FXOS8700CQ, PCB design guidelines for using QFN packages and temperature profiles for reflow soldering.

#### 11.1 Overview of soldering considerations

Information provided here is based on experiments executed on QFN devices. As they cannot represent exact conditions present at a customer site, the information provided herein should be used for guidance only and further process and design optimizations are recommended to develop an application specific solution. It should be noted that with the proper PCB footprint and solder stencil designs, the package will self-align during the solder reflow process.

#### 11.2 Halogen content

This package is designed to be Halogen Free, exceeding most industry and customer standards. Halogen Free means that no homogeneous material within the assembled package will contain chlorine (CI) in excess of 700 ppm or 0.07% weight/weight or bromine (Br) in excess of 900 ppm or 0.09% weight/weight.

#### 11.3 **PCB** mounting recommendations

- The PCB land should be designed with Non-Solder Mask Defined (NSMD) as shown in Figure 20 and Figure 21. 1.
- No additional via pattern underneath package.
- PCB land pad is 0.8 mm by 0.3 mm as shown in Figure 20 and Figure 21.
- Solder mask opening = PCB land pad edge + 0.113 mm larger all around.
- Stencil opening = PCB land pad -0.015 mm smaller all around = 0.77 mm by 0.27 mm. 5.
- Stencil thickness is 100 or 125 µm.
- Do not place any components or vias at a distance less than 2 mm from the package land area. This may cause additional package stress if it is too close to the package land area.
- Signal traces connected to pads should be as symmetric as possible. Put dummy traces on the NC pads in order to have same length of exposed trace for all pads.
- Use a standard pick and place process and equipment. Do not use a hand soldering process.
- 10. Do not use a screw down or stacking to fix the PCB into an enclosure as this could bend the PCB, putting stress on the package.
- 11. The PCB should be rated for the multiple lead-free reflow condition with max 260 °C temperature.
- 12. No copper traces on top layer of PCB under the package. This will cause planarity issues with board mount. Freescale QFN sensors are compliant with Restrictions on Hazardous Substances (RoHS), having halide-free molding compound (green) and lead-free terminations. These terminations are compatible with tin-lead (Sn-Pb) as well as tinsilver-copper (Sn-Ag-Cu) solder paste soldering processes. Reflow profiles applicable to those processes can be used successfully for soldering the devices.

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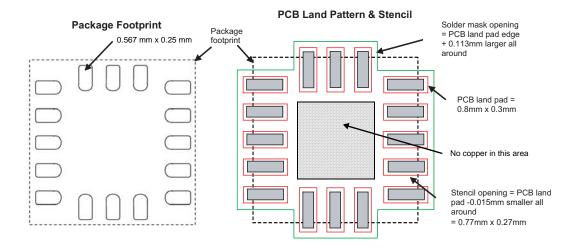


Figure 20. Recommended PCB land pattern, solder mask, and stencil opening near package footprint

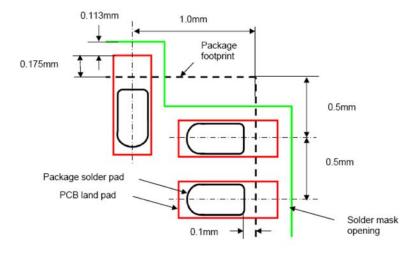


Figure 21. Detailed dimensions

# 12 Package Thermal Characteristics

Table 223. Thermal resistance data

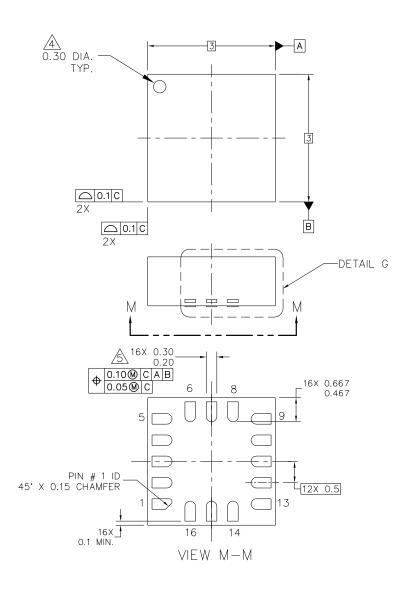
| Rating  | Description                                | Symbol             | Value | Unit |
|---|--|--------------------|-------|------|
| Junction-to-ambient, natural convection <sup>(1)(2)</sup> | Single-layer board                         | $R_{	heta JA}$     | 163   | °C/W |
| Junction-to-ambient, natural convection <sup>(1)(3)</sup> | Four-layer board (two signals, two planes) | ıνθJA              | 70    | C/VV |
| Junction-to-board <sup>(4)</sup>                          |  | $R_{\theta JB}$    | 33    | °C/W |
| Junction-to-case (top) <sup>(5)</sup>                     |  | $R_{\theta JCTop}$ | 84    | °C/W |
| Junction-to-package (top) <sup>(6)</sup>                  | Natural convection                         | $\Psi_{JT}$        | 6     | °C/W |

<sup>1.</sup> Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

- 2. Per JEDEC JESD51-2 with the single-layer board (JESD51-3) horizontal.
- 3. Per JEDEC JESD51-6 with the board (JESD51-7) horizontal.
- 4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

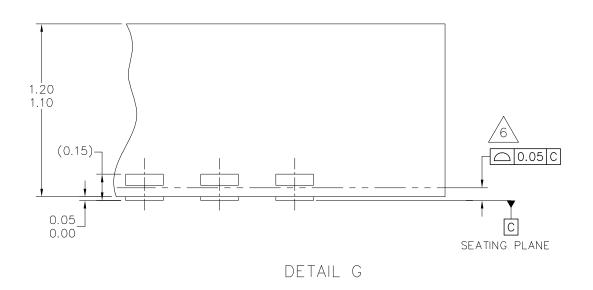
# 13 Package

This drawing is located at http://cache.freescale.com/files/shared/doc/package\_info/98ASA00318D.pdf



| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTLINE | PRINT VERSION NO   | T TO SCALE  |
|--|--------------------|--------------------|-------------|
| TITLE: QFN-COL,                                      | DOCUME             | NT NO: 98ASA00318D | REV: A      |
| 3 X 3 X 1.2,   |                    | UMBER: 2188-02     | 20 NOV 2012 |
| 0.5 PITCH, 16 TERM                                   | MNAL STANDA        | RD: NON JEDEC      |             |

Case 98ASA00318D, 3 x 3 x 1.2, 16-lead QFN



| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.  MECHANICAL C |                    |      | TLINE   | PRINT VERSION NO   | T TO SCALE  |
|--|--------------------|------|---------|--------------------|-------------|
| TITLE:   | QFN-COL,           |      | DOCUME  | NT NO: 98ASA00318D | REV: A      |
|  | 3 X 3 X 1.2,       |      | CASE NU | JMBER: 2188-02     | 20 NOV 2012 |
|  | 0.5 PITCH, 16 TERM | MNAL | STANDAF | RD: NON JEDEC      |             |

Case 98ASA00318D, 3 x 3 x 1.2, 16-lead QFN

#### NOTES:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. THIS IS NON JEDEC REGISTERED PACKAGE.



PIN #1 ID ON TOP WILL BE LASER MARKED.



THIS DIMENSION APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP. IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL, THIS DIMENSION SHOULD NOT BE MEASURED IN THAT RADIUS AREA.



 $\sqrt{6}$ \ COPLANARITY APPLIES TO LEADS AND ALL OTHER BOTTOM SURFACE METALLIZATION.

7. MIN. METAL GAP SHOULD BE 0.2MM.

| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. | MECHANICAL OUTL | .INE    | PRINT VERSION NO  | T TO SCALE  |
|--|-----------------|---------|-------------------|-------------|
| TITLE: QFN-COL,                                      | DC              | OCUMENT | T NO: 98ASA00318D | REV: A      |
| 3 X 3 X 1.2,   |                 | ASE NUM | MBER: 2188-02     | 20 NOV 2012 |
| 0.5 PITCH, 16 TERM                                   | INAL ST         | TANDARD | ): NON JEDEC      |             |

Case 98ASA00318D, 3 x 3 x 1.2, 16-lead QFN

# 14 Revision History

## Table 224. Revision history

| Revision number | Revision date | Description of changes  |
|-----------------|---------------|---|
| 0.1             | 05/2012       | Corrected Figure 1 and updated Figure 4 to include acceleration values.   |
| 0.2             | 05/2012       | <ul> <li>Added Autonomous sub-bullets to first page.</li> <li>Table 2: Changed Cross-axis Max value to ±0.5 and Die-to-package alignment error Max value to ±2.</li> <li>Table 13: WHO_AM_I register, Default Hex Value numbers changed from 0xC4/0xC7 to 0xC7 removed Note 4 and 5.</li> <li>Section 9.1.7, WHO_AM_I register changed register numbers in Figure 16 from 0xC4/0xC7 to 0xC7</li> </ul>  |
| 0.3             | 05/2012       | <ul> <li>Table 2: Changed Nonlinearity values to TBD. Added Test Conditions for Noise rows.</li> <li>Table 3: Added Min values for Self-test output change for X-axis and Y-axis rows.</li> <li>Table 5: Updated ODR values for Low-power acceleration mode, Normal-acceleration mode, Hybrid mode and Magnetic mode. Added max value for IddSTBY, Standby mode; added Typ values for VIH and VIL, all previously TBD. Added Typ value for 25° SCL, SDA pin leakage.</li> <li>Added Section 7.5, Hybrid mode.</li> <li>Table 13:. Deleted registers 0x79, 0x7A, 0x7B and 0x7C,</li> <li>Table 50: Updated a _ffmt_ths_xyz_en description.</li> <li>Table 51: Updated a _ffmt_trans_ths_en description.</li> <li>Updated descriptive paragraph for Section 9.11.3.</li> <li>Updated descriptive paragraph for Section 9.11.4.</li> </ul> |
| 1               | 06/2012       | <ul> <li>Changed title of document.</li> <li>Table 3: Updated Note 2. Tco spec updated, Hysteresis value updated, Updated Noise values for ODR = 6.25 Hz, OS = 256 and ODR = 1.56 Hz, OS = 1024. Updated Vst X-axis Typ value from -1500 to -1320 and Z-axis from TBD to 100.</li> <li>Table 4: Removed first two rows, X, Y, Z inertial alignment parameters and Typ values.</li> <li>Table 8: Added SCL, SDA pin leakage Typ value 4 nA, added SCL, SDA pin capacitance 3 pf.</li> <li>Replace Table 8 with updated parameters.</li> <li>Updated section 5.2 SPI interface characteristics.</li> <li>Table 94: updated m_st_xy[1:0] bit description.</li> </ul>   |

Table 224. Revision history (Continued)

| <ul> <li>Changed Zero-<i>g</i> level change versus temperature Typ value from ±0.15 to ±0.2. Changed Typ value in Hysteresis from ±1 to ±0.5. Updated Nonlinearity row from TBD to 0.25%FS<sub>ACCEL</sub>. Self-Test output change updated Typ values from 143, 255, and 1330 to 249, 335, and 1640 respectively and changed Symbol of for all axes. Deleted ODR accuracy row. Moved Output data bandwidth row to Table 4. Typ values, added values. Removed footnote 2 from table.</li> <li>Table 3: Updated Symbol names for all rows. Updated Unit column for Hysteresis and added note 3 to Nonlinearity and Magnetometer output noise rows. Removed Temperature sensor repeatability row and footnote 4. Updated all Typ values for Magnetometer output noise row(s). Changed Self-test output changes Symbol from Vst to STOC<sub>mag</sub>, updated Typ values from 1164, 1130, 41 to 1161, -1130 and -43 respectively Removed Typ and Max values and updated min values. Removed Min and Max values from Output data bandwidth row, added Min value. Footnote 2: changed applied magnetic field values from -1200 μT to -100 μT to 1000 μT</li> </ul>   | Revision number | Revision date | Description of changes   |
|--|-----------------|---------------|--|
| <ul> <li>Table 5: Updated Symbol names for most rows. Updated Test conditions column for Hybrid mode and Ma mode rows. Updated Standby mode current over-temperature range row Max value column from 16 to 1 Moved Typ value for Digital high-level input voltage RST pin to Min column, and moved Typ value for Digital level input voltage RST pin to Max column. Removed BW rows (two) from table. Changed Power-on ram to VDD rise time. Corrected footnote order.</li> <li>Added paragraph for Section 4.5.</li> <li>Table 9: Removed note regarding preproduction parts and addresses.</li> <li>Section 5.2.1: Updated first paragraph with point-to-point information.</li> <li>Added text in paragraph for Section 5.2.3.</li> <li>Table 14: Updated PL_CFG register Default Hex Value from 0x83 to 0x80, PL_BF_ZCOMP from 0x00 to PL_THS_REG from 0x14 to 0x44 Changed Reserved bit address from 0x7D-0xFF to 0x79-0xFF. Added incremented Address information for register addresses 0x32-0x78.</li> <li>Updated NOTE following Table 14.</li> <li>Corrected bit names in Table 17.</li> <li>Table 25: Updated last two rows, ODR accelerometer or magnetometer only modes was 6.3 to 6.25, and 1.5625 respectively; ODR hybrid mode was 3.15 to 3.125 and 0.8 to 0.7813 respectively.</li> <li>Table 34: updated rst Description.</li> <li>Added Table 36.</li> <li>Added text in paragraph for Section 9.3.1.</li> <li>Corrected bit names in Table 63.</li> <li>Table 69: Changed bits 0 and 1 values from 1 to 0.</li> <li>Table 69: Change bits 0 and 1 values from 03010 to 00b100 and changed bits 7 and 6 values from 0 to 0.</li> <li>Table 70: Updated Descriptions for zlock, default value from 00 → 13° to 0x04 → ~28° and maximum valu 07 → 44° to 0x07 → ~44°. Updated Descriptions for bkfr, default value from 10 → ±75° to 0b10 →</li></ul> | number          | date          | <ul> <li>Changed title of document.</li> <li>Table 1: Added footnotes.</li> <li>Table 2: Added footnotes. Updated Sensitivity change with temperature row Typ value from 0.008 to 0.01. Changed Zero-g level change versus temperature Typ value from ±0.15 to ±0.2. Changed Typ value in Hysteresis from ±1 to ±0.5. Updated Nonlinearity row from TBD to 0.25%FS<sub>ACCEL</sub>. Self-Test output change row: updated Typ values from 143, 255, and 1330 to 249, 335, and 1640 respectively and changed Symbol column for all axes. Deleted ODR accuracy row. Moved Output data bandwidth row to Table 4. Typ values, added min values. Removed footnote 2 from table.</li> <li>Table 3: Updated Symbol names for all rows. Updated Unit column for Hysteresis and added note 3 to Nonlinearity and Magnetometer output noise rows. Removed Temperature sensor repeatability row and footnote 4. Updated all Typ values for Magnetometer output noise row(s). Changed Self-lest output change row Symbol from Vst to STOC<sub>mag</sub>, updated Typ values from 1164, 1130, 41 to 1161, -1130 and -43 respectively. Removed Typ and Max values and updated min values. Removed Min and Max values from Output data bandwidth row, added Min value. Footnote 2: changed applied magnetic field values from -1200 μT to -1200 μT to 1000 μT to 1000 μT</li> <li>Table 4: Added Symbol for Maximum output data rate in hybrid mode.</li> <li>Table 5: Updated Symbol names for most rows. Updated Test conditions column for Hybrid mode and Magnetic mode rows. Updated Standby mode current over-temperature range row Max value column from 16 to 10. Moved Typ value for Digital high-level input voltage RST pin to Min column, and moved Typ value for Digital low-level input voltage RST pin to Max column. Removed BW rows (two) from table. Changed Power-on ramp time to VDD rise time. Corrected footnote order.</li> <li>Added text in paragraph for Section 5.2.3.</li> <li>Table 9: Removed note regarding preproduction parts and addresses.</li> <li>Section 5.2.1: Updated first paragraph with point-to-point information.</li></ul> |

Table 224. Revision history (Continued)

| Revision number | Revision date | Description of changes  |
|-----------------|---------------|---|
| 3               | 07/2013       | <ul> <li>Added new Section 3 Example Driver Code.</li> <li>Table 5: Updated Test Conditions column for Nonlinearity from ±2 g to ±1 g. Added footnote 7 to Output noise density row.</li> <li>Section 6.2.4: Added toggle information to end of paragraph.</li> <li>Table 15: Updated Comment column for Register addresses 0x07-0x08, 0x1D, 0x51, and 0x79. Updated contents of NOTE following table.</li> <li>Section 10.1.2: Corrected first paragraph from Data-Ready Status when STATUS = 0x00 to Data-Ready Status when F_SETUP[f_mode] = 0x00.</li> <li>Section 10.1.3: Corrected first paragraph from FIFO Status when STATUS = 0x00 to FIFO Status when F_SETUP[f_mode] = 0x00.</li> <li>Section 10.1.8: Updated last paragraph; deleted sentence "Data read from the FIFO will also skip over the LSE data, reducing the data acquisition time".</li> <li>Deleted Table 38.</li> <li>Section 9.3.1: Updated 6.25 Hz values for LPLN and Low Power and 1.56 Hz values for LPLN.</li> <li>Table 68: Updated 6.25 Hz values for LPLN and Low Power and 1.56 Hz values for LPLN.</li> <li>Table 75: Switched columns, updated first column header.</li> <li>Deleted Table 38.</li> <li>Section 10.10.4: Updated contents of table.</li> <li>Section 10.10.4: Updated contents of paragraph following Table 99.</li> <li>Deleted Table 100.</li> <li>Table 120: Updated 6.25 Hz and 1.56 Hz rows, values for LPLN and Low Power columns. Updated the paragraph following the table.</li> <li>Table 130: Updated title from "Time step for pulse time limit LPF_EN = 1" to "PULSE_TMLT with HP_FILTER_CUTOFF[pls_hpf_en] = 1". Updated 6.25 Hz and 1.56 Hz rows, values for LPLN and Low Power columns.</li> <li>Table 133: Updated title from "Time step for PULSE Latency @ ODR and power mode LPF_EN = 0" to "Time step PULSE LTCY with to HP_FILTER_CUTOFF[pls_hpf_en] = 0". Updated 6.25 Hz and 1.56 Hz rows, values for LPLN and Low Power columns.</li> <li>Table 138: Updated title from "Time step PULSE detection window @ ODR and power mode LPF_EN = 1" to "Time step for PULSE_Vilvno with HP_FILTER_CUTOFF[</li></ul> |
| 4.0             | 02/2014       | <ul> <li>Global change to register tables, changed format of bit values.</li> <li>Section 5.2, Table 3: Changed Min, Typ and Max values for Self-Test output change row. Added Note 4.</li> <li>Added Table 6.</li> <li>Moved section 3 Example FXOS8700CQ Driver Code and subsections after section 9 Register Map renumbering both sections to 8 and 9 respectively.</li> <li>Corrected codes in Example 6.</li> <li>Table 15: Updated and correct footnote numbering in table.</li> <li>Table 28: Corrected Description for src_a_vecm from "This bit is asserted whenever PULSE_SRC[ea] is asserted" to "This bit is asserted whenever A_FFMT_SRC[ea] is asserted"</li> <li>Table 33: Updated descriptions for smods[1:0] and mods[1:0] bit fields.</li> <li>Table 37: Updated Description for fifo_gate and changed bit name for wake_en_a vecm to wake_a_vecm.</li> </ul>   |
|                 | 2017          | Table 43. Updated int_cfg_drdy description from "INT1/INT2 configuration." to "Data-ready interrupt routing."   |
| 4.1             | 01/2015       | Removed Appendix A and created document FXOS8700CQER.   |

## Table 224. Revision history (Continued)

| Revision number | Revision date | Description of changes  |  |  |
|-----------------|---------------|---|--|--|
| 5.0             | 05/2015       | <ul> <li>Section 7.3: Updated content in first paragraph.</li> <li>Section 10.1.8: Table 31, updated Description for Inoise Field.</li> <li>Section 10.1.9: Table 35, updated Description for rst Field.</li> <li>Section 10.6.1: Table 59, added Sensitivity column with previous Full-scale Range values and added new values to the Full-scale range column.</li> <li>Section 10.9.3: Table 84, updated Description for a_ffmt_ths_xyz_en field.</li> <li>Section 10.11.3: Updated first paragraph.</li> </ul> |  |  |

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